

based on **ARM®32bitCortex™-M4** microcontroller with **16Kbyte to 64Kbyte** flash,
sLib, 10a timer, 1 individual ADC, 1 individual Comparators, 7 communication interface

Function

- **kernel: ARM®32bitCortex™-M4 CPU**
 - Highest 120 MHz operating frequency, with a memory protection unit (MPU), built-in single-cycle multiplication and hardware division
 - have DSP Instruction Set
- **memory**
 - 16Kbyte to 64KBytes of Flash Program/Data Memory
 - 4Kbytes of system memory as a bootloader (Bootloader), can be configured as a general user program and data area at one time
 - sLib: Set the specified main storage area as the execution code security library area, the code in this area can only be called but not read
 - 8 Kbyte to 16Kbyte SRAM CRC
- **computing unit**
- **Reset and Power Management**
 - 2.4 to 3.6 volt power supply and I/O pin
 - Power-on/Power-off reset (POR/PDR)
 - Programmable Voltage Monitor (PVD)
 - Low Power Modes: Sleep, Shutdown, Standby, 4 individual WKUP Pin to wake up from standby mode
 - support 5 individual 32bit backing register clock
- **management**
 - 4 to 25 MHz crystal oscillator
 - Built-in factory-tuned 48 MHz RC oscillator (25°C reach 1 % precision, -40°C to +105°C reach 2 % precision)
 - PLLs Flexible configuration 31 to 500 multiplier and 1 to 15 Frequency division factor
 - Built-in with calibration 40 kHz RC oscillator
 - with calibration function 32 kHz crystal
- **oscillator up to 39a quick I/O**
 - All can be mapped to external interrupt
 - Almost all I/O Tolerable 5V Input voltage
 - all fast I/O, register access speed is the highest f_{AHB}
- **5 a/s DMA controller**
- **1 individual 12bit 2 MSPS A/D converter, up to 15 external input channels**
- **1 a comparator with 5 external input channels and 1 internal reference voltage**
- **up to 10 timer**
 - 1 individual 16bit 7 Channel Advanced Timer, with 6 a/s PWM output with deadband control and emergency stop
 - up to 5 individual 16bit timers, each with up to 4 one for input capture/output compare/PWM or pulse counting channels and incremental encoder inputs
 - 1 individual 16bit basic timer
 - 2 Watchdog timers (independent and windowed)
 - System tick timer: twenty four bit down counter
- **ERTC: Enhanced RTC, with alarm clock, sub-second resolution, and hardware calendar**
- **up to 7 communication interface**
 - 2 individual I²C interface (support SMBus/PMBus)
 - 2 individual USART interface; supports master synchronization SPI and modem control; with ISO7816 interface, LIN, IrDA ability
 - 2 individual SPI interface (50Mbit/s), 2 can be reused as I²S interface
 - infrared emitter
- **Serial Wire Debug (SWD) interface**
- **96bit chip unique code (UID)**
- **temperature range: -40 to +105°C**
- **encapsulation**
 - LQFP48 7 x 7mm
 - LQFP32 7 x 7mm
 - QFN32 5 x 5mm
 - QFN32 4 x 4mm
 - QFN28 4 x 4mm
 - TSSOP20 6.5 x 4.4mm

surface 1. selection list

| flash memory | model |
|--------------|--------------------------------------------------------------------------------------|
| 64Kbyte | AT32F421C8T7, AT32F421K8T7, AT32F421K8U7, AT32F421K8U7-4, AT32F421G8U7, AT32F421F8P7 |
| 32Kbyte | AT32F421C6T7, AT32F421K6T7, AT32F421K6U7, AT32F421K6U7-4, AT32F421G6U7, AT32F421F6P7 |
| 16Kbyte | AT32F421C4T7, AT32F421K4T7, AT32F421K4U7, AT32F421K4U7-4, AT32F421G4U7, AT32F421F4P7 |

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1

introduce

This article gives AT32F421 series ordering information and device mechanical characteristics.

AT32F421 series data sheet, must be combined with [AT32F421 Series Reference Manual](#) read together. Information on programming, erasing, and protecting Flash memory is also available at [AT32F421 Series Reference Manual](#) obtained from.

related Cortex[™]-M4 For core information, please refer to Cortex-M4 Technical Reference Manual, available at [ARM company website](#) download: <http://infocenter.arm.com>

2 Specifications

AT32F421series microcontrollers using high-performanceARM®Cortex™-M4 32bitRISCcore, operating at a maximum frequency of120 MHz,Cortex™-M4The kernel has a set ofDSPinstructions and a Memory Protection Unit (MPU).

AT32F421series built-in high-speed embedded memory (up to64Kbytes of flash memory and16KbyteSRAM), the rich enhancementI/O port and connect to twoAPB peripherals on the bus. The built-in memory can set any range of program area subject toLibprotection, and become a safe library area for executing code.

Device contains1individual12bitADC,1analog comparator,5general16bit timer, and1advanced timers, also includes standard and advanced communication interfaces: up to2individualI²Cinterface,2individualSPIinterface (multiplexed asI²Sinterface),2individualUSARTinterface, and1an infrared emitter.

AT32F421series work on-40°Cto +105°Ctemperature range, supply voltage2.4Vto3.6V, power saving mode guarantees low power consumption application requirements.

AT32F421family of microcontroller offerings including from20foot to48feet6Ddifferent packaging forms; according to different packaging forms, its members are completely compatible pin-to-pin, software and function are also compatible, only the peripheral configuration in the device is not the same. A basic introduction of all peripherals in this series is given below.

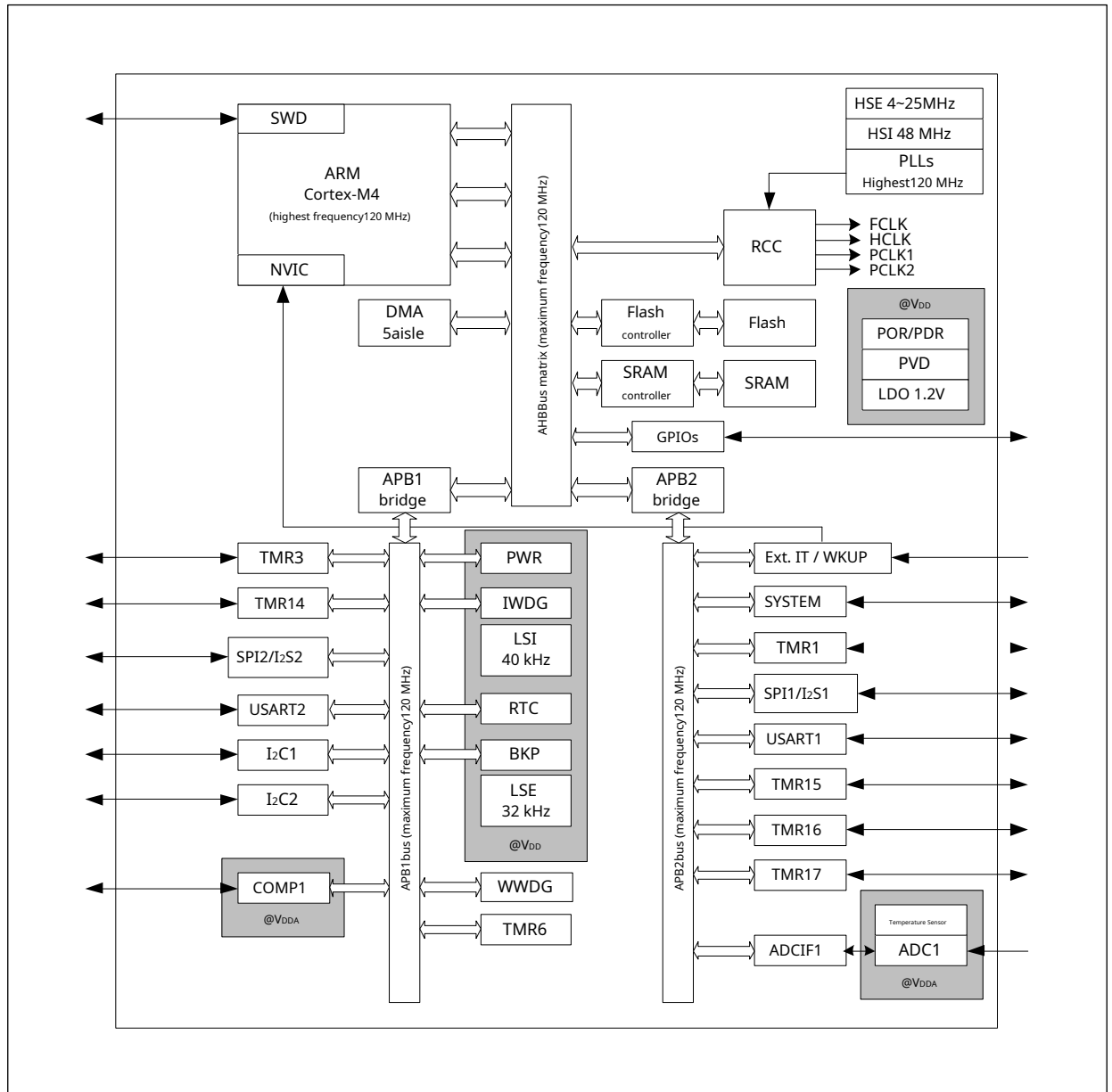
surface2. AT32F421Family Device Features and Configurations

| model | | AT32F421xxP7 | | | AT32F421xxU7 | | | AT32F421xxU7-4 | | | AT32F421xxU7 | | | AT32F421xxT7 | | | AT32F421xxT7 | | |
|-------------------------|---------------------------------------------------|-------------------------|----|----|-------------------|----|----|-------------------|----|----|------------------|----|----|--------------------|----|----|--------------------|----|----|
| | | F4 | F6 | F8 | G4 | G6 | G8 | K4 | K6 | K8 | K4 | K6 | K8 | K4 | K6 | K8 | C4 | C6 | C8 |
| frequency(MHz) | | 120 | | | | | | | | | | | | | | | | | |
| Flash (Kbyte) | | 16 | 32 | 64 | 16 | 32 | 64 | 16 | 32 | 64 | 16 | 32 | 64 | 16 | 32 | 64 | 16 | 32 | 64 |
| SRAM(Kbyte) | | 8 | 16 | 16 | 8 | 16 | 16 | 8 | 16 | 16 | 8 | 16 | 16 | 8 | 16 | 16 | 8 | 16 | 16 |
| timer | advanced | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| | 16bit generic | 5 | | | 5 | | | 5 | | | 5 | | | 5 | | | 5 | | |
| | basic | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| | SysTick | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| | IWDG | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| | WWDG | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| | ERTC | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| Communication Interface | I2C | 2 | | | 2 | | | 2 | | | 2 | | | 2 | | | 2 | | |
| | SPI/I2S | 1/1 ⁽¹⁾ | | | 2/2 | | | 2/2 | | | 2/2 | | | 2/2 | | | 2/2 | | |
| | USART+UART | 1+1 ⁽²⁾ | | | 2+0 | | | 2+0 | | | 2+0 | | | 2+0 | | | 2+0 | | |
| | infrared emitter | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| simulation | 12bitADCconverter/ Number of external channels | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| | | 9 | | | 10 | | | 11 | | | 11 | | | 10 | | | 15 | | |
| | Comparators | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | | 1 | | |
| GPIOs | | 15 | | | twenty three | | | 27 | | | 27 | | | 25 | | | 39 | | |
| Operating temperature | | - 40°Cto +105°C | | | | | | | | | | | | | | | | | |
| Package form | | TSSOP20 6.5 x 4.4 mm | | | QFN28 4 x 4 mm | | | QFN32 4 x 4 mm | | | QFN32 5 x 5mm | | | LQFP32 7 x 7 mm | | | LQFP48 7 x 7 mm | | |

(1)existTSSOP20on the packageonly supportSPI1.

(2)existTSSOP20on the packageUSART2All pins are reserved;USART1onlyTXandRXfeet, so onlyUARTuse.

picture1. AT32F421Series functional block diagram



3

Functional Overview

3.1 ARM®Cortex™-M4,WithDSPInstruction

ARM Cortex™-M4 is the latest generation of embedded ARM processor, which implements MCU. The need to provide a low-cost platform, reduced pin count, reduced system power consumption, while providing excellent computing performance and advanced interrupt system response.

ARM Cortex™-M4 The processor is a 32-bit RISC processor, with excellent code efficiency, employs the usual 8-bit and 16-bit device memory space to play ARM® High performance of the kernel.

The processor supports a set of DSP instructions that enable efficient signal processing and complex algorithm execution.

AT32F421 series and all ARM Tools and software are compatible.

picture is the functional block diagram of this series of products.

Note: Cortex™-M4 kernel with Cortex™-M3 The kernel is binary compatible.

3.2 memory

3.2.1 flash memory

Built-in 64K Bytes of flash memory for storing programs and data. The built-in memory can specify any range of program area to be Lib Protection, it becomes a safe library area that can only execute code that cannot be read. Lib It is designed based on protecting the code security of the solution provider and taking into account the convenience of its customers for secondary development.

on-chip 4Kbytes of system memory, the bootloader (Bootloader) are stored in it. If the user does not need to use the boot loader, the system memory can be configured as a general user program and data area at one time.

3.2.2 Memory Protection Unit (MPU)

Memory Protection Unit (MPU) for management CPU Access to memory that prevents one task from accidentally corrupting memory or resources used by another active task. This store is organized as a maximum of 8 protected areas, which in turn can be subdivided into up to 8 sub-area. The size of the protected area can be 32 bytes to the entire 4Gbyte.

If there is some critical or critical code in the application that must be protected from erroneous behavior by other tasks, then MPU is especially useful. It usually consists of RTOS (real-time operating system) management. If the program accesses a memory location that is MPU prohibited, then RTOS It can be detected and acted upon. In the environment, the kernel can be dynamically updated based on the executing process MPU zone settings.

MPU is optional and can be bypassed if not required by the application.

3.2.3 built-in SRAM

16Kbyte embedded SRAM, CPU can be accessed (read/write) with zero wait cycles.

3.3 Cyclic Redundancy Check (CRC) computing unit

CRC (cyclic redundancy check) calculation unit using a fixed polynomial generator from a 32-bit data word to generate a CRC code. In many applications, based on CRC the technique is used to verify the consistency of data transmission or storage. according to EN/IEC 60335-1 These techniques provide a means of detecting errors in flash memory as specified in the standard. CRC Computational units help to calculate the software's signature during runtime and compare this signature with a reference signature generated at link time and stored in a given memory unit.

3.4 Interrupts and events

3.4.1 Nested Vectored Interrupt Controller (NVIC)

AT32F421The series products have built-in nested vector interrupt controller, which can manage16priority, processingCortex™-M4most cores28 maskable interrupt channels and16interrupt line.

- Tightly coupledNVICcan achieve low-latency interrupt response processing
- interrupt vector entry address directly into the kernel
- Tightly coupledNVICinterface
- Allows early handling of interrupts
- Handle late arriving higher priority interrupts
- Support interrupt tail link function
- Automatically save processor state
- Automatic recovery on return from interrupt without additional instruction overhead

This module provides flexible interrupt management functions with minimal interrupt latency.

3.4.2 External Interrupt/Event Controller (EXTI)

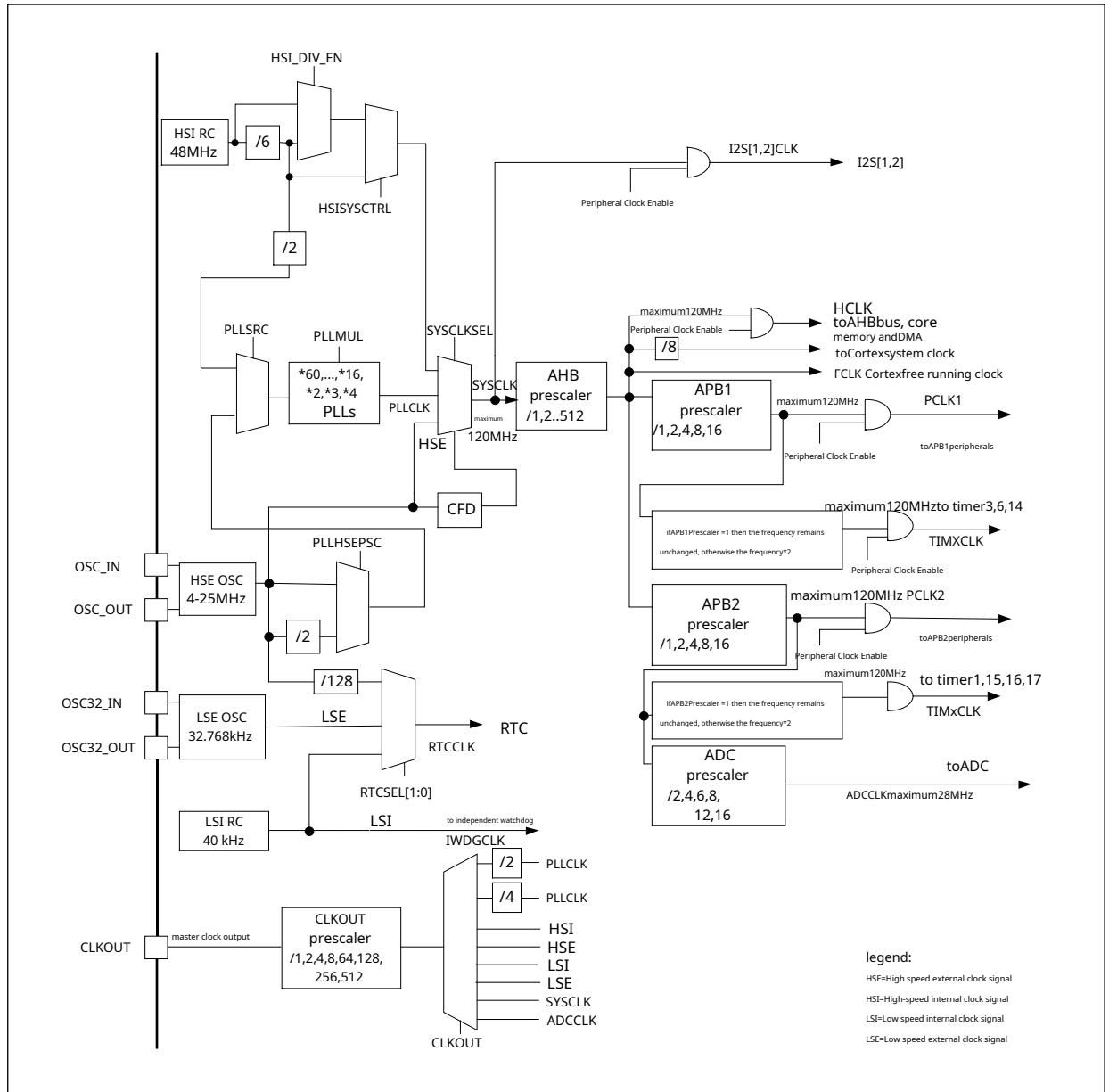
The external interrupt/event controller contains20An edge detector for generating interrupt/event requests. Each interrupt line can independently configure its trigger event (rising edge trigger, falling edge trigger, or both edge triggers), and can be masked individually; there is a pending register to maintain the status of all interrupt requests.EXTIcan detect pulse widths smaller than the internalAHBthe clock cycle. The external interrupt line has a maximum of16root, available from as many as39generalI/Oport to select the connection.

3.5 clock and start

The selection of the system clock is performed at startup, and the internal48MHzofRCoscillator(HSI)through6After frequency division (8 MHz) was selected as the defaultCPUclock, followed by an optional external, fail-safe4~25MHzclock(HSE);When the external clock failure is detected, it will be isolated and the system will automatically switch to the internalRCoscillator(HSI), if the interrupt is enabled, the software can receive the corresponding interrupt. Likewise, when required, thePLLsClock complete interrupt management (eg when an indirectly used external oscillator fails).

Multiple prescalers are used to configureAHBFrequency of,APB(APB1andAPB2)area.AHBandAPBThe highest frequency of120 MHz. refer to [picture2](#)The clock driver block diagram.

picture2.clock tree



3.6 boot mode

At startup, passBOOT0pin and user select bytenBOOT1Bit settings can select one of three boot modes:

- boot from user flash memory;
- boot from system memory;
- from the insideSRAMstart up.

boot loader (Bootloader) are stored in the system memory and can be accessed byUSART1orUSART2Reprogram the flash memory.

surface3Provides a bootloader (Bootloader)rightAT32F421pin configuration.

surface3.boot loader (Bootloader) of the pin configuration

| peripherals | Corresponding pin |
|-------------|---------------------------------|
| USART1 | PA9:USART1_TX PA10:USART1_RX |
| USART2 | PA2:USART2_TX PA3:USART2_RX |

3.7 power management

3.7.1 Power supply scheme

- $V_{DD} = 2.4 \sim 3.6V$: pass V_{DD} Pin is I/O pin, ERTC, external 32 kHz Oscillator, backup registers, and internal voltage regulator.
- $V_{DDA} = 2.4 \sim 3.6V$: pass V_{DDA} Pin is A/D converter and COMP Comparator power supply. V_{DDA} and V_{SSA} must be connected to V_{DD} and V_{SS} .

For details on how to connect the power pins, see [picture 11](#) power supply scheme.

3.7.2 power monitor

This product integrates a power-on reset (POR)/ Brownout Reset (PDR) circuit, which is always active to ensure that the device does not operate at a voltage lower than 2.4V can work normally; when V_{DD} below the specified threshold ($V_{POR/PDR}$), puts the device in a reset state without the use of an external reset circuit.

There is also a programmable voltage monitor (PVD), which monitors V_{DD} powered and with V_{PVD} Threshold comparison, when V_{DD} below or above V_{PVD} . When the threshold is interrupted, the interrupt handler can issue a warning message or transfer the microcontroller into a safe mode. PVD The function needs to be enabled by software. about $V_{POR/PDR}$ and V_{PVD} The value reference [surface 11](#) and [surface 12](#).

3.7.3 Regulator

The regulator has three modes of operation: Master Mode (MR), low power mode (LPR), and shutdown mode

- main mode (MR) for normal run operation and CPU shutdown mode; low
- power mode (LPR) Can be used as CPU shutdown mode;
- Shutdown mode is used for CPU Standby mode: the output of the voltage regulator is in a high-impedance state, the power supply of the core circuit is cut off, and the voltage regulator is in a state of zero consumption. (but registers and SRAM will be lost.)

The voltage regulator is always active after reset, and the high-impedance output is turned off in standby mode.

3.7.4 low power mode

AT32F421 The family of products supports three low-power modes, which can achieve the best balance between requiring low power consumption, short startup time and multiple wake-up events.

- sleep mode

In sleep mode, only CPU stop working, all peripherals keep running and can wake up on interrupt/event CPU.

- shutdown mode

Low power consumption can be achieved in shutdown mode while maintaining SRAM and register contents. at this time, 1.2V All clocks in the domain are stopped, PLLs, HSI oscillator, and HSE The crystal oscillator is also turned off. It is also possible to place the regulator in normal mode (MR) or low power mode (LPR), in which the low power mode can also lower the output voltage of the voltage regulator to further reduce power consumption. can be configured by either EXT signal to wake up the microcontroller from shutdown mode, EXT signal can be 16 external I/O one of the mouth, PVD Output, ERTC alarm/intrusion detection/time stamp events, or COMP wake-up signal. standby mode

-

The lowest power consumption is achieved in standby mode. At this time, the internal voltage regulator is turned off, so the entire internal 1.2V Part of the power supply was cut off. PLLs, HSI of RC oscillator and HSE The crystal oscillator is also turned off. After entering standby mode, SRAM and register contents will disappear, but RTC The contents of domain registers and backup registers are still preserved, and the standby circuit still works.

occurNRSTexternal reset signal on theIWDGreset,wxysA rising edge on the pin, or triggerERTCArm/Intrusion Detection/Timestamp event, device exit from Standby mode.

Note: When entering shutdown or standby mode, theERTC,IWDGand the corresponding clock will not be stopped.

3.8 Direct Memory Access Controller (DMA)

5Channel commonDMACan manage storage-to-storage, device-to-storage, and storage-to-device data transfers.

DMAThe controller supports the management of the ring buffer without intervention by user code when the controller reaches the end of the buffer.

Each channel has dedicated hardwareDMArequest logic, while each channel can be triggered by software. The length of the transfer, the source address and the destination address of the transfer can all be set individually by software.

DMAAvailable for major peripherals:SPI,I2S,I2C,USART, all timersTMRx(Apart fromTMR14),andADC.

3.9 Enhanced Real Time Clock (ERTC) and backup registers after

Fallback domains include:

- Enhanced Real Time Clock (ERTC)
- Sindividual32bit backing register

Enhanced Real Time Clock (ERTC) is an independentBCDTimer/Counter. It supports the following functions:

- The calendar has seconds, minutes, hours (12ortwenty fourhour format), day of week, day, month, year in the formatBCD(binary coded decimal).
- Provides subsecond values in binary format.
- Automatically adjusts the number of days per month to28,29(leap year),30,still31sky.
- Programmable alarm clock has the ability to wake up from stop and standby mode.
- run-time correction1arrive32767individualERTCclock pulse. This can be used toERTCsynchronized with the master clock. The digital calibration circuit has1 ppmresolution to compensate for the inaccuracy of the quartz crystal. The tamper detect pin has a programmable filter. When a tamper event is detected,MCUWake up from stop and standby mode.
- The timestamp feature can be used to save calendar content. This function can be triggered by an event on the timestamp pin, or by a tamper event. When a timestamp event is detected,MCUWake up from stop and standby mode.
- Reference Clock Detection: Allows use of a more accurate second clock source (50or60Hz) to increase the accuracy of the calendar.

The alarm clock register is used to generate an alarm at a specific time, and the calendar fields can be individually masked to compare alarms.

20bit prescaler for the time reference clock. By default, it is configured from32.768 kHzclock generation1The time base in seconds.

The backing register is32bit register, used to store20bytes of user application data. The backup registers are not reset on system reset, nor on device wake-up from Standby mode.

other32Bit registers also contain programmable alarm subseconds, seconds, minutes, hours, day of the week, and date.

ERTCThe clock source can be:

- 32.768 kHzexternal crystal, resonator, or oscillator (LSE); internal
- low powerRCoscillator (LSI), the typical frequency is40 kHz; High-
- speed external clock (HSE)of32crossover.

3.10 Timers and Watchdogs

AT32F421The series includes the most1an advanced timer,5an ordinary timer,1a basic timer, and2a watchdog timer, and1A system tick timer.

The table below compares the functionality of the different timers:

| surface4.Timer Function Comparison | | | | | | | |
|------------------------------------|----------------|-----------------------|----------------------------------------------|----------------------------------|---------------|-------------------------|----------------------|
| timer type | timer | counter Resolution | counter type | Prescaler coefficient | produceDMAask | capture/compare channel | complementary output |
| advanced | TMR1 | 16bit | increment, decrement, increment/decrement | 1~65536between any integer of | have | 4 | 3 |
| universal | TMR3 | 16bit | increment, decrement, increment/decrement | 1~65536between any integer of | have | 4 | none |
| | TMR14 | 16bit | increment | 1~65536between any integer of | none | 1 | none |
| | TMR15 | 16bit | increment | 1~65536between any integer of | have | 2 | 1 |
| | TMR16 TMR17 | 16bit | increment | 1~65536between any integer of | have | 1 | 1 |
| basic | TMR6 | 16bit | increment | 1~65536between any integer of | have | none | none |

3.10.1 Advanced Timer (TMR1)

An Advanced Timer (TMR1) can be viewed as assigning to6three-phasePWMgenerator with complementaryPWMoutput, which can also be used as a complete general-purpose timer. Four independent channels can be used for:

- input capture
- output compare
- with full modulation capability (0~100%)ofPWMGeneration (Edge or Center Aligned Mode) Single
- Pulse Mode Output

In debug mode, the counters can be frozen whilePWMoutputs are disabled, turning off the switches controlled by those outputs.

Many features of Advanced Timer are related to general-purposeTMRThe timers are the same, and the internal structure is the same, so the advanced timer can cooperate with the general-purpose timer through the timer link function to provide synchronization or event link function.

3.10.2 General purpose timer (TMR3,TMR14,TMR15,TMR16,andTMR17)

AT32F421series products, built-in up to5A general-purpose timer that can run synchronously. Every general purpose timer can be used to generate PWMoutput, or as a simple time reference.

- TMR3

TMR3is based on a16bit dynamic loading up/down counters and a16bit prescaler. This timer is available in the largest package configuration4independent channels, each of which can be used for input capture, output compare,PWMand single pulse mode output.

TMR3It can also work with advanced timers through the timer chaining function to provide synchronization or event chaining functions.TMR3can be used to generatePWMoutput.TMR3It can also process signals from incremental encoders, and can also process1to3Digital output of a Hall sensor.

In debug mode, the counters can be frozen.TMR3independentDMArequest mechanism.

- **TMR14**

The timer is based on a16bit autoloading up counter, a16bit prescaler and1independent channels, each of which can be used for input capture, output compare,PWMand single-pulse mode output, which can be synchronized with a full-featured general-purpose timer or used as a simple timer.

In debug mode, the counters can be frozen.

- **TMR15,TMR16,andTMR17**

These three general-purpose timers have16bit auto-reload incrementing counter and16bit prescaler.TMR15have2channels and1a complementary channel,TMR16andTMR17have1channels and1a complementary channel. All channels are available for input capture/output compare, PWMor single pulse mode output.

These timers can work together through timer chaining to provide synchronization or event chaining.

In debug mode, the counters can be frozen. These timers have independentDMARequest generation mechanism.

3.10.3Basic Timer (TMR6)

This timer is used as a general16bit time base counter.

3.10.4Independent Watchdog (IWDG)

The independent watchdog is based on a8bit prescaler and a12bit down counter, which consists of an internal independent40 kHzof RCThe oscillator provides the clock; since thisRCThe oscillator is independent of the main clock, so it can run in shutdown and standby modes. It can be used as a watchdog to reset the entire system when a problem occurs, or as a free timer to provide timeout management for applications. It can be configured as a software or hardware enabled watchdog by selecting bytes. In debug mode, the counters can be frozen.

3.10.5window watchdog (WWDG)

The window watchdog is based on a free-running7Bit down counter. It can be used as a watchdog to reset the entire system when a problem occurs. it consists ofAPB1Clock driven with early warning interrupt function. In debug mode, the counters can be frozen.

3.10.6System Tick Timer (SysTick)

This timer is dedicated to real-time operating systems and can also be used as a general-purpose down counter. It has the following properties:

- twenty fourbit down counter
- auto reload function
- When the counter is0, a maskable system interrupt is generated
- Programmable Clock Source (HCLKorHCLK/8)

3.11 Inter-IC bus (I2C)

2 individual I2C bus interface, able to work in multi-master mode or slave mode, supports standard mode (up to 100 kbit/s) and fast mode (maximum 400 kbit/s). I2C The bus frequency can be increased up to 1 MHz. For a more complete and detailed solution, you can contact the nearest YateLi sales office for technical support.

I2C interface supports 7-bit or 10-bit addressable, 7-bit slave mode supports dual slave address addressing. built-in hardware CRC Generator/Checker. they can use DMA operate and support SMBus 2.0 Version / PMBus.

3.12 Universal Synchronous/Asynchronous Transceiver (USART)

AT32F421 series products, the built-in 2 Universal Synchronous/Asynchronous Transceiver (USART1 and USART2).

this 2 individual USART The interface provides asynchronous communication, supports IrDA SIR ENDEC Transport codec, multiprocessor communication mode, master synchronous communication, single-wire half-duplex communication mode, and LIN Master/slave functionality. 2 individual USART interface with hardware CTS and RTS Signal Management, Compatibility ISO7816 smart card mode. 2 individual USART interface can be used DMA operate.

2 individual USART interface communication rate can reach 7.5 megabits per second.

3.13 Serial Peripheral Interface (SPI)/internal integrated audio interface (I2S)

2 individual SPI interface, in slave or master mode, full-duplex and half-duplex communication speed up to 50 megabits per second. 3-bit prescaler can generate 8 main mode frequency, configurable as per frame 8-bit or 16-bit. hardware CRC Generate/verify support for basic SD Card, MMC mode, and SDHC mode.

2 standard I2S interface (with SPI multiplexing) can work in master or slave mode, which 2 An interface can be configured as 16-bit, twenty-four bit, or 32-bit transmission, can also be configured as input or output channel, supports audio sampling frequency from 8 kHz to 192 kHz. as either I2S The interface is configured in master mode, and its master clock can be 256 times the sampling frequency output to an external DAC or CODEC (decoder).

all SPI interface can be used DMA operate.

3.14 Infrared Emitter (IR)

AT32F421 device provides an IR emitter solution. The solution is based on TMR16, USART1, or USART2 and TMR17 internal connection between. TMR17 used to provide the carrier frequency, TMR16, USART1, or USART2 Provides the main signal to send. Infrared output signal at PB9 or PA13 available on .

In order to generate an IR remote control signal, it must be properly configured TMR16 and TMR17 to generate the correct waveform. all standards IR Both pulse modulation modes are available by programming the two timer output compare channels.

3.15 GPIO (GPIOs)

each GPIOs All pins can be configured by software as output (push-pull or open-drain), input (with or without pull-up or pull-down), or multiplexed peripheral function ports. most GPIOs Pins are shared with digital or analog multiplexed peripherals.

in case of need, I/O The peripheral function of the pin can be locked by a specific operation to avoid the I/OA register has performed an unexpected write operation.

3.16 Analog/Digital Converter (ADC)

AT32F421 series of products, built-in individual 12-bit analog/digital converter (ADC), sharing up to 15 external channels and 3 internal (temperature sensor, internal voltage reference, and V_{SSA}) channels, single-shot or scan conversions can be implemented. In scan mode, conversions on a selected set of analog inputs are performed automatically.

ADC can use DMA to operate.

The analog watchdog function allows very precise monitoring of one, multiple or all selected channels, and an interrupt will be generated when the monitored signal exceeds a preset threshold.

by the general purpose timer (TMRx) and Advanced Timer (TMR1) can be cascaded internally to the ADC. The start trigger and injection trigger, the application can make the ADC conversions are synchronized with the clock.

3.16.1 Temperature Sensor

The temperature sensor produces a voltage that varies linearly with temperature V_{SENSE} , the conversion range is $2.4V \leq V_{DDA} \leq 3.6V$ between. The temperature sensor is internally connected to the ADC_IN16. On the input channel of the sensor, it is used to convert the output of the sensor into a digital value.

3.16.2 Internal reference voltage (V_{REFINT})

internal reference voltage (V_{REFINT}) for ADC and comparator provides a regulated voltage output. V_{REFINT} internally connected to ADC_IN17 on the input channel for the V_{REFINT} . The output of is converted to a numeric value.

3.17 Comparators (COMP)

AT32F421 The device contains a rail-to-rail comparator (COMP), with programmable reference voltage (internal or external), hysteresis and speed, selectable output polarity, output function with blanking, and glitch filter.

The reference voltage can be one of the following:

- external I/O
- internal reference voltage (V_{REFINT}) or its submultiples (1/4, 1/2, 3/4). Please refer to [surface 13](#) to obtain the value and accuracy of the internal reference voltage.

The comparator can wake up from stop mode, and can also generate interrupt and disconnect for the timer.

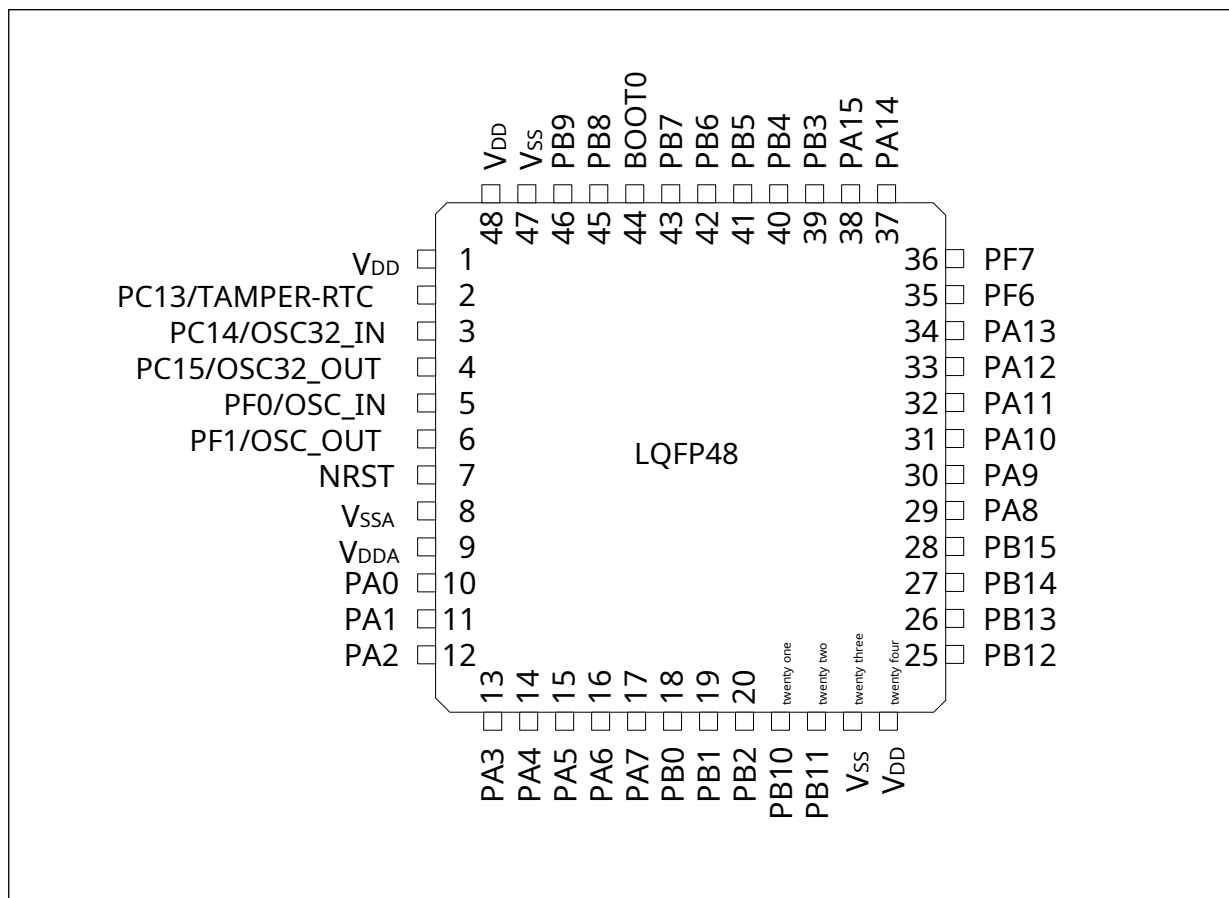
3.18 Serial Wire Debug Port (SW-DP)

embedded ARMv7-M SW-DP Interface, this is a serial line debugging interface, which can realize the connection of the serial line debugging interface to the target, and realize the programming and debugging of the target.

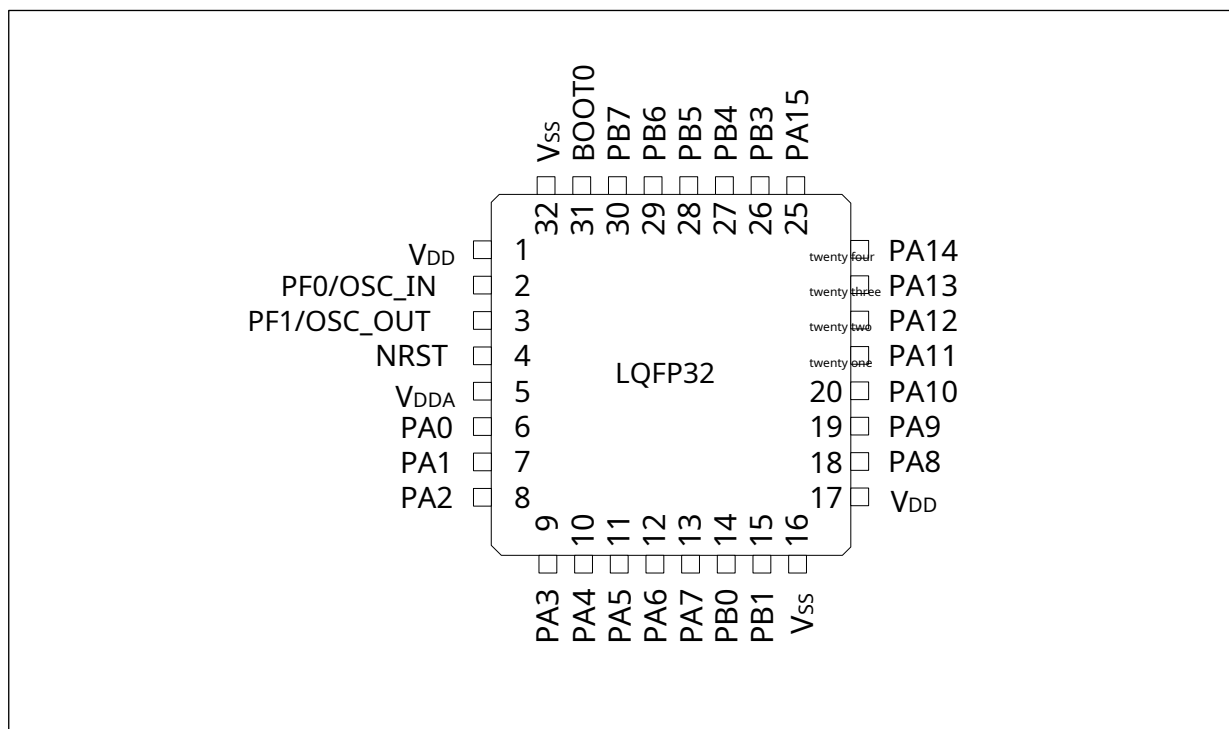
4

pin definition

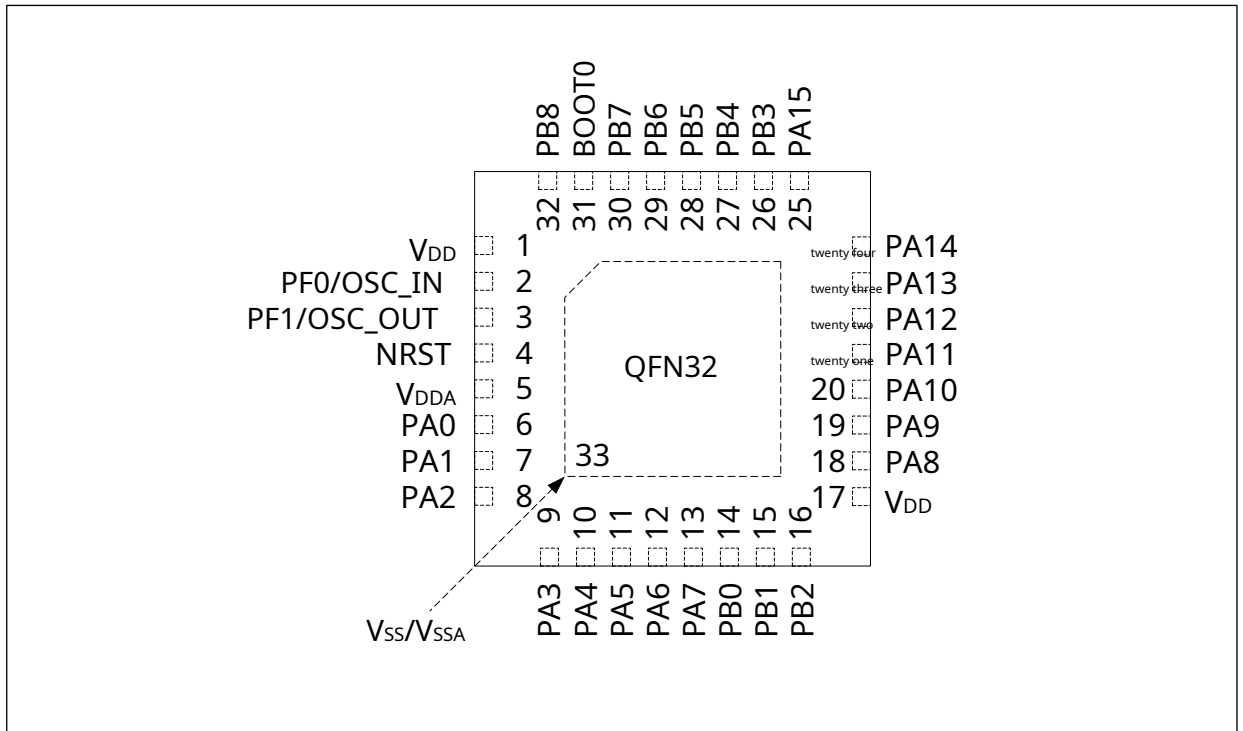
picture3. AT32F421seriesLQFP48pin distribution



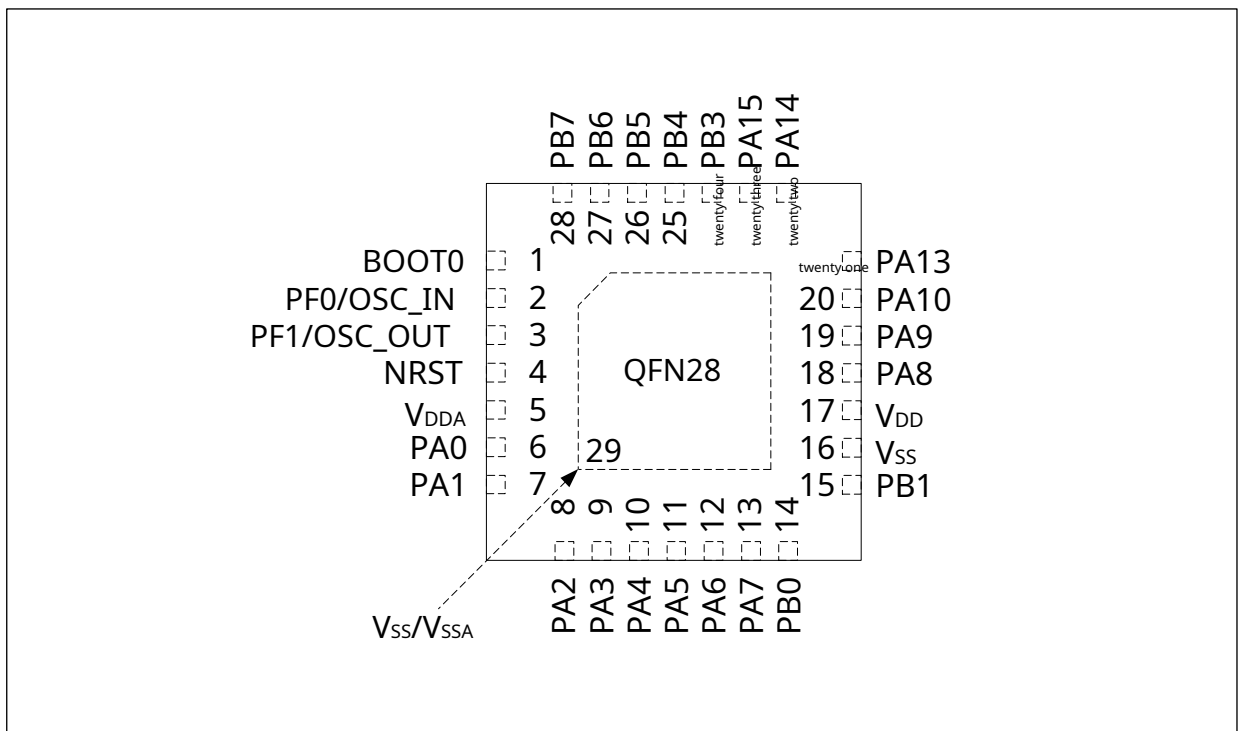
picture4. AT32F421seriesLQFP32pin distribution



picture5. AT32F421seriesQFN32pin distribution



picture6. AT32F421seriesQFN28pin distribution



picture7. AT32F421seriesTSSOP20pin distribution

| | | | | | |
|------------------|--------------------------|----|------------|--------------------------|-----------------|
| BOOT0 | <input type="checkbox"/> | 1 | 20 | <input type="checkbox"/> | PA14 |
| PF0/OSC_IN | <input type="checkbox"/> | 2 | 19 | <input type="checkbox"/> | PA13 |
| PF1/OSC_OUT | <input type="checkbox"/> | 3 | 18 | <input type="checkbox"/> | PA10 (PA12) |
| NRST | <input type="checkbox"/> | 4 | 17 | <input type="checkbox"/> | PA9 (PA11) |
| V _{DDA} | <input type="checkbox"/> | 5 | TSSOP20 16 | <input type="checkbox"/> | V _{DD} |
| PA0 | <input type="checkbox"/> | 6 | 15 | <input type="checkbox"/> | V _{SS} |
| PA1 | <input type="checkbox"/> | 7 | 14 | <input type="checkbox"/> | PB1 |
| PA2 | <input type="checkbox"/> | 8 | 13 | <input type="checkbox"/> | PA7 |
| PA3 | <input type="checkbox"/> | 9 | 12 | <input type="checkbox"/> | PA6 |
| PA4 | <input type="checkbox"/> | 10 | 11 | <input type="checkbox"/> | PA5 |

The table below is AT32F421Series pin definition, "-" indicates that there is no such pin under the corresponding package.

surface5. AT32F421Series pin definition

| pin number | | | | | pin name (Function after reset) | pin type ⁽¹⁾ | I/O structure ⁽²⁾ | multiplexing function | Additional features |
|------------|-------|-------|--------|--------|-------------------------------------|-------------------------|------------------------------|---------------------------------------------------------------------------------------------|-----------------------------------------------|
| TSSOP20 | QFN28 | QFN32 | LQFP32 | LQFP48 | | | | | |
| -- | 1 | 1 | 1 | | V _{DD} | S | - | digital power | |
| - | - | - | - | 2 | PC13 | I/O | FT | - | TAMPER-RTC/WKUP2 |
| - | - | - | - | 3 | PC14/OSC32_IN (PC14) | I/O | TC | - | OSC32_IN |
| - | - | - | - | 4 | PC15/OSC32_OUT (PC15) | I/O | TC | - | OSC32_OUT |
| 2 | 2 | 2 | 2 | 5 | PF0/OSC_IN (PF0) | I/O | TC | I2C1_SDA | OSC_IN |
| 3 | 3 | 3 | 3 | 6 | PF1 / OSC_OUT (PF1) | I/O | TC | I2C1_SCL | OSC_OUT |
| 4 | 4 | 4 | 4 | 7 | NRST | I/O | R | Device reset input/internal reset output (active low) | |
| - | - | - | - | 8 | V _{SSA} /V _{REF-} | S | - | Analog Ground / Negative Reference Voltage | |
| 5 | 5 | 5 | 5 | 9 | V _{DDA} /V _{REF+} | S | - | Analog Supply / Positive Reference Voltage | |
| 6 | 6 | 6 | 6 | 10 | PA0 | I/O | FTa | TMR1_ETR / USART2_CTS / I2C2_SCL / COMP_OUT | ADC_IN0 / COMP_INP2 / COMP_INM6 / WKUP1 |
| 7 | 7 | 7 | 7 | 11 | PA1 | I/O | FTa | TMR15_CH1N/USART2_RTS/ I2C2_SDA / EVENTOUT | ADC_IN1 / COMP_INP1 |
| 8 | 8 | 8 | 8 | 12 | PA2 | I/O | FTa | TMR15_CH1 / USART2_TX | ADC_IN2 / COMP2_INM7 |
| 9 | 9 | 9 | 9 | 13 | PA3 | I/O | FTa | TMR15_CH2/USART2_RX/ I2S2_MCK | ADC_IN3 |
| 10 | 10 | 10 | 10 | 14 | PA4 | I/O | FTa | TMR14_CH1/USART2_CK/ SPI1_NSS / I2S1_WS | ADC_IN4/ COMP_INM4 |
| 11 | 11 | 11 | 11 | 15 | PA5 | I/O | FTa | SPI1_SCK / I2S1_CK | ADC_IN5 / COMP_INP0 / COMP_INM5 |
| 12 | 12 | 12 | 12 | 16 | PA6 | I/O | FTa | TMR1_BKIN/TMR3_CH1/ TMR16_CH1/SPI1_MISO/ I2S1_MCK / I2S2_MCK / COMP_OUT / EVENTOUT | ADC_IN6 |
| 13 | 13 | 13 | 13 | 17 | PA7 | I/O | FTa | TMR1_CH1N/TMR3_CH2/ TMR14_CH1/TMR17_CH1/ SPI1_MOSI/I2S1_SD/ EVENTOUT | ADC_IN7 |
| - | 14 | 14 | 14 | 18 | PB0 | I/O | FTa | TMR1_CH2N/TMR3_CH3/ USART2_RX/I2S1_MCK/ EVENTOUT | ADC_IN8 |
| 14 | 15 | 15 | 15 | 19 | PB1 | I/O | FTa | TMR1_CH3N/TMR3_CH4/ TMR14_CH1 / SPI2_SCK / I2S2_CK | ADC_IN9 |
| - | - | 16 | - | 20 | PB2 | I/O | FTa | TMR3_ETR | ADC_IN10 |

| pin number | | | | | pin name (Function after reset) | pin type ⁽¹⁾ | I/Ostructure ⁽²⁾ | multiplexing function | Additional features |
|-------------------|--------------|--------------|--------------|--------------|------------------------------------|-------------------------|-----------------------------|-------------------------------------------------------------------------------------------------|---------------------------------|
| TSSOP20 | QFN28 | QFN32 | LQFP32 | LQFP48 | | | | | |
| - | - | - | - | twenty one | PB10 | I/O | FT | SPI2_SCK/I2S2_CK/ I2C2_SCL | - |
| - | - | - | - | twenty two | PB11 | I/O | FT | I2C2_SDA / EVENTOUT | - |
| 15 | 16 | - | 16 | twenty three | V _{SS} | S | - | digitally | |
| 16 | 17 | 17 | 17 | twenty four | V _{DD} | S | - | digital power | |
| - | - | - | - | 25 | PB12 | I/O | FTa | TMR1_BKIN / TMR15_BKIN / SPI2_NSS / I2S2_WS / I2C2_SMBA / EVENTOUT | ADC_IN11 |
| - | - | - | - | 26 | PB13 | I/O | FTa | TMR1_CH1N / SPI2_SCK/I2S2_CK/ I2C2_SCL | ADC_IN12 |
| - | - | - | - | 27 | PB14 | I/O | FTa | TMR1_CH2N/TMR15_CH1/ SPI2_MISO/I2S2_MCK/ I2C2_SDA | ADC_IN13 |
| - | - | - | - | 28 | PB15 | I/O | FTa | TMR1_CH3N / TMR15_CH2/TMR15_CH1N/ SPI2_MOSI/I2S2_SD | ADC_IN14 / RTC_REFIN / WKUP7 |
| - | 18 | 18 | 18 | 29 | PA8 | I/O | FT | TMR1_CH1 / USART1_CK / UART2_TX / I2C2_SCL / CLKOUT / EVENTOUT | - |
| 17 | 19 | 19 | 19 | 30 | PA9 | I/O | FT | TMR1_CH2/TMR15_BKIN/ USART1_TX / I2C1_SCL/I2C2_SMBA/ CLKOUT | - |
| 18 | 20 | 20 | 20 | 31 | PA10 | I/O | FT | TMR1_CH3 / TMR17_BKIN / USART1_RX / I2C1_SDA | - |
| 17 ⁽³⁾ | -(4) | twenty one | twenty one | 32 | PA11 | I/O | FT | TMR1_CH4/USART1_CTS/ I2C1_SMBA / I2C2_SCL / COMP_OUT / EVENTOUT | - |
| 18 ⁽³⁾ | -(4) | twenty two | twenty two | 33 | PA12 | I/O | FT | TMR1_ETR / USART1_RTS / I2C2_SDA / EVENTOUT | - |
| 19 | twenty one | twenty three | twenty three | 34 | PA13 (SWDIO ⁽⁵⁾) | I/O | FT | PA13/IR_OUT/ SPI2_MISO/I2S2_MCK | - |
| - | - | - | - | 35 | PF6 | I/O | FT | I2C2_SCL | - |
| - | - | - | - | 36 | PF7 | I/O | FT | I2C2_SDA | - |
| 20 | twenty two | twenty four | twenty four | 37 | PA14 (SWCLK ⁽⁵⁾) | I/O | FT | PA14/USART2_TX/ SPI2_MOSI/I2S2_SD | - |
| - | twenty three | 25 | 25 | 38 | PA15 | I/O | FT | USART2_RX / SPI1_NSS/I2S1_WS/ SPI2_NSS/I2S2_WS/ EVENTOUT | - |
| - | twenty four | 26 | 26 | 39 | PB3 | I/O | FT | SPI1_SCK / I2S1_CK / SPI2_SCK / I2S2_CK / EVENTOUT | - |
| - | 25 | 27 | 27 | 40 | PB4 | I/O | FT | TMR3_CH1/TMR17_BKIN/ SPI1_MISO / I2S1_MCK / SPI2_MISO / I2S2_MCK / I2C2_SDA / EVENTOUT | - |

| pin number | | | | | pin name (Function after reset) | pin type ⁽¹⁾ | I/O structure ⁽²⁾ | multiplexing function | Additional features |
|------------|-------|-------|--------|--------|----------------------------------------------|-------------------------|------------------------------|-------------------------------------------------------------------------------|---------------------|
| TSSOP20 | QFN28 | QFN32 | LQFP32 | LQFP48 | | | | | |
| - | 26 | 28 | 28 | 41 | PB5 | I/O | FT | TMR3_CH2/TMR16_BKIN/ SPI1_MOSI/I2S1_SD/ SPI2_MOSI/I2S2_SD/ I2C1_SMBA | WKUP6 |
| - | 27 | 29 | 29 | 42 | PB6 | I/O | FT | TMR16_CH1N/USART1_TX/ I2S1_MCK / I2C1_SCL | - |
| - | 28 | 30 | 30 | 43 | PB7 | I/O | FT | TMR17_CH1N/USART1_RX/ I2C1_SDA | - |
| 1 | 1 | 31 | 31 | 44 | BOOT0 | I | B | Boot mode selection0 | |
| - | - | 32 | - | 45 | PB8 | I/O | FT | TMR16_CH1/I2C1_SCL | |
| - | - | - | - | 46 | PB9 | I/O | FT | TMR17_CH1/IR_OUT/ SPI2_NSS/I2S2_WS/ I2S1_MCK/I2C1_SDA/ EVENTOUT | |
| - | - | - | 32 | 47 | V _{SS} | S | - | digitally | |
| - | - | - | - | 48 | V _{DD} | S | - | digital power | |
| - | 29 | 33 | - | - | EPAD (V _{SS} /V _{SSA}) | S | - | Digital Ground/ Analog Ground | |

(1) I =enter, O =output, S =power supply.

(2) TC =standard level, FT =generally 5V level tolerance, FTa =with analog function 5V level tolerance, R =Bidirectional reset pin with built-in weak pull-up resistor, B = Dedicated with built-in weak pull-down resistor BOOT0 pin. FTa When the pin is set as input floating, input pull-up, or input pull-down, it has 5V level tolerance; when set to analog mode, no 5V level tolerance characteristics, at this time the input level must be less than VDD + 0.3V.

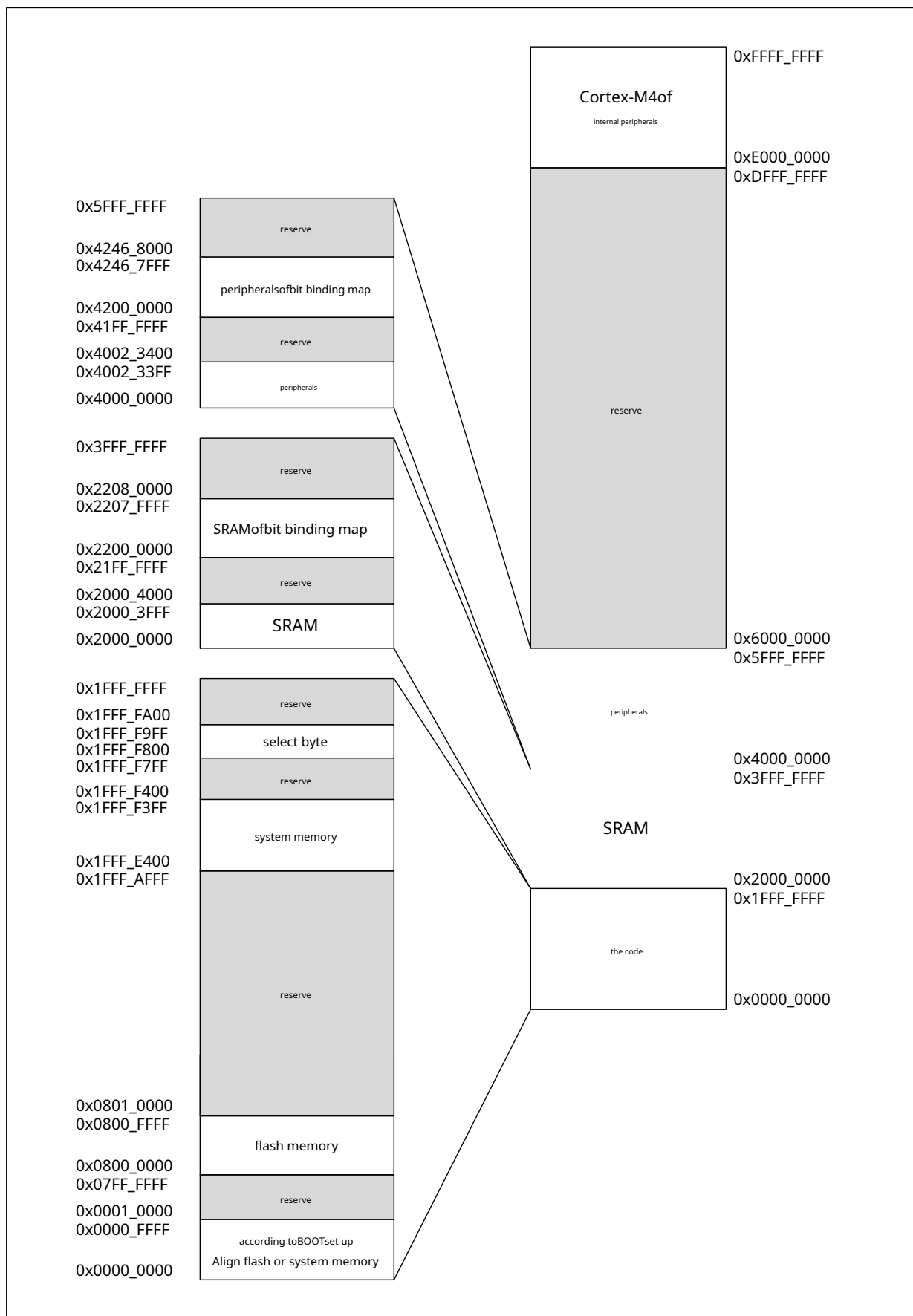
(3) exist TSSOP20 Package support PA11/PA12 and its multiplexing functions replace the original through software remapping PA9/PA10 and its reuse function.

(4) exist QFN28 package, even if PA11 and PA12 Not available on the package, they should be treated as unused pins. Hardware will not force them to a fixed level, it is recommended that software set them to a fixed level or analog mode to prevent leakage.

(5) After reset, PA13/PA14 pins are configured as alternate function SWDIO/SWCLK, at this time SWDIO pins with internal pull-up resistors and SWCLK The pin's internal pull-down resistor is turned on.

5 memory image

picture8.memory map



6 electrical characteristics

6.1 Test Conditions

Unless otherwise specified, all voltages are in V_{SS} as the benchmark.

6.1.1 Minimum and maximum values

Unless otherwise specified, in the production line at ambient temperature $T_A = 25^{\circ}\text{C}$ and $T_A = T_{Amax}$. Tests performed under (T_{Amax} match the selected temperature range), all minimum and maximum values are guaranteed under worst-case ambient temperature, supply voltage, and clock frequency conditions.

Notes below each table represent data obtained through comprehensive evaluation, design simulations, and/or process characterization and will not be tested in production line.

6.1.2 typical value

Unless otherwise stated, typical data are based on $T_A = 25^{\circ}\text{C}$ and $V_{DD} = 3.3\text{V}$. These data are for design guidance only and not tested.

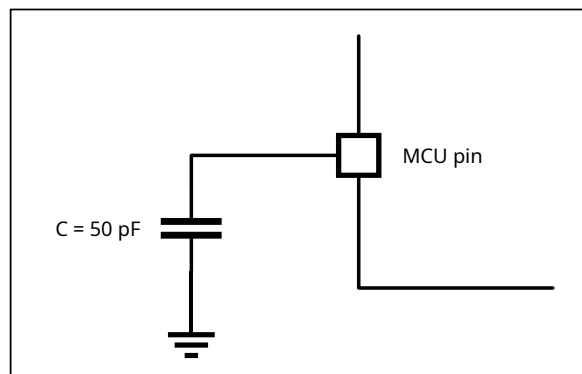
6.1.3 typical curve

Unless otherwise stated, typical curves are for design guidance only and are not tested.

6.1.4 load capacitance

The load conditions when measuring pin parameters are shown in [picture9](#) middle.

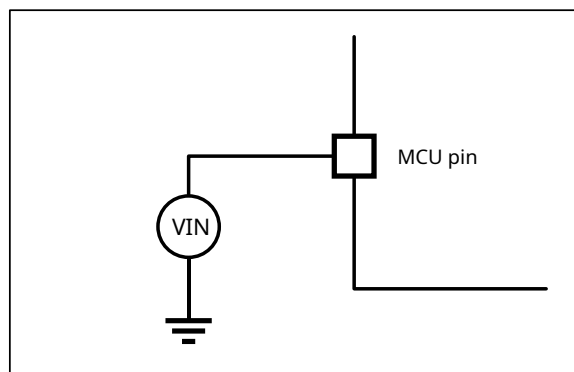
picture9. The load condition of the pin



6.1.5 pin input voltage

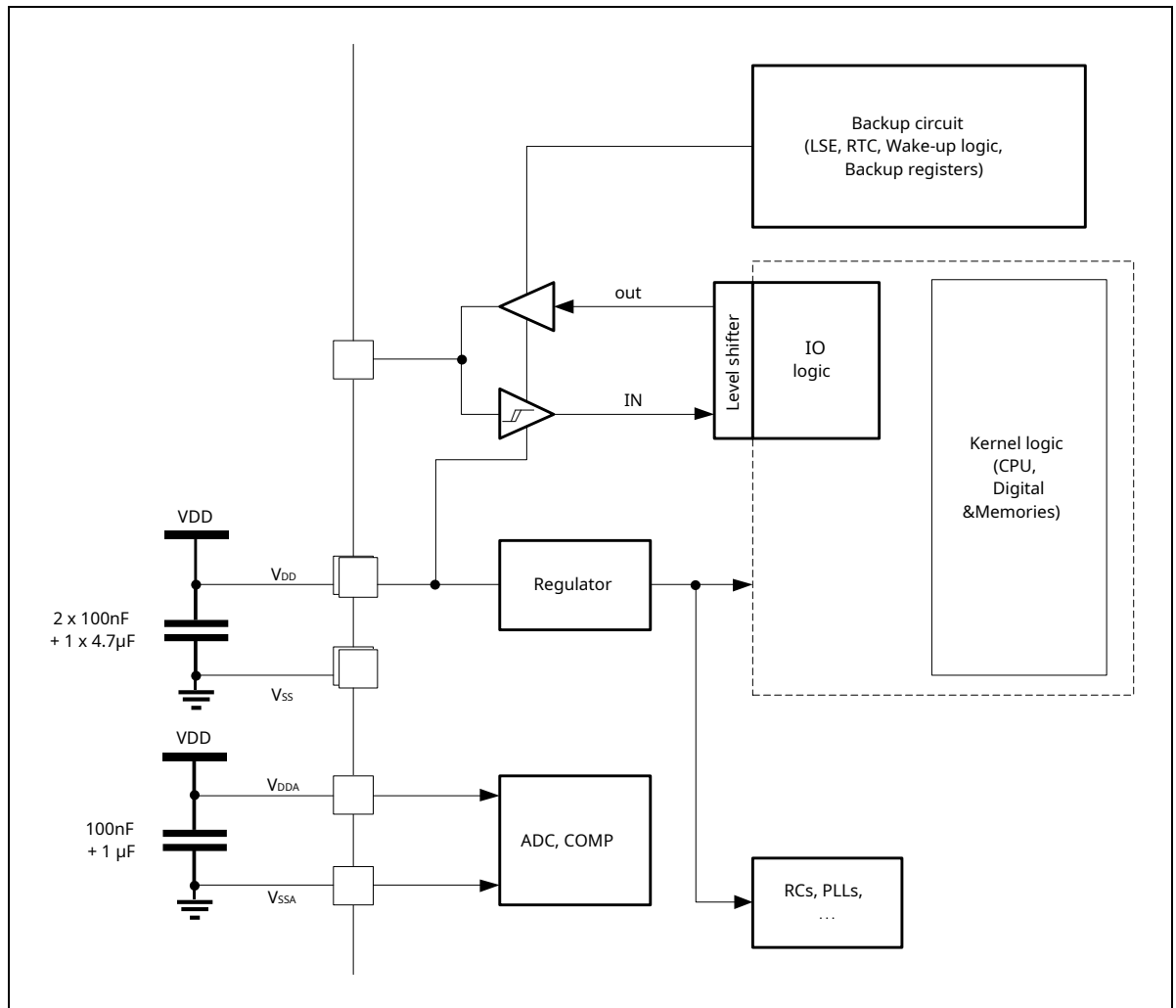
The input voltage at the pin is measured as shown in the [picture10](#) middle.

picture10. pin input voltage



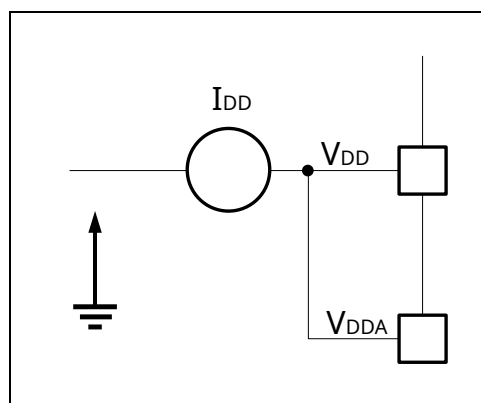
6.1.6 Power supply scheme

picture11.Power supply scheme



6.1.7 Current consumption measurement

picture12.Current Consumption Measurement Solution



6.2

Absolute Maximum Ratings

Loads applied to the device in excess of those listed in the "Absolute Maximum Ratings" ([surface6](#), [surface7](#), [surface8](#)), may cause permanent damage to the device. The maximum load that can be tolerated here is only given, and it does not mean that the functional operation of the device under this condition is correct. The long-term operation of the device under the maximum value will affect the reliability of the device.

surface6.Voltage characteristics

| symbol | describe | minimum value | maximum value | unit |
|-----------------------------------|----------------------------------------------------------------------------------------------------------------|----------------------|---------------|------|
| V _{DD} -V _{SS} | External mains supply voltage (includesV _{DDA} andV _{DD})(1) | - 0.3 | 4.0 | V |
| V _{IN} | existFTThe input voltage on the pin | V _{SS} -0.3 | 6.0 | |
| | existFTaThe input voltage on the pin, the pin is set to input floating, input pull-up, or input pull-down mode | | | |
| | existTCThe input voltage on the pin | V _{SS} -0.3 | 4.0 | |
| | existFTaThe input voltage on the pin, the pin is set to analog mode | | | |
| ΔV _{DDx} | Voltage difference between different supply pins | - | 50 | mV |
| V _{SSx} -V _{SS} | The voltage difference between different ground pins | - | 50 | |

(1) All power supplies (V_{DD} , V_{DDA}) and land (V_{SS} , V_{SSA}) pins must always be connected to an external power supply within the allowable range.

surface7.Current characteristics

| symbol | describe | maximum value | unit |
|-----------|--------------------------------------------------------------------------------|---------------|------|
| I_{VDD} | External mains supply voltage (includes V_{DDA} and V_{DD})(1) | 150 | mA |
| I_{VSS} | go through V_{SS} The total current of the ground wire (outgoing current)(1) | 150 | |
| I_{IO} | arbitrarily I/O and the output sink current on the CONTROL pin | 25 | |
| | arbitrarily I/O and the output current on the CONTROL pin | - 25 | |

(1) All power supplies (V_{DD} , V_{DDA}) and land (V_{SS} , V_{SSA}) pins must always be connected to an external power supply within the allowable range.

surface8.temperature characteristics

| symbol | describe | value | unit |
|-----------|------------------------------|-------------|------|
| T_{STG} | storage temperature range | - 60 ~ +150 | °C |
| T_J | maximum junction temperature | 125 | |

6.3 working conditions

6.3.1general working conditions

surface9.general working conditions

| symbol | parameter | condition | minimum value | maximum value | unit |
|---------------------------------|------------------------------------------|-------------------------------------|---------------|---------------|------|
| f _{HCLK} | internalAHBClock frequency | - | 0 | 120 | MHz |
| f _{PCLK1} | internalAPB1Clock frequency | - | 0 | 120 | MHz |
| f _{PCLK2} | internalAPB2Clock frequency | - | 0 | 120 | MHz |
| V _{DD} | Standard working voltage | - | 2.4 | 3.6 | V |
| V _{DDA} ⁽¹⁾ | Analog part operating voltage | must be withV _{DD(1)} same | 2.4 | 3.6 | V |
| P _D | Power Dissipation:T _A = 105°C | LQFP48 (7 x 7 mm) | - | 230 | mW |
| | | LQFP32 (7 x 7mm) | - | 243 | |
| | | QFN32 (5x5mm) | - | 503 | |
| | | QFN32 (4x4mm) | - | 446 | |
| | | QFN28 (4x4mm) | - | 446 | |
| | | TSSOP20 (6.5 x 4.4mm) | - | 194 | |
| T _A | ambient temperature | - | - 40 | 105 | °C |

(1)It is recommended to use the same power supply asV_{DD}andV_{DDA}power supply, during power-up and normal operation, theV_{DD}andV_{DDA} maximum of300mVdifference.

6.3.2Operating Conditions During Power-Up and Power-Down

The parameters given in the table below are based onsurface9Tested at ambient temperature listed.

surface10.Operating Conditions During Power-Up and Power-Down

| symbol | parameter | condition | minimum value | maximum value | unit |
|------------------|---------------------------------|-----------|---------------|---------------|------|
| t _{VDD} | V _{DD} rate of ascent | - | 0 | ∞ | ms/V |
| | V _{DD} rate of descent | | 20 | ∞ | μs/V |

6.3.3 Built-in reset and power control block features

The parameters given in the table below are based on [surface9](#) listed ambient temperature and V_{DD} Tested under supply voltage.

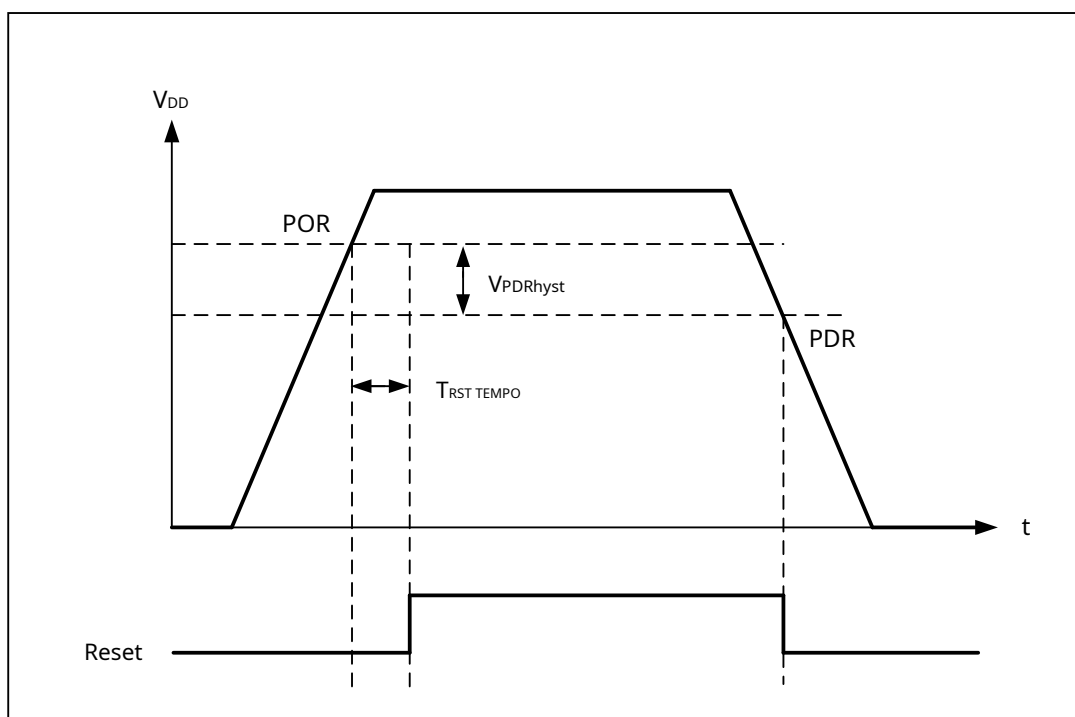
surface11.Embedded Reset and Power Control Block Features

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|---------------------|----------------------------------------------------------------------------------------------------------------|--------------|---------------------|---------------|---------------------|------|
| $V_{POR/PDR}$ | Power-on/power-down reset threshold | falling edge | 1.62 ⁽¹⁾ | 1.88 | 2.16 ⁽²⁾ | V |
| | | rising edge | 1.73 ⁽²⁾ | 2.06 | 2.4 | V |
| $V_{PDRhyst}^{(2)}$ | PDRhysteresis | - | - | 180 | - | mV |
| $T_{RST\ TEMP0(2)}$ | Reset duration: V_{DD} higher than V_{POR} and lasts longer than $T_{RST\ TEMP0}$ back CPU start operation | - | - | 4.5 | - | ms |

(1) The characteristics of the product are guaranteed by design to the minimum value $V_{POR/PDR}$.

(2) Guaranteed by design, not tested in production.

picture13.Waveform diagram of power-on reset and power-off reset



surface12.Programmable Voltage Detector Features

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|-------------------------------------|-------------------------------|----------------------------|---------------|---------------|-------------------|------|
| V _{PVD1} | PVDthreshold1(PLS[2:0] = 001) | rising edge ⁽¹⁾ | 2.19 | 2.28 | 2.37 | V |
| | | falling edge | 2.09 | 2.18 | 2.27 | V |
| V _{PVD2} | PVDthreshold2(PLS[2:0] = 010) | rising edge | 2.28 | 2.38 | 2.48 | V |
| | | falling edge | 2.18 | 2.28 | 2.38 | V |
| V _{PVD3} | PVDthreshold3(PLS[2:0] = 011) | rising edge | 2.38 | 2.48 | 2.58 | V |
| | | falling edge | 2.28 | 2.38 | 2.48 | V |
| V _{PVD4} | PVDthreshold4(PLS[2:0] = 100) | rising edge | 2.47 | 2.58 | 2.69 | V |
| | | falling edge | 2.37 | 2.48 | 2.59 | V |
| V _{PVD5} | PVDthreshold5(PLS[2:0] = 101) | rising edge | 2.57 | 2.68 | 2.79 | V |
| | | falling edge | 2.47 | 2.58 | 2.69 | V |
| V _{PVD6} | PVDthreshold6(PLS[2:0] = 110) | rising edge | 2.66 | 2.78 | 2.9 | V |
| | | falling edge | 2.56 | 2.68 | 2.8 | V |
| V _{PVD7} | PVDthreshold7(PLS[2:0] = 111) | rising edge | 2.76 | 2.88 | 3 | V |
| | | falling edge | 2.66 | 2.78 | 2.9 | V |
| V _{PVDhyst} ⁽²⁾ | PVDhysteresis | - | - | 100 | - | mV |
| I _{DD} (PVD) | PVDcurrent consumption | - | - | 20 | 30 ⁽²⁾ | μA |

(1) PLS[2:0] = 001level may be lower than theV_{PD}not available.

(2)Guaranteed by design, not tested in production.

6.3.4Built-in reference voltage

The parameters given in the table below are based on[surface9](#)listed ambient temperature andV_{DD}Tested under supply voltage.

surface13.Built-in reference voltage

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|---------------------------------------|---------------------------------------------------------------------|-----------|---------------|---------------|---------------------|--------|
| V _{REFINT} | Built-in reference voltage | - | 1.17 | 1.20 | 1.23 | V |
| T _{S_vrefint} ⁽¹⁾ | When reading the internal reference voltage,ADCThe sampling time of | - | - | 5.1 | 17.1 ⁽²⁾ | μs |
| T _{Coeff} ⁽²⁾ | Temperature Coefficient | - | - 120 | - | 120 | ppm/°C |

(1)The shortest sample time is obtained by looping through the application multiple times.

(2)Guaranteed by design, not tested in production.

6.3.5 Supply Current Characteristics

Current consumption is a composite indicator of various parameters and factors, including operating voltage, ambient temperature, I/O pin loading, product software configuration, operating frequency, I/O flip rate of the foot, and the code executed, etc.

For the description of the measurement method of current consumption, see [picture 12](#).

Typical Current Consumption

The microcontroller is subjected to the following conditions:

- all I/O pins are in analog mode.
- Flash memory access time varies with f_{HCLK} frequency adjustment (0 ~ 32 MHz when 0 waiting period, 33 ~ 64 MHz when 1 waiting period, 65 ~ 96 MHz when 2 waiting period, more than 96 MHz when 3 waiting period).
- The instruction prefetch function is enabled (reminder: this parameter must be set before setting the clock and bus frequency division).
- ambient temperature and V_{DD} The supply voltage complies with [surface 9](#).
- $f_{PCLK1} = f_{HCLK}$, $f_{PCLK2} = f_{HCLK}$, $f_{ADCCLK} = f_{PCLK2}/8$.

surface 14. Typical current consumption in run mode

| symbol | parameter | condition | f_{HCLK} | typical value ⁽¹⁾ | | unit |
|----------|-------------------------------|-------------------------------------------------|------------|------------------------------|--------------------------|------|
| | | | | Enable all peripherals | turn off all peripherals | |
| I_{DD} | in run mode supply current | external clock ⁽²⁾ | 120 MHz | 16.7 | 11.3 | mA |
| | | | 108 MHz | 15.2 | 10.3 | |
| | | | 72 MHz | 10.5 | 7.19 | |
| | | | 48 MHz | 7.62 | 5.44 | |
| | | | 36 MHz | 5.98 | 4.34 | |
| | | | 24 MHz | 4.65 | 3.54 | |
| | | | 16 MHz | 3.45 | 2.71 | |
| | | | 8 MHz | 1.96 | 1.57 | |
| | | | 4 MHz | 1.50 | 1.30 | |
| | | | 2 MHz | 1.27 | 1.16 | |
| | | | 1 MHz | 1.16 | 1.10 | |
| | | | 500 kHz | 1.10 | 1.07 | |
| | | | 125 kHz | 1.06 | 1.04 | |
| | | run at high speed inside RC oscillator (HSI) | 120 MHz | 16.7 | 11.3 | mA |
| | | | 108 MHz | 15.1 | 10.3 | |
| | | | 72 MHz | 10.4 | 7.14 | |
| | | | 48 MHz | 7.52 | 5.38 | |
| | | | 36 MHz | 5.88 | 4.27 | |
| | | | 24 MHz | 4.53 | 3.47 | |
| | | | 16 MHz | 3.34 | 2.63 | |
| | | | 8 MHz | 1.83 | 1.48 | |
| | | | 4 MHz | 1.37 | 1.20 | |
| | | | 2 MHz | 1.15 | 1.06 | |
| | | | 1 MHz | 1.03 | 0.99 | |
| | | | 500 kHz | 0.97 | 0.95 | |
| | | | 125 kHz | 0.93 | 0.93 | |

(1)Typical values are in $T_A = 25^{\circ}\text{C}$, $V_{DD} = 3.3\text{V}$ When the test is obtained.

(2)The external clock is 8 MHz, when $f_{HCLK} > 8\text{ MHz}$ enabled when PLLs.

surface15. Typical current consumption in sleep mode

| symbol | parameter | condition | f_{HCLK} | typical value ⁽¹⁾ | | unit |
|-----------------|---------------------------------|------------------------------------------------|------------|------------------------------|--------------------------|------|
| | | | | Enable all peripherals | turn off all peripherals | |
| I _{DD} | in sleep mode supply current | external clock ⁽²⁾ | 120 MHz | 12.2 | 4.99 | mA |
| | | | 108MHz | 11.1 | 4.59 | |
| | | | 72MHz | 7.76 | 3.38 | |
| | | | 48MHz | 5.81 | 2.89 | |
| | | | 36 MHz | 4.60 | 2.42 | |
| | | | 24 MHz | 3.70 | 2.25 | |
| | | | 16 MHz | 2.80 | 1.83 | |
| | | | 8 MHz | 1.60 | 1.11 | |
| | | | 4 MHz | 1.30 | 1.05 | |
| | | | 2 MHz | 1.15 | 1.02 | |
| | | | 1 MHz | 1.07 | 1.00 | |
| | | | 500 kHz | 1.03 | 0.99 | |
| | | | 125 kHz | 1.00 | 0.98 | |
| | | run at high speed inside RCoscillator (HSI) | 120 MHz | 12.1 | 4.88 | mA |
| | | | 108MHz | 11.0 | 4.47 | |
| | | | 72MHz | 7.65 | 3.27 | |
| | | | 48MHz | 5.70 | 2.78 | |
| | | | 36 MHz | 4.49 | 2.30 | |
| | | | 24 MHz | 3.59 | 2.13 | |
| | | | 16 MHz | 2.68 | 1.71 | |
| | | | 8 MHz | 1.47 | 0.98 | |
| | | | 4 MHz | 1.17 | 0.93 | |
| | | | 2 MHz | 1.02 | 0.89 | |
| | | | 1 MHz | 0.94 | 0.88 | |
| | | | 500 kHz | 0.90 | 0.87 | |
| | | | 125 kHz | 0.87 | 0.86 | |

(1)Typical values are in $T_A = 25^{\circ}\text{C}$, $V_{DD} = 3.3\text{V}$ When the test is obtained.

(2)The external clock is 8 MHz, when $f_{HCLK} > 8\text{ MHz}$ enabled when PLLs.

Maximum current consumption

The microcontroller is subjected to the following conditions:

- all I/O pins are in analog mode.
- Flash memory access time varies with f_{HCLK} frequency adjustment (0 ~ 32MHz when 0 waiting period, 33 ~ 64MHz when 1 waiting period, 65 ~ 96MHz when 2 waiting period, more than 96 MHz when 3 waiting period).
- The instruction prefetch function is enabled (reminder: this parameter must be set before setting the clock and bus frequency division).
- When turning on a peripheral: $f_{PCLK1} = f_{HCLK}$, $f_{PCLK2} = f_{HCLK}$, $f_{ADCCLK} = f_{PCLK2}/8$.

surface16 and surface17 The parameters given are at ambient temperature and V_{DD} . The supply voltage complies with surface9. The conditional test is obtained.

surface16. Maximum current consumption in run mode

| symbol | parameter | condition | f_{HCLK} | maximum value(1) | | unit |
|----------|----------------------------|--------------------------------------------|------------|---------------------|----------------------|------|
| | | | | $T_A = 85^{\circ}C$ | $T_A = 105^{\circ}C$ | |
| I_{DD} | Supply current in run mode | external clock(2) Enable all peripherals | 120 MHz | 18.9 | 20.7 | mA |
| | | | 108MHz | 17.3 | 19.1 | |
| | | | 72MHz | 12.6 | 14.4 | |
| | | | 48MHz | 9.69 | 11.5 | |
| | | | 36 MHz | 8.04 | 9.81 | |
| | | | 24 MHz | 6.69 | 8.45 | |
| | | | 16 MHz | 5.49 | 7.24 | |
| | | | 8 MHz | 3.99 | 5.73 | |
| | | external clock(2) turn off all peripherals | 120 MHz | 13.5 | 15.2 | mA |
| | | | 108MHz | 12.4 | 14.2 | |
| | | | 72MHz | 9.29 | 11.0 | |
| | | | 48MHz | 7.52 | 9.26 | |
| | | | 36 MHz | 6.41 | 8.14 | |
| | | | 24 MHz | 5.60 | 7.33 | |
| | | | 16 MHz | 4.76 | 6.49 | |
| | | | 8 MHz | 3.61 | 5.35 | |

(1) Derived from comprehensive evaluation, not tested in production.

(2) The external clock is 8 MHz, when $f_{HCLK} > 8$ MHz enabled when PLLs.

surface17.Maximum Current Consumption in Sleep Mode

| symbol | parameter | condition | f _{HCLK} | maximum value ⁽¹⁾ | | unit |
|-----------------|------------------------------|-------------------------------------------------------|-------------------|------------------------------|------------------------|------|
| | | | | T _A = 85°C | T _A = 105°C | |
| I _{DD} | Supply Current in Sleep Mode | external clock ₂ ;Enable all peripherals | 120 MHz | 14.4 | 16.1 | mA |
| | | | 108MHz | 13.3 | 15.0 | |
| | | | 72MHz | 9.85 | 11.6 | |
| | | | 48MHz | 7.89 | 9.58 | |
| | | | 36 MHz | 6.69 | 8.36 | |
| | | | 24 MHz | 5.79 | 7.45 | |
| | | | 16 MHz | 4.88 | 6.53 | |
| | | | 8 MHz | 3.68 | 5.31 | |
| | | external clock ₂ ;turn off all peripherals | 120 MHz | 7.06 | 8.70 | mA |
| | | | 108MHz | 6.66 | 8.30 | |
| | | | 72MHz | 5.45 | 7.09 | |
| | | | 48MHz | 4.96 | 6.57 | |
| | | | 36 MHz | 4.48 | 6.12 | |
| | | | 24 MHz | 4.31 | 5.93 | |
| | | | 16 MHz | 3.89 | 5.53 | |
| | | | 8 MHz | 3.18 | 4.81 | |

(1)Derived from comprehensive evaluation, not tested in production.

(2)The external clock is 8 MHz,when f_{HCLK}> 8 MHz enabled when PLLs.

surface18.Typical and Maximum Current Consumption in Shutdown and Standby Modes

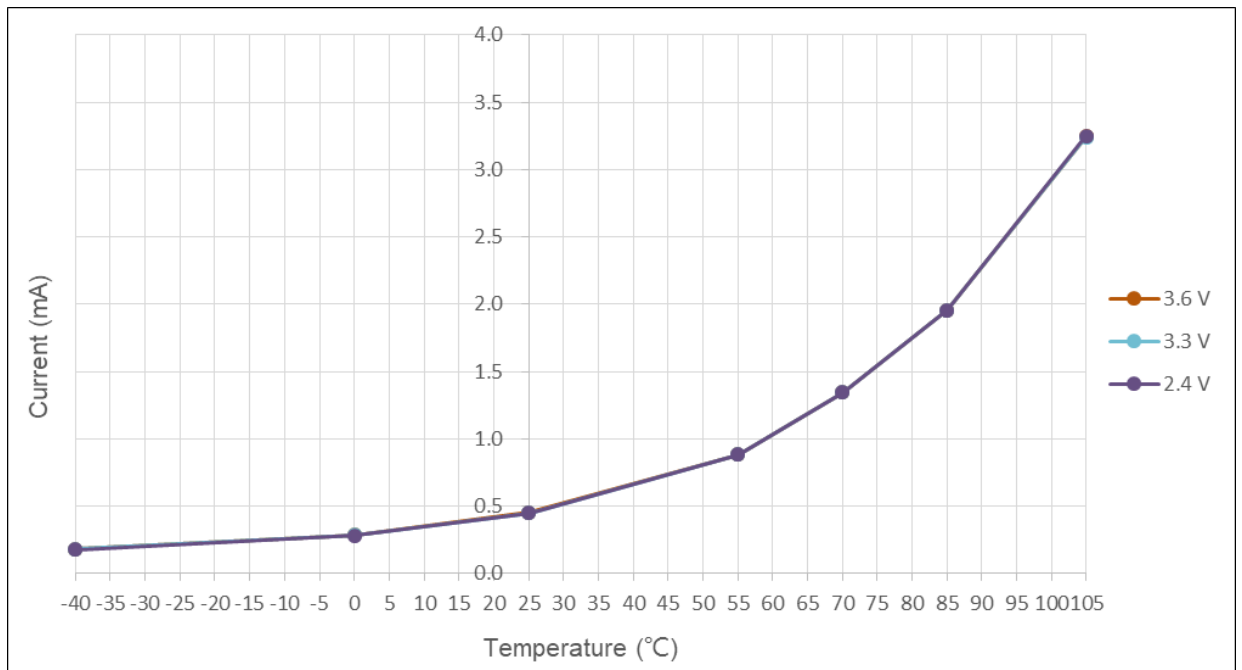
| symbol | parameter | condition | typical value ⁽¹⁾ | | maximum value ⁽²⁾ | | unit |
|-----------------|---------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------|------------------------|------------------------------|------------------------|------|
| | | | V _{DD} = 2.4V | V _{DD} = 3.3V | T _A = 85°C | T _A = 105°C | |
| I _{DD} | in stop mode supply current (3) | regulator is in run mode, the high-speed internal RC oscillators and high-speed external oscillators at in shutdown state (no independent watchdog) | 445 | 450 | 4100 | 6750 | μA |
| | | The regulator is in low power mode and the LPDS1 Set as 1, high-speed internal RC Oscillator and High Speed External Oscillator are off Closed state (no independent watchdog) | 205 | 210 | 2000 | 3315 | |
| | in standby mode supply current | low speed external oscillator and RTC is off state | 2.4 | 3.6 | 5.9 | 7.6 | μA |
| | | low speed external oscillator and RTC is on state | 3.2 | 5.1 | 7.2 | 9.2 | |

(1)Typical values are in T_A= 25°C The next test is obtained.

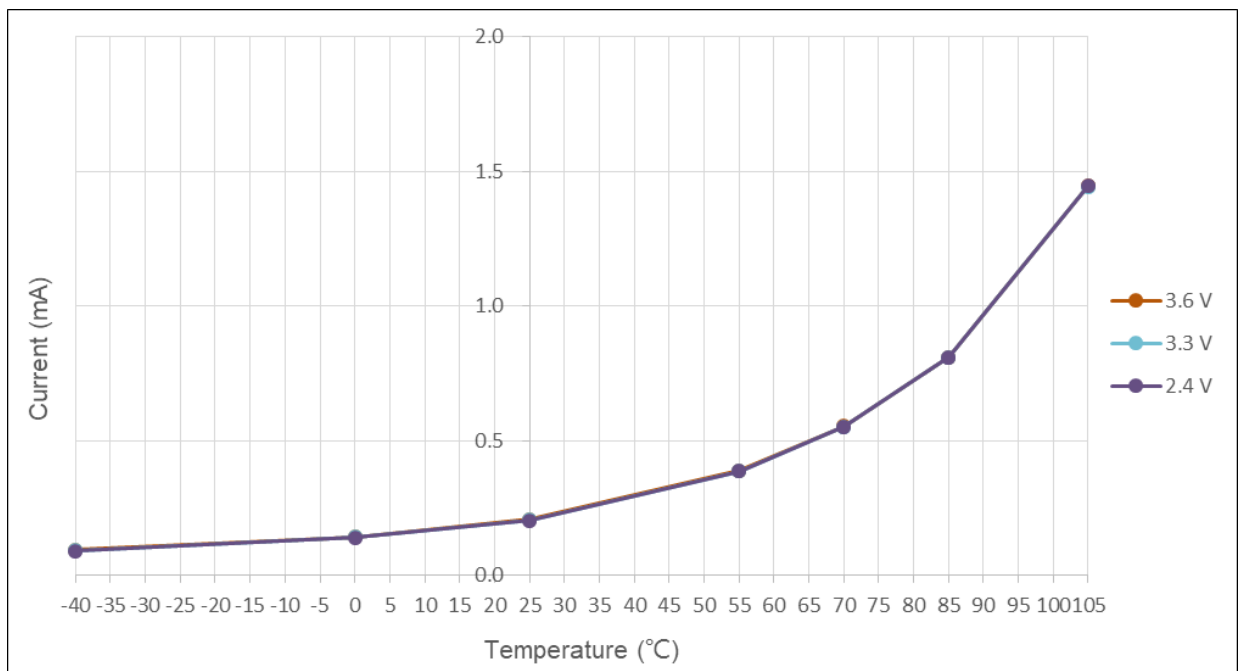
(2)Derived from comprehensive evaluation, not tested in production.

(3)Before entering stop mode RCC_AHBN[4] (FLASHEN) must be set to 1, otherwise the typical value will generate an additional approx. 50 μA power consumption.

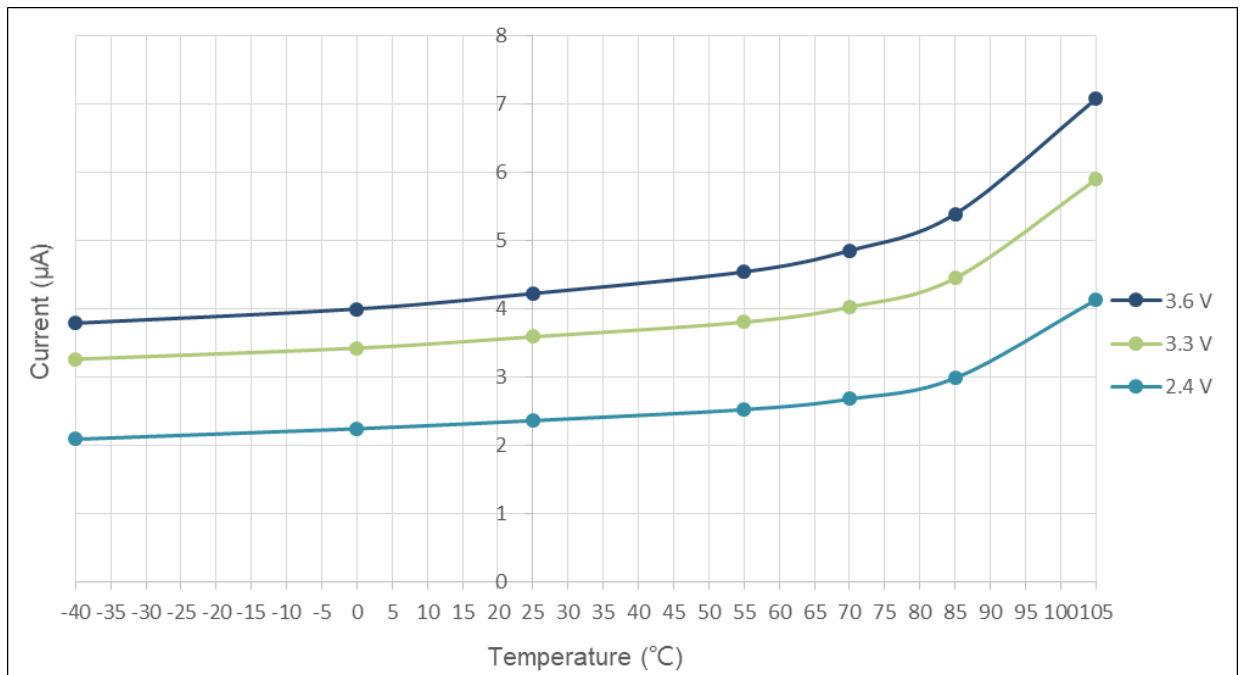
picture14. When the regulator is in run mode, the typical current consumption in stop mode varies between V_{DD} time versus temperature



picture15. When the regulator is in low-power mode, the typical current consumption in shutdown mode varies between V_{DD} time versus temperature



picture16. Typical current consumption in standby mode at different V_{DD} time versus temperature



Built-in Peripheral Current Consumption

The current consumption of the built-in peripherals is listed in [surface19](#), the operating conditions of the microcontroller are as follows:

- all I/O pins are in analog mode.
- All peripherals are turned off unless otherwise noted.
- The values given are calculated by measuring the current consumption
 - Turn off clocks to all peripherals
 - Turn on the clock of only one peripheral
- ambient temperature and V_{DD} The supply voltage conditions are listed in the [surface9](#).

surface19.Current Consumption of Built-in Peripherals

| built-in peripherals | | typical value | unit |
|----------------------|-------------|---------------|--------------------------|
| AHB(up to 120 MHz) | DMA1 | 2.15 | $\mu\text{A}/\text{MHz}$ |
| | SRAM | 1.06 | |
| | Flash | 12.08 | |
| | GPIOA | 0.50 | |
| | GPIOB | 0.50 | |
| | GPIOC | 0.50 | |
| | GPIOF | 0.50 | |
| | CRC | 0.70 | |
| APB1(up to 120 MHz) | TMR3 | 6.29 | |
| | TMR6 | 0.49 | |
| | TMR14 | 2.28 | |
| | SPI2/I2S2 | 2.26 | |
| | USART2 | 2.11 | |
| | I2C1 | 1.71 | |
| | I2C2 | 1.68 | |
| | WWDG | 0.20 | |
| | PWR | 0.39 | |
| APB2(up to 120 MHz) | SYSCFG/COMP | 0.29 | |
| | SPI1/I2S1 | 2.03 | |
| | USART1 | 2.12 | |
| | TMR1 | 7.68 | |
| | TMR15 | 4.65 | |
| | TMR16 | 3.19 | |
| | TMR17 | 3.41 | |
| | ADC1 | 5.17 | |
| | ACC | 0.95 | |

6.3.6 External Clock Source Characteristics

High-speed external user clock generated by external oscillator source

In bypass mode, HSE oscillator off, input pins are standard GPIOs.

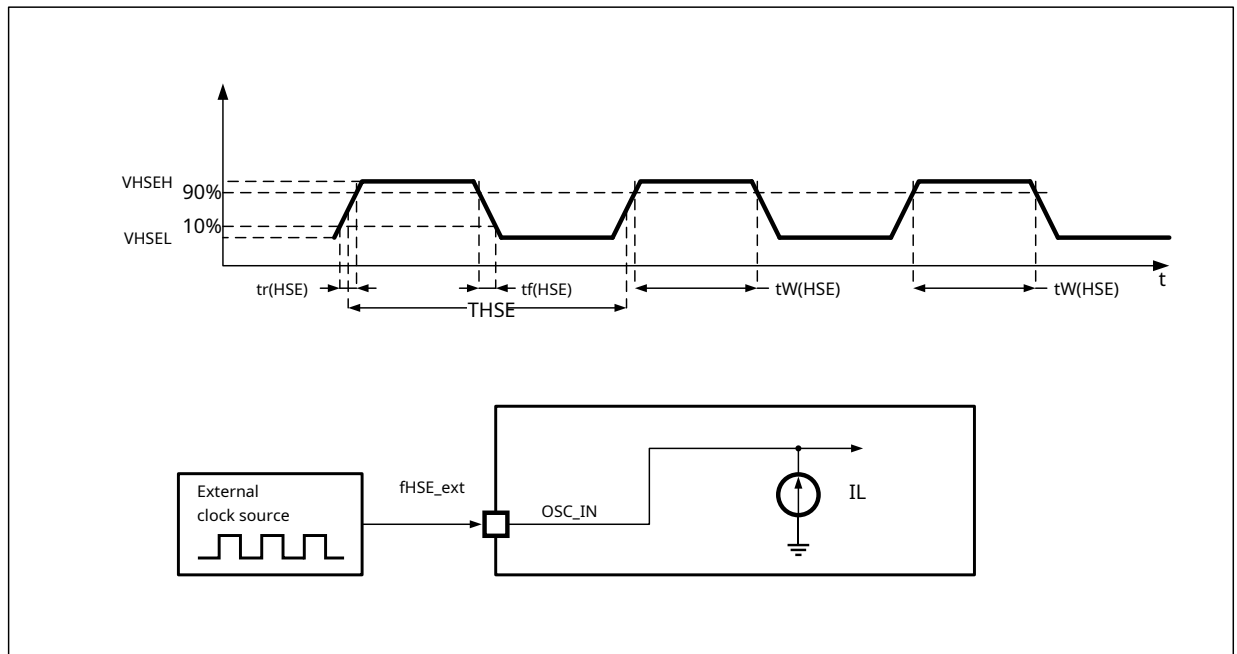
The external clock signal must take into account the first 6.3.7.3 in the chapter 1/O characteristic. However, the suggested clock input waveform is shown in picture 17 middle.

surface20.High-Speed External User Clock Features

| symbol | parameter ⁽¹⁾ | condition | minimum value | typical value | maximum value | unit |
|--------------------------------------------|------------------------------------|---------------------------------------------------|--------------------|---------------|--------------------|------|
| f _{HSE_ext} | User external clock frequency | - | 1 | 8 | 25 | MHz |
| V _{HSEH} | OSC_INInput pin high level voltage | | 0.7V _{DD} | - | V _{DD} | V |
| V _{HSEL} | OSC_INInput pin low level voltage | | V _{SS} | - | 0.3V _{DD} | |
| t _{w(HSE)} t _{w(HSE)} | OSC_INhigh or low time | | 5 | - | - | ns |
| t _{r(HSE)} t _{f(HSE)} | OSC_INrise or fall time | | - | - | 20 | |
| DuCy _(HSE) | duty cycle | | - | 45 | - | |
| I _L | OSC_INinput leakage current | V _{SS} ≤V _{IN} ≤V _{DD} | - | - | ±1 | μA |

(1) Guaranteed by design, not tested in production.

picture17.AC Timing Diagram for External High Speed Clock Source



Low-speed external user clock from external oscillator source

In bypass mode, LSE oscillator off, input pins are standard GPIOs.

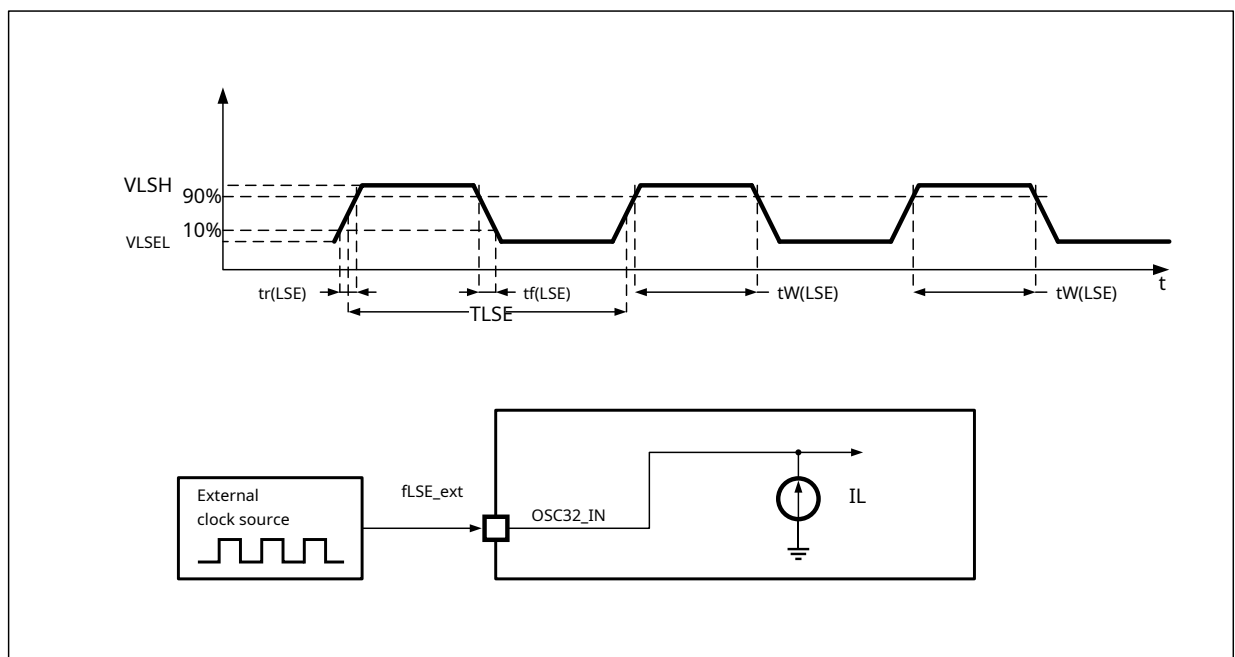
The external clock signal must take into account the first 6.3.7.3 in the chapter 10 characteristic. However, the suggested clock input waveform is shown in picture 18 middle.

surfacetwenty one.Low-Speed External User Clock Characteristics

| symbol | parameter ⁽¹⁾ | condition | minimum value | typical value | maximum value | unit | |
|--------------------------------------------|--------------------------------------|---------------------------------------------------|--------------------|---------------|--------------------|------|----|
| f _{LSE_ext} | User external clock frequency | - | - | 32.768 | 1000 | kHz | |
| V _{LSEH} | OSC32_INInput pin high level voltage | | 0.7V _{DD} | - | V _{DD} | | V |
| V _{LSEL} | OSC32_INInput pin low level voltage | | V _{SS} | - | 0.3V _{DD} | | |
| t _{w(LSE)} t _{w(LSE)} | OSC32_INhigh or low time | | 450 | - | - | ns | |
| t _{r(LSE)} t _{f(LSE)} | OSC32_INrise or fall time | | - | - | 50 | | |
| DuCy _(LSE) | duty cycle | | - | 30 | - | | 70 |
| I _L | OSC32_INinput leakage current | V _{SS} ≤V _{IN} ≤V _{DD} | - | - | ±1 | μA | |

(1) Guaranteed by design, not tested in production.

picture18.AC Timing Diagram for External Low Speed Clock Source



High-speed external clock from crystal/ceramic resonator

High speed external clock (HSE) can use 4~25MHz Oscillators constructed from crystal/ceramic resonators are produced. The information given in this section is based on comprehensive characterization results using typical external components listed in the table below. In the application, the resonator and load capacitors must be placed as close as possible to the pins of the oscillator to minimize output distortion and settling time during start-up. For detailed parameters (frequency, package, accuracy, etc.) of crystal resonators, please consult the corresponding manufacturers.

surface22. HSE 4~25 MHz Oscillator Characteristics⁽¹⁾⁽²⁾

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|-------------------------------------|----------------------|---------------------------|---------------|---------------|---------------|------|
| f _{OSC_IN} | oscillator frequency | - | 4 | 8 | 25 | MHz |
| t _{SU(HSE)} ⁽³⁾ | Start Time | V _{DD} is stable | - | 2 | - | ms |

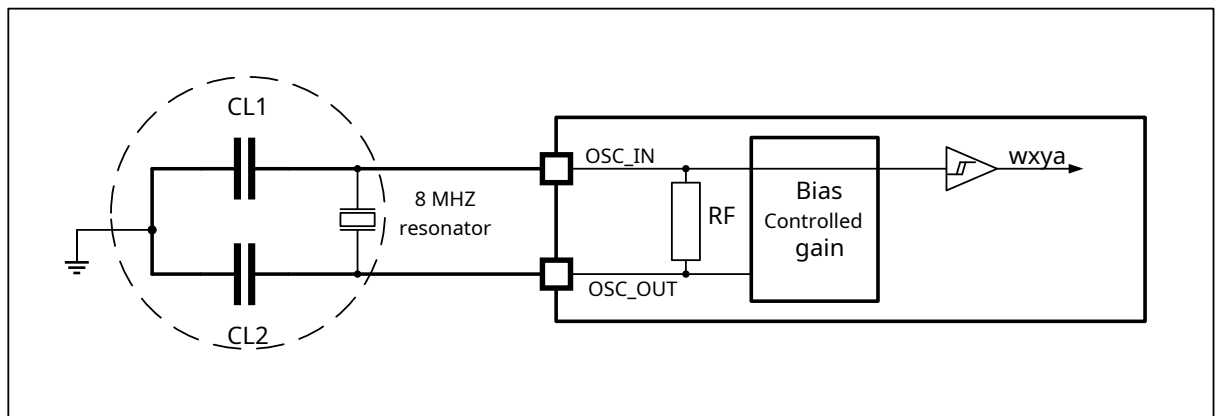
(1) The characteristic parameters of the resonator are given by the crystal/ceramic resonator manufacturer.

(2) Derived from comprehensive evaluation, not tested in production.

(3) t_{SU(HSE)} is the start-up time and is the slave software enable HSE start measuring until a stable 8 MHz Oscillate this time. This value is measured on a standard crystal resonator and may vary widely depending on the crystal manufacturer.

for C_{L1} and C_{L2}, it is recommended to use a high-quality, designed for high-frequency applications (typical value) 5pF~25pF. Between the ceramic capacitors, and select a crystal or resonator that meets the requirements. usually C_{L1} and C_{L2} have the same parameters. Crystal manufacturers usually start with C_{L1} and C_{L2}. The serial combination of gives the parameters of the load capacitance. in selection C_{L1} and C_{L2} hour, PCB and MCU The capacitive reactance of the pin should be taken into account (you can roughly compare the pin with the PCB board capacitance by 10pF estimate).

picture19. use 8MHz Typical Applications of Crystals



Low-speed external clock generated by crystal oscillator

Low Speed External Clock (LSE) can use a 32.768 kHz Oscillators composed of crystal oscillators are generated. The information given in this section is based on comprehensive characterization results using typical external components listed in the table below. In the application, the crystal and load capacitors must be placed as close as possible to the pins of the crystal to minimize output distortion and settling time at start-up. For detailed parameters of the crystal oscillator (frequency, package, precision, etc.), please consult the corresponding manufacturer.

surface23. LSE Oscillator Characteristics ($f_{LSE} = 32.768 \text{ kHz}$)⁽¹⁾⁽²⁾

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|---------------|------------|--------------------|---------------|---------------|---------------|------|
| $t_{SU}(LSE)$ | Start Time | V_{DD} is stable | - | 180 | - | ms |

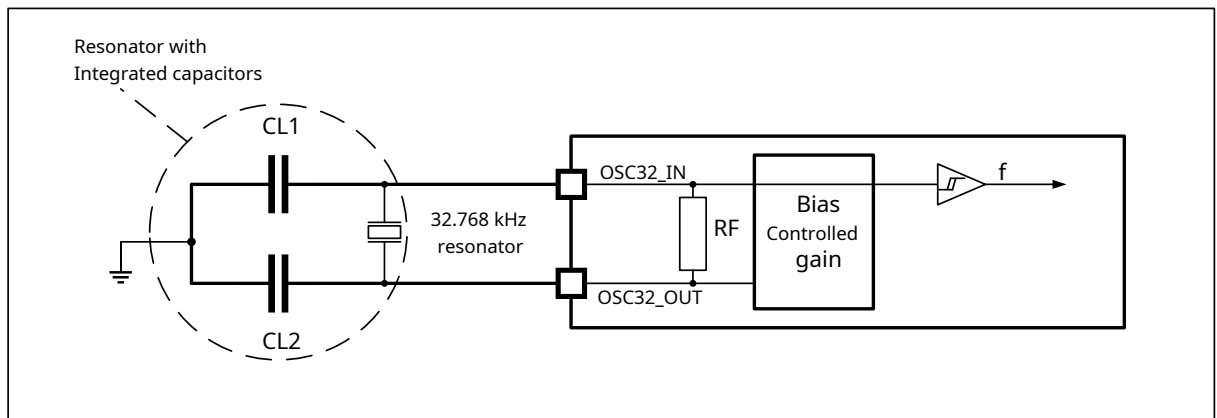
(1) The characteristic parameters of the resonator are given by the crystal manufacturer.

(2) Derived from comprehensive evaluation, not tested in production.

for C_{L1} and C_{L2} , it is recommended to use high quality 5pF~15pF. Between the ceramic capacitors, and select a crystal or resonator that meets the requirements. usually C_{L1} and C_{L2} have the same parameters. Crystal manufacturers usually start with C_{L1} and C_{L2} . The serial combination of gives the parameters of the load capacitance.

load capacitance C_L . Calculated by the following formula: $C_L = C_{L1} \times C_{L2} / (C_{L1} + C_{L2}) + C_{stray}$, in C_{stray} is the capacitance of the pin and PCB board or PCB associated capacitance, its typical value is between 2 pF to 7 pF between.

picture20. use 32.768 kHz Typical Applications of Crystals



Note: OSC32_IN and OSC32_OUT No external resistors are required between and are prohibited from being added.

6.3.7 Internal Clock Source Characteristics

The characteristic parameters given in the following table are the operating environment temperature and supply voltage conforming to [surface9](#) conditions are measured. Curves provided are based on characterization results, not production tested.

High-speed internal (HSI)RCoscillator

surface24. HSI Oscillator Characteristics⁽¹⁾

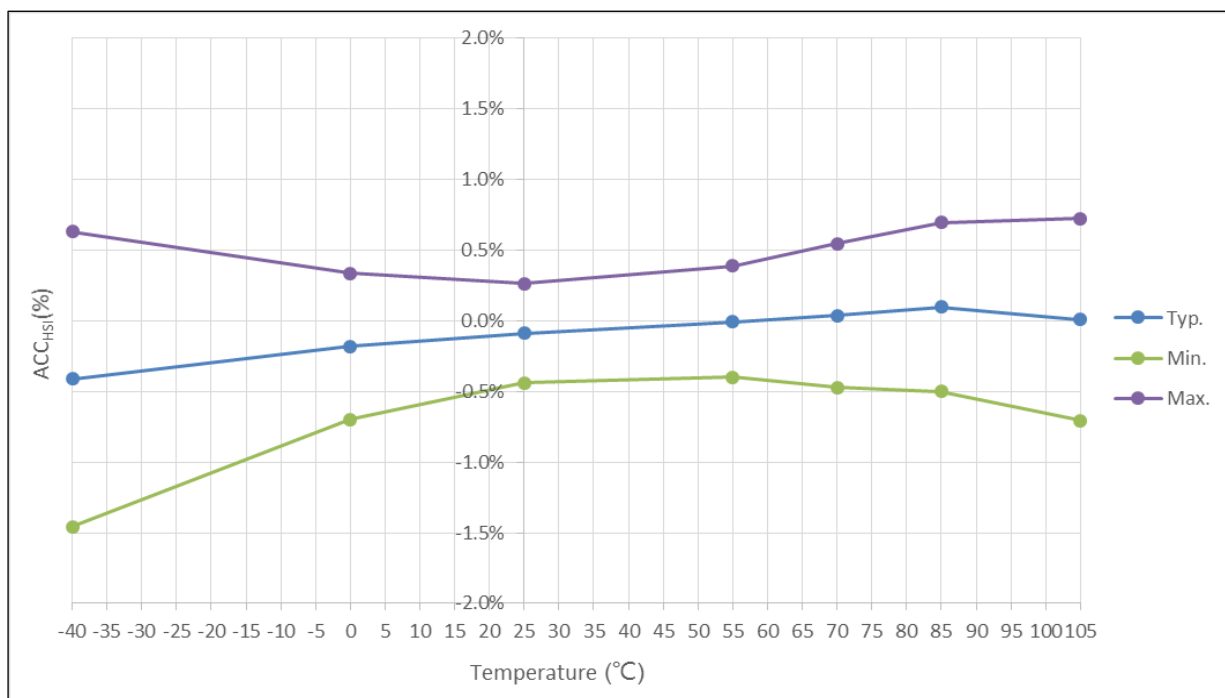
| symbol | parameter | condition | | minimum value | typical value | maximum value | unit |
|--------------------------|---------------------------------|------------------------------------|------------------------------|---------------|---------------|------------------|------|
| f _{HSI} | frequency | - | | - | 48 | - | MHz |
| DuCy(HSI) | duty cycle | - | | 45 | - | 55 | % |
| ACC _{HSI} | HSIOscillator Accuracy | registerRCC_CTRL | | - | - | 1 ⁽²⁾ | % |
| | | calibration | | | | | |
| | | factory calibration ⁽³⁾ | T _A = -40 ~ 105°C | - 2 | - | 1.5 | % |
| | | | T _A = -40 ~ 85°C | - 2 | - | 1.2 | % |
| | | | T _A = 0 ~ 70°C | - 1.5 | - | 1.2 | % |
| T _A = 25°C | - 1 | | - | 1 | % | | |
| t _{SU} (HSI)(3) | HSIOscillator start-up time | - | | - | 10 | 12 | μs |
| I _{DD} (HSI)(3) | HSIOscillator Power Consumption | - | | - | 220 | 290 | μA |

(1) V_{DD} = 3.3V, T_A = -40~105°C, unless otherwise specified.

(2) Guaranteed by design, not tested in production.

(3) Derived from comprehensive evaluation, not tested in production.

picture21. HSI Oscillator Accuracy vs. Temperature



low speed internal (LSI)RCoscillator

surface25. LSI Oscillator Characteristics⁽¹⁾

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|--------------|-----------|-----------|---------------|---------------|---------------|------|
| $f_{LSI(2)}$ | frequency | - | 25 | 35 | 45 | kHz |

(1) V_{DD} = 3.3V, T_A = -40~105°C, unless otherwise specified.

(2) Derived from comprehensive evaluation, not tested in production.

6.3.8Low Power Mode Wake Up Time

The wake-up times listed in the table below are at a system clock of HSI RCThe wake-up phase of the oscillator is measured as the delay between the wake-up event and the execution of the first user instruction. The clock source used on wake-up currently depends on the current operating mode:

- Shutdown or Standby Mode: The clock source is HSI RCOscillator sleep
- mode: clock source is the clock used when entering sleep mode

All times are using ambient temperature and supply voltage in compliance with [surface9](#) conditions are measured.

surface26.Wake-up time for low-power modes

| symbol | parameter | typical value | unit |
|---------------|-----------------------------------------------------|---------------|---------|
| $t_{WUSLEEP}$ | wake up from sleep mode | 3.3 | μs |
| t_{WUSTOP} | Wake-up from shutdown (regulator in run mode) | 380 | μs |
| | Wake up from shutdown (regulator in low power mode) | 450 | |
| $t_{WUSTDBY}$ | Wake up from standby mode | 1250 | μs |

6.3.9 PLLscharacteristic

The parameters listed in the table below are the operating environment temperature and supply voltage [surface9](#) conditions are measured.

surface27. PLLscharacteristic

| symbol | parameter | minimum value | typical value | maximum value(1) | unit |
|----------------------|-----------------------------|---------------|---------------|------------------|------|
| f _{PLL_IN} | PLLsinput clock(2) | 2 | 8 | 16 | MHz |
| | PLLsInput Clock Duty Cycle | 40 | - | 60 | % |
| f _{PLL_OUT} | PLLsMultiplied output clock | 16 | - | 120 | MHz |
| t _{LOCK} | PLLsphase lock time | - | - | 200 | μs |
| Jitter | Cycle-to-cycle jitter | - | - | 300 | ps |

(1)Derived from comprehensive evaluation, not tested in production.

(2)Care needs to be taken to use the correct multiplication factor so that according toPLLsThe input clock frequency makesf_{PLL_OUT}is within the allowable range.

6.3.10memory characteristics

Unless otherwise specified, [surface28](#) The characteristic parameters given in are based onT_A= -40to105°Cconditions are measured.

surface28.Flash memory characteristics

| symbol | parameter | condition | minimum value | typical value | maximum value(1) | unit |
|--------------------|---------------------|--------------------------------------------------------------------------------------|---------------|---------------|------------------|------|
| T _{PROG} | programming time | T _A = -40 ~ 105°C | - | 40 | 60 | μs |
| t _{ERASE} | page erase time | T _A = -40 ~ 105°C | - | 6.4 | 8 | ms |
| t _{ME} | chip erase time | T _A = -40 ~ 105°C | - | 8 | 10 | ms |
| I _{DD} | programming current | write mode, V _{DD} = 3.3V, f _{HCLK} = 8 MHz, T _A = 25°C | - | 1.95 | - | mA |
| | | erase mode, V _{DD} = 3.3V, f _{HCLK} = 8 MHz T _A =, 25°C | - | 1.62 | - | |

(1)Guaranteed by design, not tested in production.

surface29.Flash Memory Lifetime and Data Retention

| symbol | parameter | condition | minimum value(1) | typical value | maximum value | unit |
|------------------|--------------------------|------------------------------|------------------|---------------|---------------|----------------|
| N _{END} | Lifespan (erasing times) | T _A = -40 ~ 105°C | 100 | - | - | thousand times |
| t _{RET} | Data retention period | T _A = 105°C | 10 | - | - | Year |

(2)Guaranteed by design, not tested in production.

6.3.11 EMC characteristic

Sensitivity testing is performed on a sample basis during the comprehensive evaluation of the product.

Feature EMS (electromagnetic susceptibility)

- **EFT:** exist V_{DD} and V_{SS} through a 47 μ F and two 100 nF capacitors. The capacitor applies a burst of transient voltages (forward and reverse) until a functional error occurs. This test meets IEC 61000-4-4 standard.

surface30.EMS characteristic

| symbol | parameter | condition | level/type |
|-----------|----------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------|--------------|
| V_{EFT} | exist V_{DD} and V_{SS} through a 47 μ F and two 100 nF capacitors. Transient bursts imposed by the capacitance of the voltage limit | $V_{DD} = 3.3V, LQFP48, T_A = +25^{\circ}C, f_{HCLK} = 120$ MHz. conform to IEC 61000-4-4 | 3/A (2kV) |
| | | $V_{DD} = 3.3V, LQFP48, T_A = +25^{\circ}C, f_{HCLK} = 72$ MHz. conform to IEC 61000-4-4 | |

Design robust software to avoid noise issues

performed at the device level. The evaluation and optimization are carried out in a typical application environment. It should be noted that, okay EMC performance is closely related to user application and specific software.

Therefore, users are advised to implement the software EMC optimized, and performed with EMC relevant certification tests.

software advice

The software process must include the control of program run-away, such as:

- Corrupted Program Counter
- unexpected reset
- Critical data is corrupted (control registers, etc....)

Tests before certification

Many common failures (unintended resets and program counter corruption) can be detected manually in the NRST. Introduce a low level on the crystal pin or introduce a continuous 1 second low level and reproduce.

6.3.12electrical sensitivity

Based on three different tests (ESD,LU), using a specific measurement method, the chip is subjected to a stress test to determine its performance in terms of electrical susceptibility.

electrostatic discharge (ESD)

Electrostatic discharge (a positive pulse followed by a negative pulse after a second interval) was applied to all pins of all samples, and the size of the sample was related to the number of power supply pins on the chip (3piecex(n+1) supply pin). This test meetsJS-001-2017/JS-002-2014 standard.

surface31. ESDabsolute maximum

| symbol | parameter | condition | type | maximum value(1) | unit |
|------------------------|---------------------------------------------------------|----------------------------------------------|------|------------------|------|
| V _{ESD} (HBM) | Electrostatic Discharge Voltage (Human Body Model) | T _A = +25°C,conform toJS-001-2017 | 3A | 6000 | V |
| V _{ESD} (CDM) | Electrostatic discharge voltage (charging device model) | T _A = +25°C,conform toJS-002-2014 | III | 1000 | |

(1)Derived from comprehensive evaluation, not tested in production.

static latch

To evaluate latch-up performance, the6samples2A complementary static latch-up test:

- For each supply pin, provide a supply voltage exceeding the limit.
- at each input, output and configurableI/OInject current on the pin.

This test meetsEIA/JESD78EIntegrated Circuit Latch Standard.

surface32.electrical sensitivity

| symbol | parameter | condition | level/type |
|--------|--------------------|-----------------------------------------------|-----------------|
| LU | static latch class | T _A = +105°C,conform toEIA/JESD78E | IIkindA (200mA) |

6.3.13 GPIOscharacteristic

General purpose input/output characteristics

Unless otherwise specified, the parameters listed in the table below are based on [surface9](#) conditions are measured. all I/O ports are compatible CMOS and TTL.

surface33. I/O static characteristics

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|-----------|----------------------------------------------------------------------|-------------------------------------------------------|---------------------------|---------------|---------------------------|------------|
| V_{IL} | I/O Pin input low level voltage | - | - 0.3 | - | $0.28 \cdot V_{DD} + 0.1$ | V |
| V_{IH} | TC I/O Pin input high level voltage | - | $0.31 \cdot V_{DD} + 0.8$ | - | $V_{DD} + 0.3$ | V |
| | FTa I/O Pin input high level voltage | simulation mode | | - | | |
| | FT I/O Pin input high level voltage | - | | - | 5.5 | |
| | FTa I/O Pin input high level voltage | Input floating, input on pull, or input pull-down | | - | | |
| V_{hys} | TC I/O Pin Schmitt trigger voltage hysteresis ⁽¹⁾ | - | 200 | - | - | mV |
| | FT and FTa I/O Pin Schmitt trigger voltage hysteresis ⁽¹⁾ | | $5\% V_{DD}$ | - | - | - |
| I_{lk} | Input Float Mode Leakage Current ⁽²⁾ | $V_{SS} \leq V_{IN} \leq V_{DD}$ TC I/O foot | - | - | ± 1 | μA |
| | | $V_{SS} \leq V_{IN} \leq 5.5V$ FT and FTa I/O foot | - | - | ± 1 | |
| R_{PU} | Weak pull-up equivalent resistance | $V_{IN} = V_{SS}$ | 65 | 80 | 130 | k Ω |
| R_{PD} | Weak pull-down equivalent resistance ⁽³⁾ | $V_{IN} = V_{DD}$ | 65 | 70 | 130 | k Ω |
| C_{IO} | I/O Pin Capacitance | - | - | 9 | - | pF |

(1) Hysteresis voltage for Schmitt trigger switching levels. Derived from comprehensive evaluation, not tested in production.

(2) The leakage current may be higher than the maximum value if there is reverse current flowing in adjacent pins.

(3) BOOT0 The pin weak pull-down resistor cannot be disabled.

all I/O ports are CMOS and TTL compatible (no software configuration required), their characteristics take into account the most stringent CMOS or TTL parameter.

output drive current

In the user application, I/O The number of pins must ensure that the drive current cannot exceed 6.2 The absolute maximum ratings given in section:

- all I/O port from V_{DD} on the sum of the currents obtained, plus $MCU_{exist} V_{DD}$ The maximum operating current drawn on the absolute maximum rating must not be exceeded I_{VDD} (see [surface 7](#)).
- all I/O port absorbs and from the V_{SS} The sum of the currents flowing out, plus $MCU_{exist} V_{SS}$ The maximum operating current that flows out of the above, cannot exceed the absolute maximum rating I_{VSS} (see [surface 7](#)).

The output voltage

Unless otherwise specified, the parameters listed in the table below are based on ambient temperature and V_{DD} The supply voltage complies with [surface 9](#) conditions are measured. all I/O ports are compatible CMOS and TTL of.

surface 34. Output Voltage Characteristics

| symbol | parameter | condition | minimum value | maximum value | unit |
|----------------------------------------|-------------------|--------------------------------------|----------------------|---------------|------|
| Moderate current push/sink capability | | | | | |
| V _{OL} | output low level | CMOSport,I _{IO} = 4 mA 2.7 | - | 0.4 | V |
| V _{OH} | output high level | V ≤ V _{DD} ≤ 3.6V | V _{DD} -0.4 | - | |
| V _{OL} | output low level | TTLport,I _{IO} = 2 mA 2.7 | - | 0.4 | V |
| V _{OH} | output high level | V ≤ V _{DD} ≤ 3.6V | 2.4 | - | |
| V _{OL} | output low level | I _{IO} = 9 mA | - | 1.3 | V |
| V _{OH} | output high level | 2.7 V ≤ V _{DD} ≤ 3.6V | V _{DD} -1.3 | - | |
| V _{OL} | output low level | I _{IO} = 4 mA | - | 0.4 | V |
| V _{OH} | output high level | 2.4 V ≤ V _{DD} < 2.7V | V _{DD} -0.4 | - | |
| High current push/sink capability | | | | | |
| V _{OL} | output low level | CMOSport,I _{IO} = 6 mA 2.7 | - | 0.4 | V |
| V _{OH} | output high level | V ≤ V _{DD} ≤ 3.6V | V _{DD} -0.4 | - | |
| V _{OL} | output low level | TTLport,I _{IO} = 5 mA 2.7 | - | 0.4 | V |
| V _{OH} | output high level | V ≤ V _{DD} ≤ 3.6V | 2.4 | - | |
| V _{OL} | output low level | I _{IO} = 18mA | - | 1.3 | V |
| V _{OH} | output high level | 2.7 V ≤ V _{DD} ≤ 3.6V | V _{DD} -1.3 | - | |
| V _{OL} | output low level | I _{IO} = 8mA | - | 0.4 | V |
| V _{OH} | output high level | 2.4 V ≤ V _{DD} < 2.7V | V _{DD} -0.4 | - | |
| Very high current push/sink capability | | | | | |
| V _{OL} | output low level | CMOSport,I _{IO} = 15 mA 2.7 | - | 0.4 | V |
| V _{OH} | output high level | V ≤ V _{DD} ≤ 3.6V | V _{DD} -0.4 | - | |
| V _{OL} | output low level | TTLport,I _{IO} = 12 mA 2.7 | - | 0.4 | V |
| V _{OH} | output high level | V ≤ V _{DD} ≤ 3.6V | 2.4 | - | |
| V _{OL} | output low level | I _{IO} = 36mA | - | 1.3 | V |
| V _{OH} | output high level | 2.7 V ≤ V _{DD} ≤ 3.6V | V _{DD} -1.3 | - | |
| V _{OL} | output low level | I _{IO} = 18mA | - | 0.4 | V |
| V _{OH} | output high level | 2.4 V ≤ V _{DD} < 2.7V | V _{DD} -0.4 | - | |

(1) Derived from comprehensive evaluation, not tested in production.

Input AC Characteristics

The definition and values of the input AC characteristics are given in the table below.

Unless otherwise specified, the parameters listed in the table below are based on the ambient temperature and power supply voltage [surface9](#) conditions are measured.

surface35.Input AC Characteristics

| symbol | parameter | minimum value | maximum value | unit |
|--------------|-------------------------------------------------------------------|---------------|---------------|------|
| t_{EXTIpw} | EXTIThe controller detects the pulse width of the external signal | 10 | - | ns |

6.3.14 NRSTsPin Characteristics

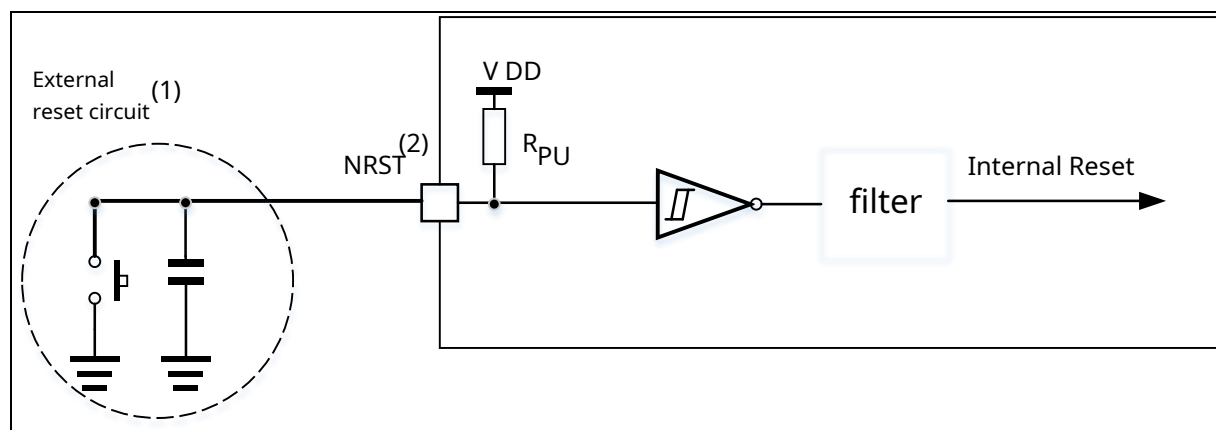
NRSTpin input driver usingCMOSprocess, which connects a pull-up resistor that cannot be disconnected, R_{PU} (see table below). Unless otherwise specified, the parameters listed in the table below are based on the ambient temperature and power supply voltage [surface9](#) conditions are measured.

surface36. NRSTPin Characteristics

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|----------------------|----------------------------------------|-------------------|---------------|---------------|----------------|------------|
| $V_{IL(NRST)}^{(1)}$ | NRSTInput low level voltage | - | - 0.3 | - | 0.72 | V |
| $V_{IH(NRST)}^{(1)}$ | NRSTInput high level voltage | - | 2 | - | $V_{DD} + 0.3$ | |
| $V_{hys(NRST)}$ | NRSTSchmitt Trigger Voltage Hysteresis | - | - | 400 | - | mV |
| R_{PU} | Weak pull-up equivalent resistance | $V_{IN} = V_{SS}$ | 30 | 40 | 50 | k Ω |
| $V_{F(NRST)}^{(1)}$ | NRSTinput filter pulse | - | - | 29 | 40 | μs |
| $V_{NF(NRST)}^{(1)}$ | NRSTInput unfiltered pulse | - | 80 | 52 | - | μs |

(1)Guaranteed by design, not tested in production.

picturetwenty two.suggestedNRSTpin protection



(1)The reset network is to prevent parasitic resets.

(2)The user must guaranteeNRSTThe potential of the pin can be lower than [surface36](#) the largest listed in $V_{IL(NRST)}$ below, otherwiseMCUCan't get reset.

6.3.15 TMRsTimer Features

The parameters listed in the table below are guaranteed by design.

For input and output alternate function pins (output compare, input capture, external clock,PWMoutput), see [6.3.13 GPIOs characteristic](#).

surface37. TMRx(1)characteristic

| symbol | parameter | condition | minimum value | maximum value | unit |
|----------------|-----------------------------------------------|---------------------------------|---------------|-----------------|---------------|
| $t_{res(TMR)}$ | timer resolution time | - | 1 | - | $t_{TMRxCLK}$ |
| | | $f_{TMRxCLK} = 120 \text{ MHz}$ | 8.3 | - | ns |
| f_{EXT} | CH1toCH4external clock frequency of the timer | - | 0 | $f_{TMRxCLK}/2$ | MHz |
| | | $f_{TMRxCLK} = 120 \text{ MHz}$ | 0 | 60 | |

(1) TMRxis a generic name that stands forTMR1,TMR3,TMR6,andTMR14~17.

6.3.16 Communication Interface

I²C Interface Features

SDA and SCL I/O satisfaction of requirements is subject to the following restrictions: SDA and SCL are not a "true" open-drain pin, when configured as an open-drain output, the pin and V_{DD} between PMOS and the tube is closed, but is still there. For input and output alternate function pins (SDA and SCL) for details of the characteristics, see [6.3.13 GPIO characteristic](#).

I²C The bus interface supports standard mode (up to 100 kbit/s) and fast mode (maximum 400 kbit/s). I²C The bus frequency can be increased up to 1 MHz. For a more complete and detailed solution, you can contact the nearest YateLi sales office for technical support.

SPI-I²S Interface Features

Unless otherwise specified, [surface 38](#) listed SPI parameters and [surface 39](#) listed I²S parameter is the ambient temperature used, f_{CLK} frequency and V_{DD} The supply voltage complies with [surface 9](#) conditions are measured.

For input and output alternate function pins (SPI of NSS, SCK, MOSI, MISO, I²S of FWS, CK, SD) for details of the characteristics, see [6.3.13 GPIO characteristic](#).

surface 38. SPI characteristic

| symbol | parameter | condition | minimum value | maximum value | unit |
|------------------------------------------------------|-------------------------------|------------------------------------------------------------------|-------------------------------------------------|--------------------------|------|
| f _{SCK} (1/t _{c(SCK)})(1) | SPI Clock frequency(2) | main mode | V _{DD} = 3.3 V, T _A = 25°C | - | 50 |
| | | | V _{DD} = 3.3 V, T _A = 105°C | - | 40 |
| | | | V _{DD} = 2.4 V, T _A = 105°C | - | 36 |
| | | slave mode | - | f _{PCLK} /2 | MHz |
| t _{r(SCK)} t _{f(SCK)} | SPI Clock Rise and Fall Times | Load Capacitance: C = 15pF | - | 6 | ns |
| t _{su(NSS)} (1) | NSS build time | slave mode | 4t _{PCLK} | - | ns |
| t _{h(NSS)} (1) | NSS hold time | slave mode | 2t _{PCLK} + 10 | - | ns |
| t _{w(SCKH)} (1) t _{w(SCKL)} (1) | SCK high and low times | master mode, f _{PCLK} = 120 MHz, prescaler factor =4 | t _{PCLK} /twenty two | t _{PCLK} /2 + 1 | ns |
| t _{su(MI)} (1) | Data input setup time | main mode | 4 | - | ns |
| t _{su(SI)} (1) | | slave mode | 5 | - | |
| t _{h(MI)} (1) | Data input hold time | main mode | 4 | - | ns |
| t _{h(SI)} (1) | | slave mode | 5 | - | |
| t _{a(SO)} (1)(3) | Data Out Access Time | from the schema, f _{PCLK} = 20 MHz | 0 | 3t _{PCLK} | ns |
| t _{dis(SO)} (1)(4) | Data output inhibit time | slave mode | 0 | 18 | ns |
| t _{v(SO)} (1) | Data output effective time | Slave mode (after enable edge) | - | 22.5 | ns |
| t _{v(MO)} (1) | Data output effective time | Master mode (after enable edge) | - | 6 | ns |
| t _{h(SO)} (1) | Data output hold time | Slave mode (after enable edge) | 11.5 | - | ns |
| t _{h(MO)} (1) | | Master mode (after enable edge) | 2 | - | |

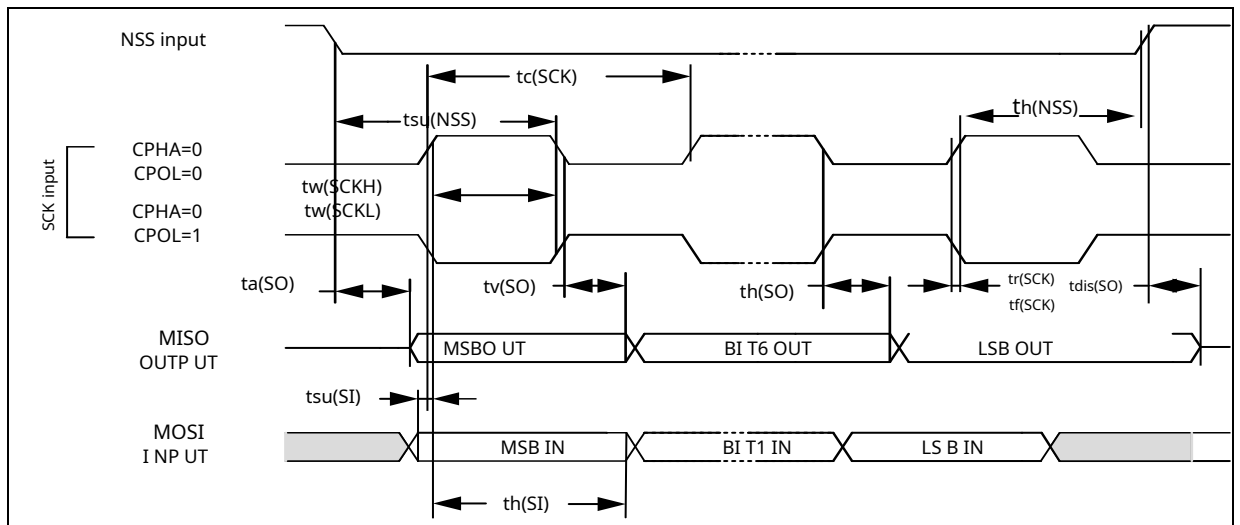
(1) Derived from comprehensive evaluation, not tested in production.

(2) The maximum clock frequency varies with the device and PCB layout is highly dependent. For a more complete and detailed solution, you can contact the nearest YateLi sales office for technical support.

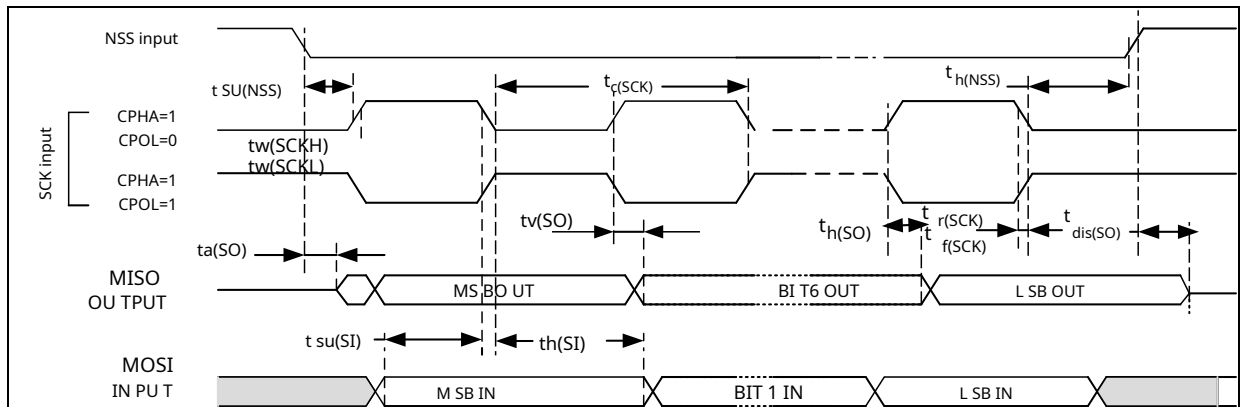
(3) The minimum value indicates the minimum time to drive the output, and the maximum value indicates the maximum time to get the data correctly.

(4) The minimum value indicates the minimum time to turn off the output, and the maximum value indicates the maximum time to put the data line in a high-impedance state.

picture23. SPITiming Diagram - Slave Mode andCPHA = 0

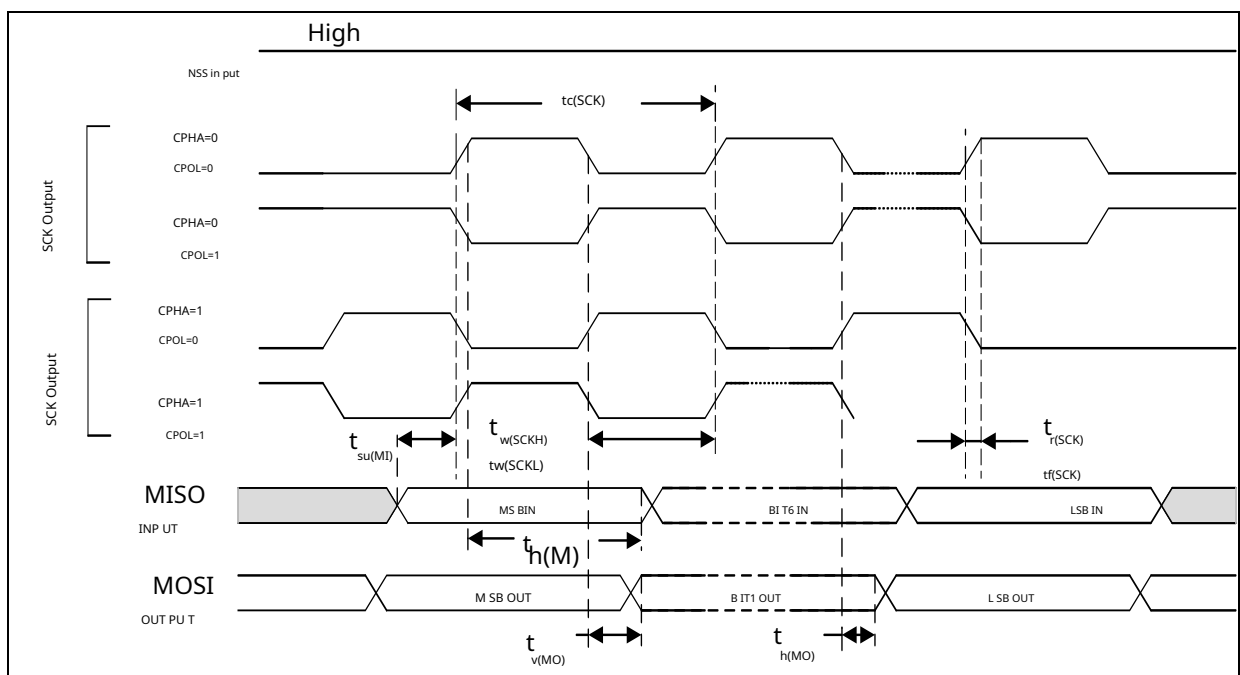


picture24. SPITiming Diagram - Slave Mode andCPHA = 1⁽¹⁾



(1)The measurement point is set atCMOSLevel:0.3V_{DD}and0.7V_{DD}.

picture25. SPITiming Diagram - Master Mode⁽¹⁾



(1)The measurement point is set atCMOSLevel:0.3V_{DD}and0.7V_{DD}.

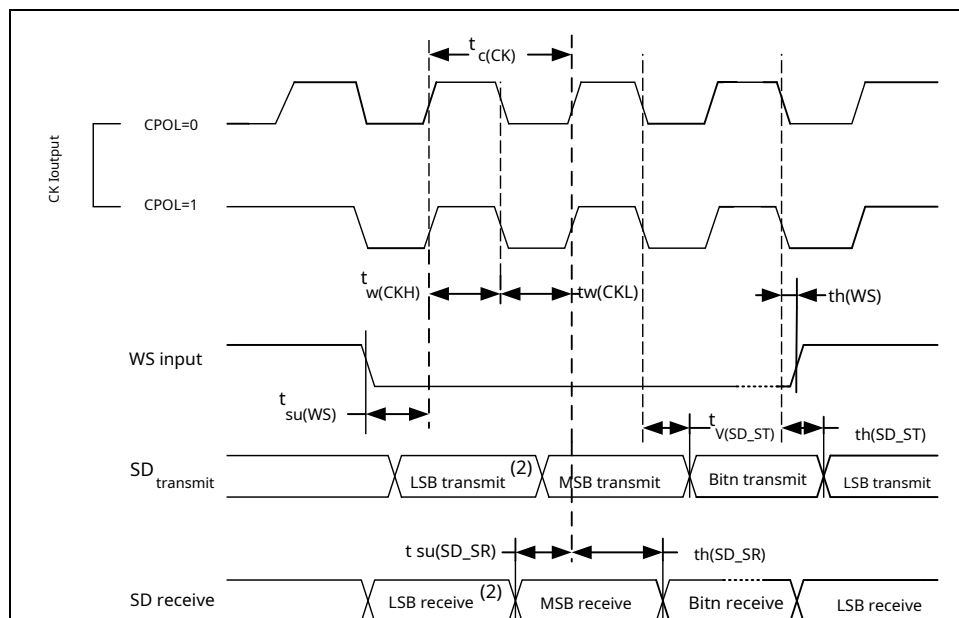
surface39.I2Scharacteristic

| symbol | parameter | condition | minimum value | maximum value | unit |
|---------------------------|------------------------------|------------------------------------------------|---------------|---------------|------|
| f_{CK} $1/t_{c(CK)}$ | I2SClock frequency | Master Mode (Source:16bits, audio:48 kHz) | 1.522 | 1.525 | MHz |
| | | slave mode | 0 | 6.5 | |
| $t_r(CK)$ $t_f(CK)$ | I2SClock Rise and Fall Times | Load Capacitance:C = 15pF | - | 12 | ns |
| $t_{v(WS)}^{(1)}$ | | | | | |
| $t_{h(WS)}^{(1)}$ | WShold time | main mode | 2 | - | |
| $t_{su(WS)}^{(1)}$ | WSbuild time | slave mode | 7 | - | |
| $t_{h(WS)}^{(1)}$ | WShold time | slave mode | 0 | - | |
| $t_{w(CKH)}^{(1)}$ | CKhigh and low times | master mode, f_{PCLK} = 16 MHz, audio:48 kHz | 306 | - | |
| $t_{w(CKL)}^{(1)}$ | | | 312 | - | |
| $t_{su(SD_MR)}^{(1)}$ | Data input setup time | master receiver | 6 | - | |
| $t_{su(SD_SR)}^{(1)}$ | | from the receiver | 2 | - | |
| $t_{h(SD_MR)}^{(1)(2)}$ | Data input hold time | master receiver | 4 | - | |
| $t_{h(SD_SR)}^{(1)(2)}$ | | from the receiver | 0.5 | - | |
| $t_{v(SD_ST)}^{(1)(2)}$ | Data output effective time | Slave transmitter (after enable edge) | - | 20 | |
| $t_{h(SD_ST)}^{(1)}$ | Data output hold time | Slave transmitter (after enable edge) | 13 | - | |
| $t_{v(SD_MT)}^{(1)(2)}$ | Data output effective time | Master Transmitter (after enable edge) | - | 4 | |
| $t_{h(SD_MT)}^{(1)}$ | Data output hold time | Master Transmitter (after enable edge) | 0 | - | |

(1)Derived from design simulation and/or synthesis evaluation, not tested in production.

(2)depends on f_{PCLK} . For example, if f_{PCLK} = 8 MHz, but t_{PCLK} = $1/f_{PCLK}$ = 125ns.

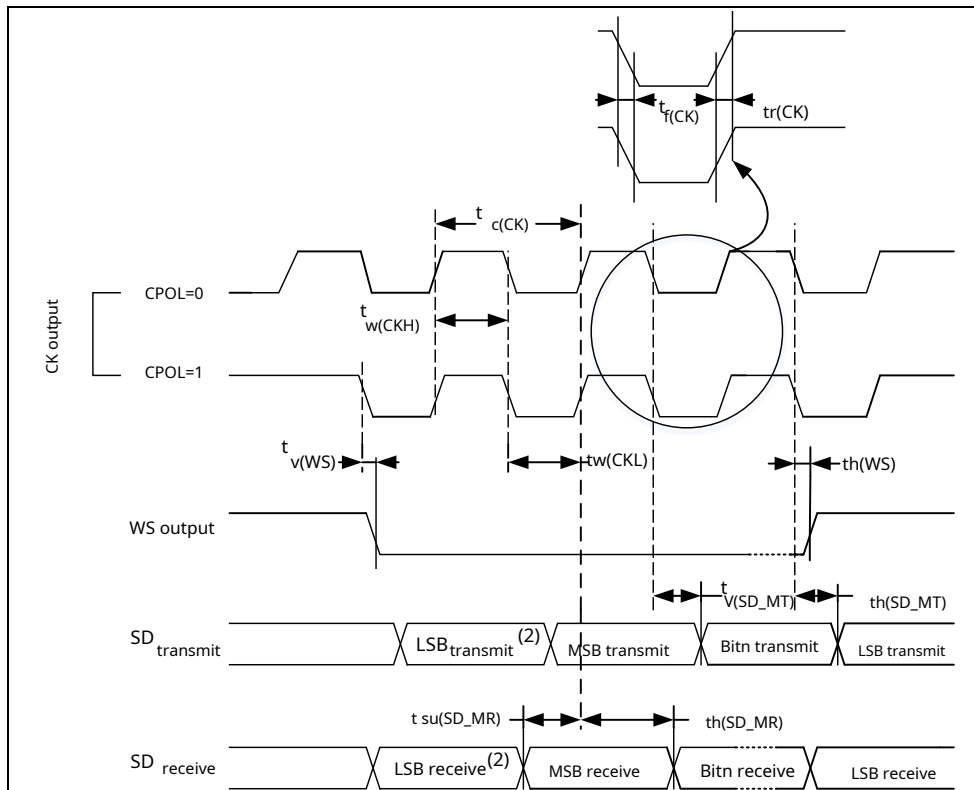
picture26.I2SSlave Mode Timing Diagram (Philipsprotocol)⁽¹⁾



(1)The measurement point is set at CMOSLevel:0.3V_{DD}and0.7V_{DD}.

(2)The lowest bit of the previous byte is sent/received. There is no sending/receiving of this lowest bit before the first byte.

picture27.I2SMaster Mode Timing Diagram (Philipsprotocol)(1)



(1)The measurement point is set atCMOSLevel:0.3V_{DD}and0.7V_{DD}.

(2)The lowest bit of the previous byte is sent/received. There is no sending/receiving of this lowest bit before the first byte.

6.3.17 12bitADCcharacteristic

Unless otherwise specified, the parameters in the table below are used in accordance with [surface9](#) conditions of ambient temperature, f_{CLK2} frequency and V_{DDA} . The supply voltage is measured.

Note:

It is recommended to perform a calibration every time the power is turned on.

surface40. ADCscharacteristic

| symbol | parameter | condition | minimum value | typical value | maximum value | unit |
|-------------------------|-----------------------------------------------------|-----------------------------------|-------------------------------------------------------------|--------------------|-------------------|--------------------|
| V_{DDA} | supply voltage | - | 2.4 | - | 3.6 | V |
| I_{DDA} | exist V_{DDA} The current on the input pin | - | - | 480 ⁽¹⁾ | 560 | μA |
| f_{ADC} | ADCClock frequency | - | 0.6 | - | 28 | MHz |
| $f_s^{(2)}$ | sampling rate | - | 0.05 | - | 2 | MHz |
| $f_{\text{TRIG}}^{(2)}$ | External trigger frequency | $f_{\text{ADC}} = 28 \text{ MHz}$ | - | - | 1.65 | MHz |
| | | - | - | - | 17 | $1/f_{\text{ADC}}$ |
| V_{AIN} | Conversion voltage range ⁽³⁾ | - | 0(V_{REF} -internally connected to ground) | - | $V_{\text{REF+}}$ | V |
| $R_{\text{AIN}}^{(2)}$ | External input impedance | - | see surface41 and surface42 | | | Ω |
| $C_{\text{ADC}}^{(2)}$ | Internal sample and hold capacitor | - | - | 8.5 | 13 | pF |
| $t_{\text{CAL}}^{(2)}$ | calibration time | $f_{\text{ADC}} = 28 \text{ MHz}$ | 6.61 | | | μs |
| | | - | 185 | | | $1/f_{\text{ADC}}$ |
| $t_{\text{IA}}^{(2)}$ | Injection Triggered Conversion Latency | $f_{\text{ADC}} = 28 \text{ MHz}$ | - | - | 107 | ns |
| | | - | - | - | 3 ⁽⁴⁾ | $1/f_{\text{ADC}}$ |
| $t_{\text{NTR}}^{(2)}$ | Normal Trigger Conversion Latency | $f_{\text{ADC}} = 28 \text{ MHz}$ | - | - | 71.4 | μs |
| | | - | - | - | 2 ⁽⁴⁾ | $1/f_{\text{ADC}}$ |
| $t_s^{(2)}$ | sampling time | $f_{\text{ADC}} = 28 \text{ MHz}$ | 0.053 | - | 8.55 | μs |
| | | - | 1.5 | - | 239.5 | $1/f_{\text{ADC}}$ |
| $t_{\text{STAB}}^{(2)}$ | power on time | - | 42 | | | $1/f_{\text{ADC}}$ |
| $t_{\text{CONV}}^{(2)}$ | Total conversion time (including sampling time) | $f_{\text{ADC}} = 28 \text{ MHz}$ | 0.5 | - | 9 | μs |
| | | - | 14~252(sampling t_s +step by step 12.5) | | | $1/f_{\text{ADC}}$ |

(1)Guaranteed by comprehensive evaluation, not tested in production.

(2)Guaranteed by design, not tested in production.

(3) $V_{\text{REF+}}$ internally connected to V_{DDA} , $V_{\text{REF-}}$ internally connected to V_{SSA} .

(4)For an external trigger, the [surface40](#) Add a delay to the listed delay $1/f_{\text{CLK2}}$.

surface41 and surface42 Determine the maximum external impedance such that the error can be less than 1 LSB.

surface41. $f_{ADC} = 14 \text{ MHz}$ when the maximum R_{AIN} ⁽¹⁾

| $T_s(\text{cycle})$ | $t_s(\mu\text{s})$ | maximum $R_{AIN}(\text{k}\Omega)$ |
|---------------------|--------------------|-----------------------------------|
| 1.5 | 0.11 | 0.35 |
| 7.5 | 0.54 | 3.9 |
| 13.5 | 0.96 | 7.4 |
| 28.5 | 2.04 | 16.3 |
| 41.5 | 2.96 | 24.0 |
| 55.5 | 3.96 | 32.3 |
| 71.5 | 5.11 | 41.8 |
| 239.5 | 17.11 | 50.0 |

(1) Guaranteed by design.

surface42. $f_{ADC} = 28 \text{ MHz}$ when the maximum R_{AIN} ⁽¹⁾

| $T_s(\text{cycle})$ | $t_s(\mu\text{s})$ | maximum $R_{AIN}(\text{k}\Omega)$ |
|---------------------|--------------------|-----------------------------------|
| 1.5 | 0.05 | 0.1 |
| 7.5 | 0.27 | 1.6 |
| 13.5 | 0.48 | 3.4 |
| 28.5 | 1.02 | 7.9 |
| 41.5 | 1.48 | 11.7 |
| 55.5 | 1.98 | 15.9 |
| 71.5 | 2.55 | 20.6 |
| 239.5 | 8.55 | 50.0 |

(1) Guaranteed by design.

surface43. ADCsprecision(1)(2)

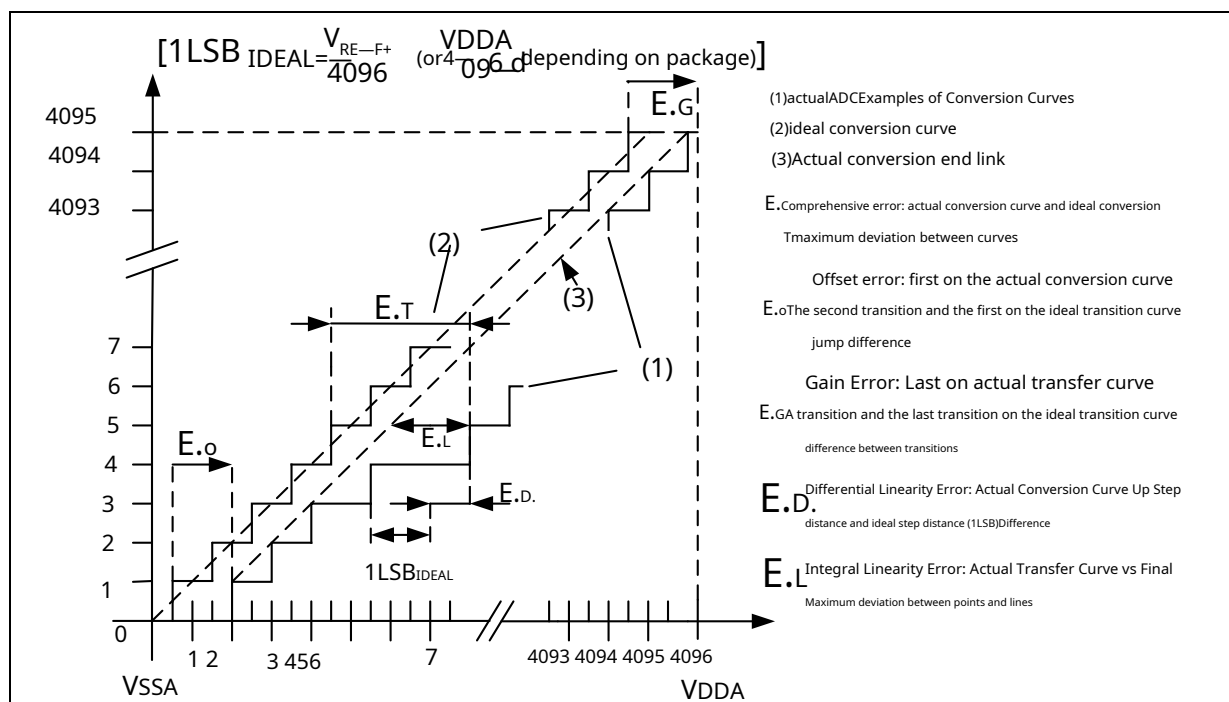
| symbol | parameter | Test Conditions | typical value | maximum value(3) | unit |
|--------|------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------|---------------|------------------|------|
| ET | Comprehensive error | $f_{CLK2}=56\text{ MHz}$, $f_{ADC}=28\text{ MHz}$, $R_{AIN}<10\text{ k}\Omega$, $V_{DDA}=3.0\sim3.6\text{ V}$, $T_A=25^\circ\text{C}$ | +2 | +3.5 | LSB |
| EO | offset error | | +1 | +2.5 | |
| EG | gain error | | +1.5 | +3 | |
| ED | Differential Linearity Error | | ± 0.7 | ± 1 | |
| EL | Integral Linearity Error | | ± 0.8 | ± 1.5 | |
| ET | Comprehensive error | $f_{CLK2}=56\text{ MHz}$, $f_{ADC}=28\text{ MHz}$, $R_{AIN}<10\text{ k}\Omega$, $V_{DDA}=2.4\sim3.6\text{ V}$ | ± 2 | +4 | LSB |
| EO | offset error | | +1 | +3 | |
| EG | gain error | | +1.5 | +3.5 | |
| ED | Differential Linearity Error | | ± 0.6 | +1.5/-1 | |
| EL | Integral Linearity Error | | ± 1 | ± 2.5 | |

(1) ADC The DC accuracy values are measured after internal calibration.

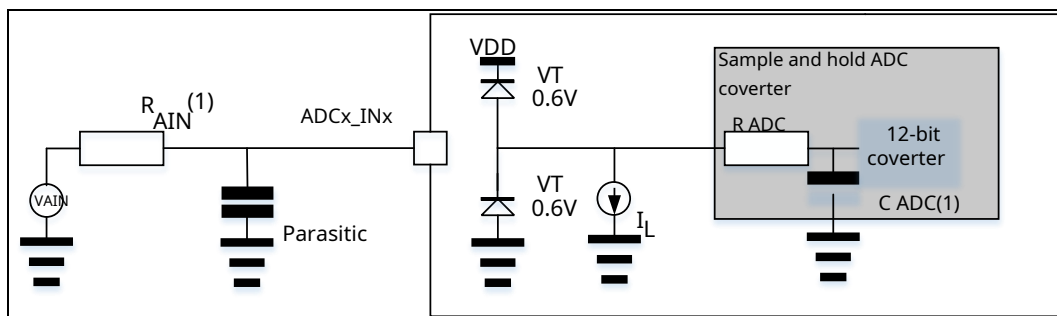
(2) ADCs Accuracy vs. Reverse Injection Current: Injecting reverse current on any standard analog input pin needs to be avoided as this can significantly degrade the accuracy of the conversion being performed on another analog input pin. It is recommended to add a Schottky diode (between pin and ground) on standard analog pins that may cause reverse injection current.

(3) Guaranteed by comprehensive evaluation, not tested in production.

picture28. ADCsAccuracy characteristics



picture29.useADCTypical Connection Diagram



(1) related R_{AIN} and C_{ADC} value, see [surface40](#).

(2) $C_{parasitic}$ express PCB (with soldering and PCB layout quality) versus the parasitic capacitance on the pad (approximately 7 pF). larger $C_{parasitic}$ The numerical value will reduce the precision of the conversion, the solution is to reduce the f_{ADC} .

PCB design advice

Should be as [picture1](#) Perform power supply decoupling as shown in .100nF The capacitors should be ceramic type (high quality), should be placed as close as possible to the chip.

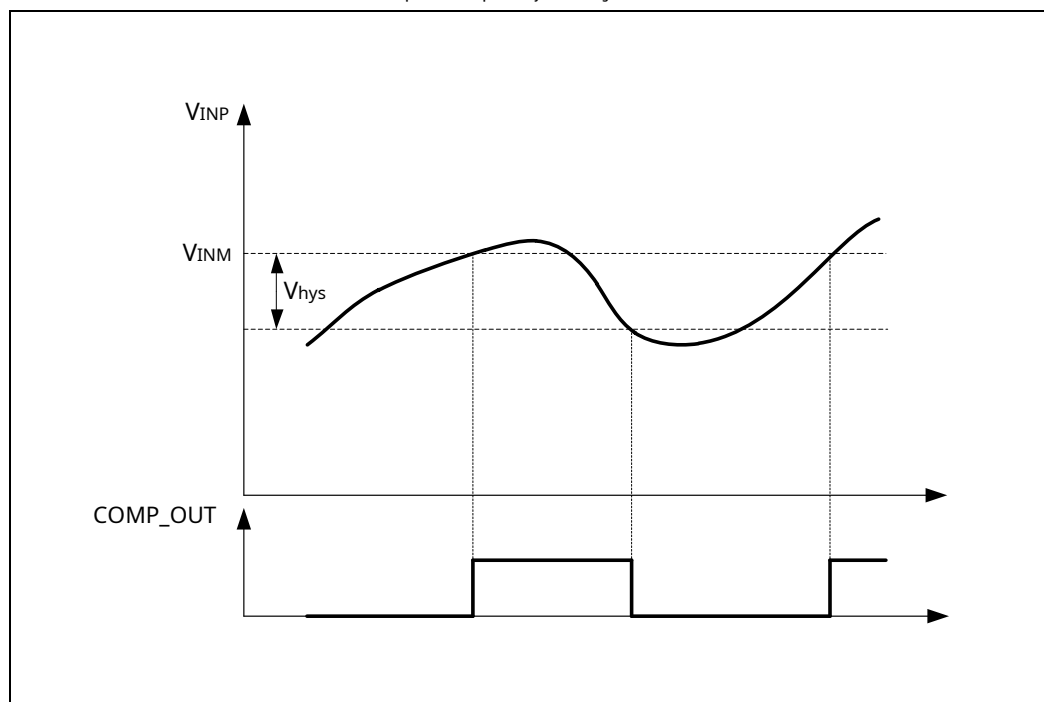
6.3.18 Comparator Characteristics

surface44.Comparator Characteristics

| symbol | parameter | condition | minimum value ⁽¹⁾ | typical value | maximum value ⁽¹⁾ | unit |
|--------------|----------------------------------------------------|----------------------|------------------------------|---------------|------------------------------|---------|
| V_{DDA} | supply voltage | - | 2.4 | - | 3.6 | V |
| V_{IN} | Input voltage range | - | 0 | - | V_{DDA} | V |
| t_{START} | Start Time | high speed mode | - | 1.0 | 3.5 | μs |
| | | medium speed mode | - | 2.8 | 5 | |
| | | low power mode | - | 8 | 13 | |
| | | Ultra Low Power Mode | - | 12 | 18 | |
| t_D | 200mVstepper,100mV overloaded propagation delay | high speed mode | - | 40 | 100 | ns |
| | | medium speed mode | - | 240 | 320 | |
| | | low power mode | - | 500 | 820 | |
| | | Ultra Low Power Mode | - | 800 | 1800 | |
| V_{offset} | shift error voltage | - | - | ± 4 | ± 15 | mV |
| V_{hys} | hysteresis voltage | no hysteresis | - | 0 | 1 | mV |
| | | low hysteresis | 5 | 8 | 17 | |
| | | medium hysteresis | 10 | 18 | 37 | |
| | | high hysteresis | 18 | 38 | 70 | |
| I_{DDA} | exist V_{DDA} The current on the input pin | high speed mode | - | 40 | 61 | μA |
| | | medium speed mode | - | 9.7 | 13.9 | |
| | | low power mode | - | 3.2 | 4.7 | |
| | | Ultra Low Power Mode | - | 1.9 | 2.8 | |

(1)Guaranteed by comprehensive evaluation, not tested in production.

picture30.Comparator Hysteresis Diagram



6.3.19 Temperature Sensor Characteristics

surface45.Temperature Sensor Characteristics

| symbol | parameter | minimum value | typical value | maximum value | unit |
|-------------------------------|---------------------------------------------------|---------------|---------------|---------------|------------------------|
| $T_{(1)}$ | V_{SENSE} Linearity with respect to temperature | - | ± 1 | ± 2 | $^{\circ}\text{C}$ |
| $\text{Avg_Slope}_{(1)(2)}$ | mean slope | - 4.17 | - 4.30 | - 4.44 | mV/ $^{\circ}\text{C}$ |
| $V_{(2)}$ | exist 25 $^{\circ}\text{C}$ voltage at | 1.22 | 1.28 | 1.34 | V |
| $t_{\text{START}}^{(3)}$ | build time | - | - | 100 | μs |
| $T_{\text{S_temp}}^{(3)(4)}$ | When reading the temperature, ADC sampling time | - | 8.6 | 17.1 | μs |

(1) Guaranteed by comprehensive evaluation, not tested in production.

(2) The output voltage of the temperature sensor changes linearly with the temperature. Due to the change of the production process, the offset of the temperature change curve will be different on different chips (the difference is at most 50 $^{\circ}\text{C}$). Internal temperature sensors are better suited for detecting changes in temperature rather than measuring absolute temperature. If accurate temperature measurement is required, an external temperature sensor should be used.

(3) Guaranteed by design, not tested in production.

(4) Short sample times can be determined by the application through multiple loops.

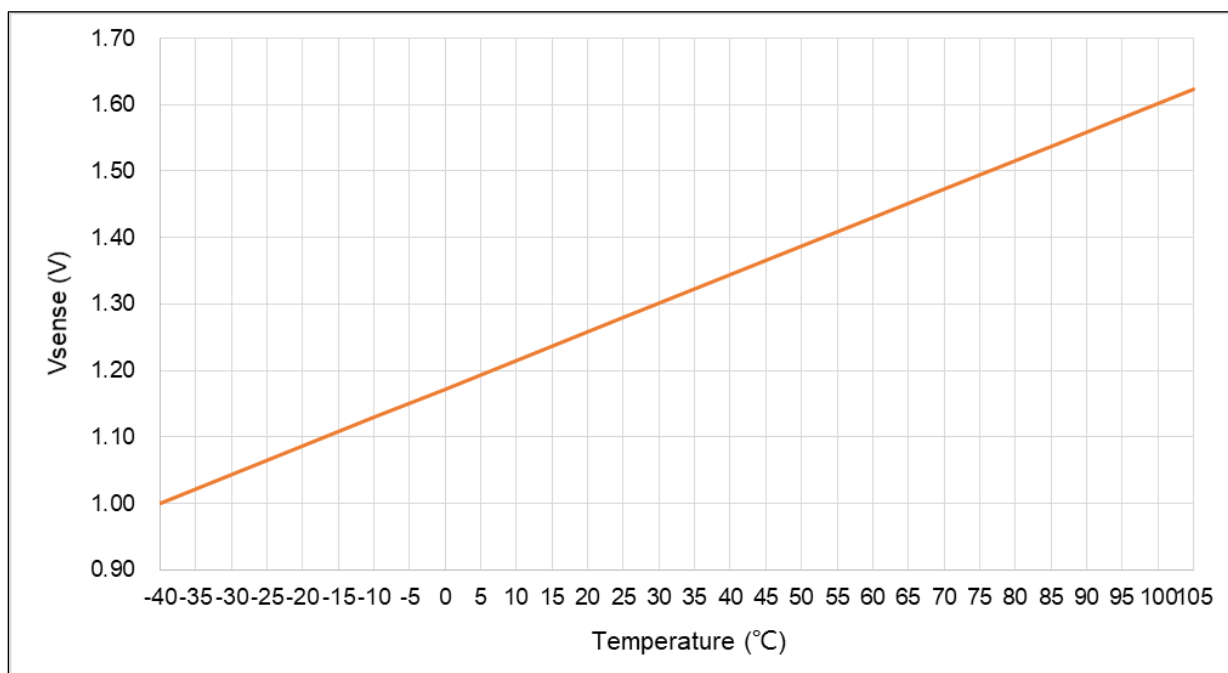
Use the following formula to find the temperature:

$$\text{temperature}(^{\circ}\text{C}) = \{(V_{25} - V_{\text{SENSE}}) / \text{Avg_Slope}\} + 25$$

here:

$V_{25} = V_{\text{SENSE}}$ exist 25 $^{\circ}\text{C}$ when the value

Avg_Slope = temperature and V_{SENSE} The average slope of the curve (in units of mV/ $^{\circ}\text{C}$)

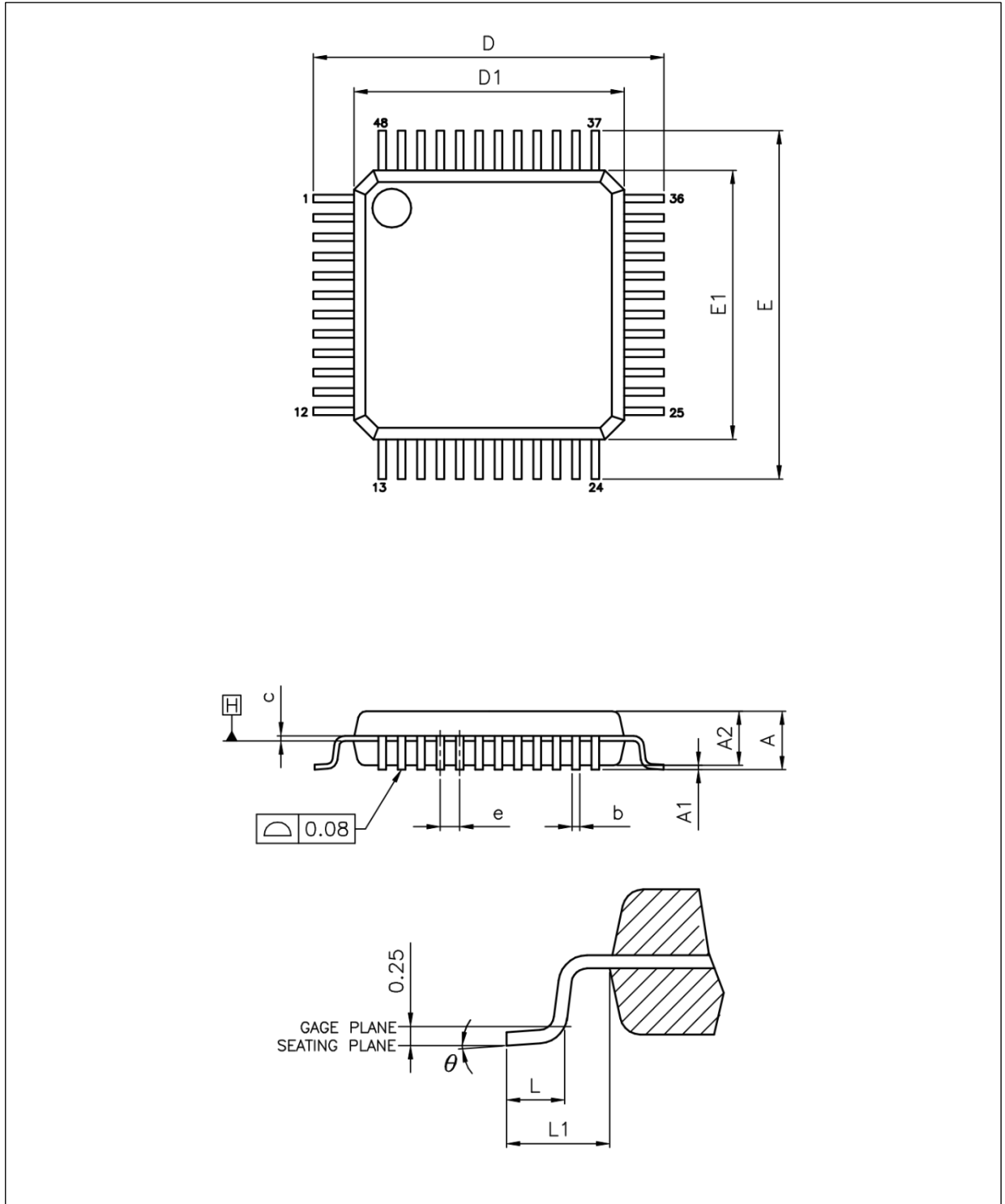
picture31. V_{SENSE} Ideal curve for temperature

7

Package Features

7.1 LQFP48 – 7 x 7 mm encapsulated data

picture32. LQFP48 – 7 x 7 mm 48Lead Thin Quad Flat Package Diagram



(1) Figures are not drawn to scale.

surface46. LQFP48 – 7 x 7 mm 48Leaded Thin Quad Flat Pack Mechanical Data

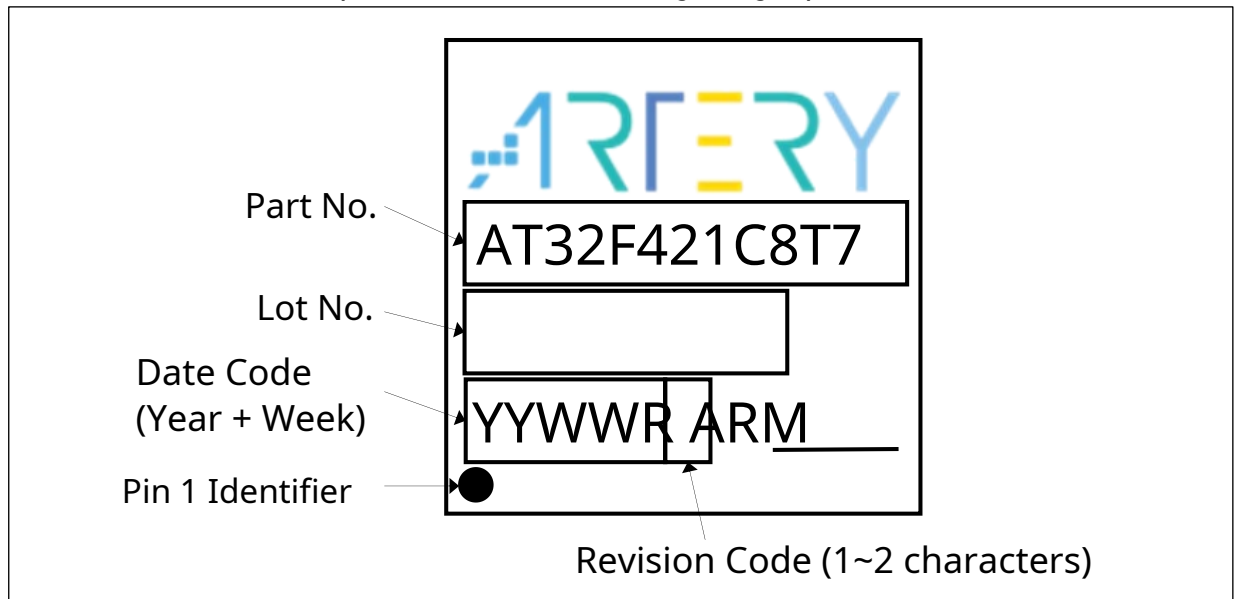
| label | mm | | | inch ⁽¹⁾ | | |
|-------|---------------|---------------|---------------|---------------------|---------------|---------------|
| | minimum value | typical value | maximum value | minimum value | typical value | maximum value |
| A | - | - | 1.60 | - | - | 0.063 |
| A1 | 0.05 | - | 0.15 | 0.002 | - | 0.006 |
| A2 | 1.35 | 1.40 | 1.45 | 0.053 | 0.055 | 0.057 |
| b | 0.17 | 0.22 | 0.27 | 0.007 | 0.009 | 0.011 |
| c | 0.09 | - | 0.20 | 0.004 | - | 0.008 |
| D. | 9.00 BSC. | | | 0.345 BSC. | | |
| D1 | 7.00 BSC. | | | 0.276 BSC. | | |
| E. | 9.00 BSC. | | | 0.345 BSC. | | |
| E1 | 7.00 BSC. | | | 0.276 BSC. | | |
| e | 0.50 BSC. | | | 0.020 BSC. | | |
| Θ | 0° | 3.5° | 7° | 0° | 3.5° | 7° |
| L | 0.45 | 0.60 | 0.75 | 0.018 | 0.024 | 0.030 |
| L1 | 1.00 REF. | | | 0.039 REF. | | |

(1) Inch values are based on mm data according to 3It is obtained by rounding to decimal precision conversion.

LQFP48 – 7 x 7 mm equipment marking The image below is a top marking orientation with pin1

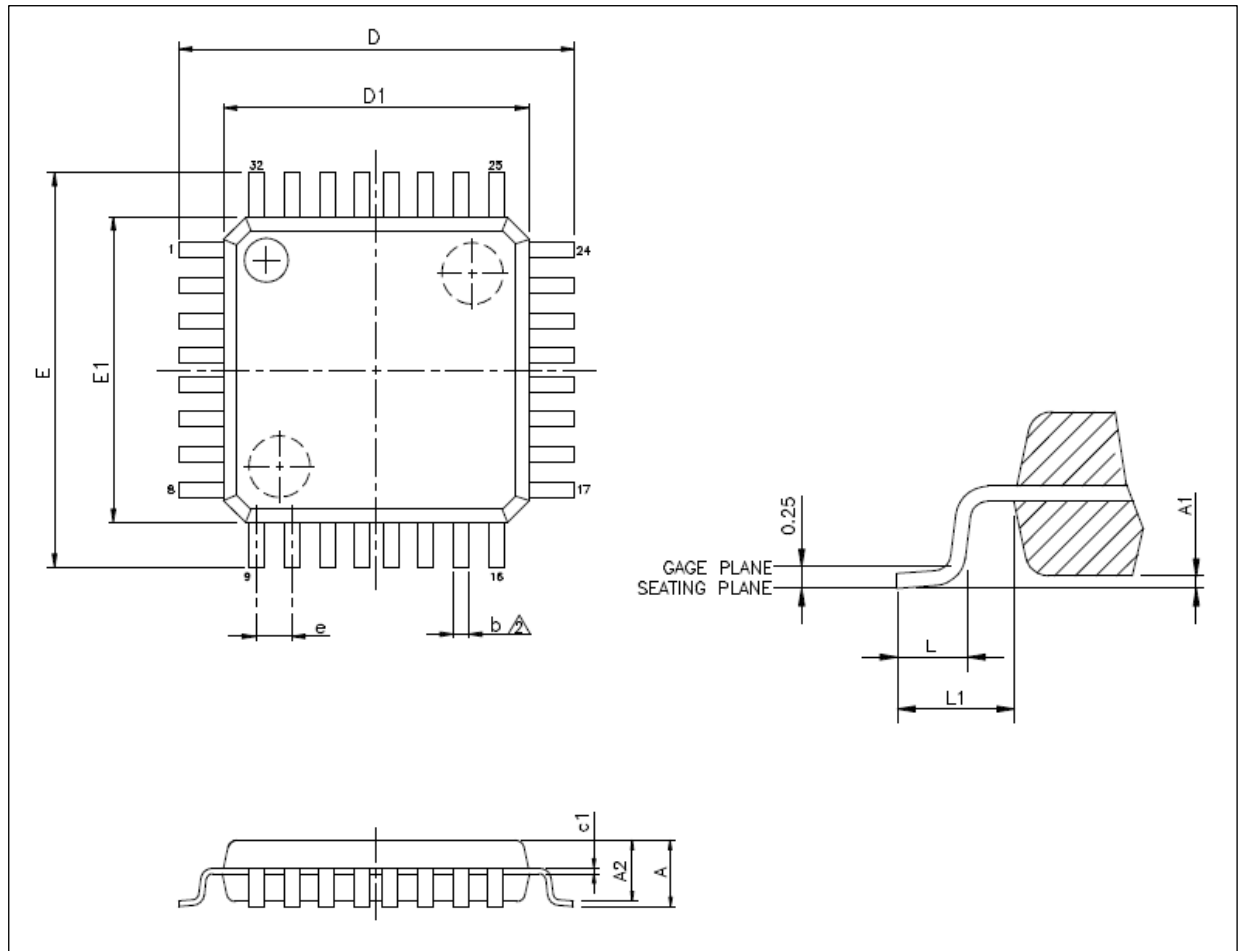
Examples of identifying marker locations

picture33. LQFP48 – 7 x 7 mmMarking (Package Top View)



7.2 LQFP32 – 7 x 7 mm encapsulated data

picture34. LQFP32 – 7 x 7 mm 32Lead Thin Quad Flat Package Diagram



(1) Figures are not drawn to scale.

surface47. LQFP32 – 7 x 7 mm 32Leaded Thin Quad Flat Pack Mechanical Data

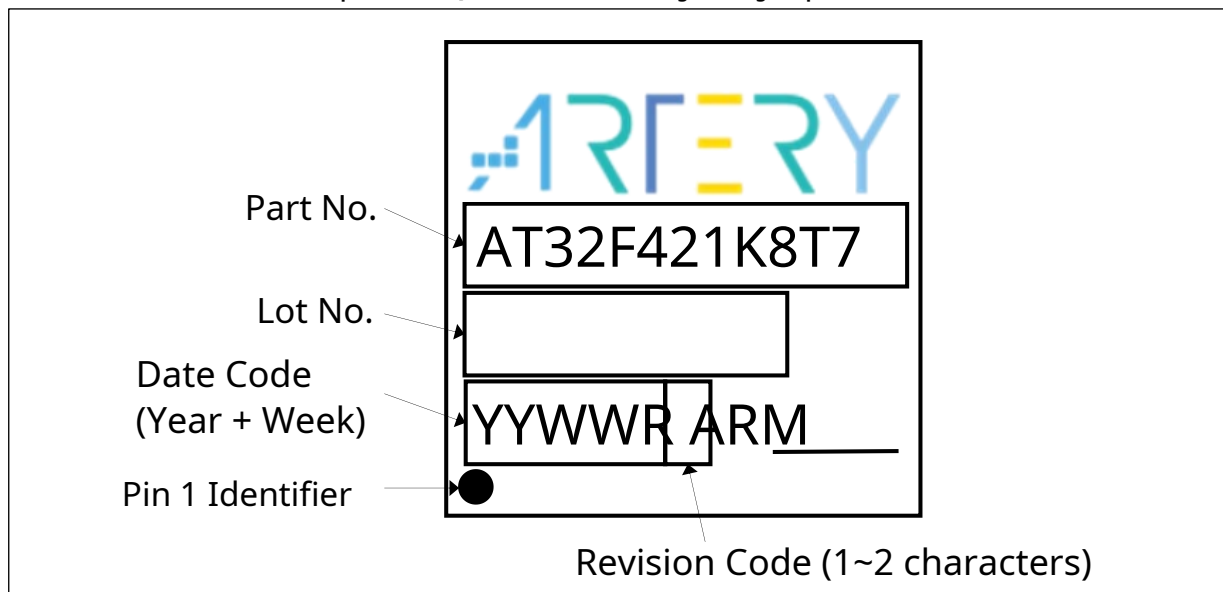
| label | mm | | | inch ⁽¹⁾ | | |
|-------|---------------|---------------|---------------|---------------------|---------------|---------------|
| | minimum value | typical value | maximum value | minimum value | typical value | maximum value |
| A | - | - | 1.60 | - | - | 0.063 |
| A1 | 0.05 | - | 0.15 | 0.002 | - | 0.006 |
| A2 | 1.35 | - | 1.45 | 0.053 | - | 0.057 |
| b | 0.30 | - | 0.45 | 0.012 | - | 0.018 |
| c | 0.09 | - | 0.16 | 0.004 | - | 0.006 |
| D. | 9.00 BSC. | | | 0.345 BSC. | | |
| D1 | 7.00 BSC. | | | 0.276 BSC. | | |
| E. | 9.00 BSC. | | | 0.345 BSC. | | |
| E1 | 7.00 BSC. | | | 0.276 BSC. | | |
| e | 0.80 BSC. | | | 0.031 BSC. | | |
| L | 0.45 | - | 0.75 | 0.018 | - | 0.030 |
| L1 | 1.00 REF. | | | 0.039 REF. | | |

(1) Inch values are based on mm data according to 3It is obtained by rounding to decimal precision conversion.

LQFP32 – 7 x 7 mequipment marking The image below is a top marking orientation with pin1

Examples of identifying marker locations

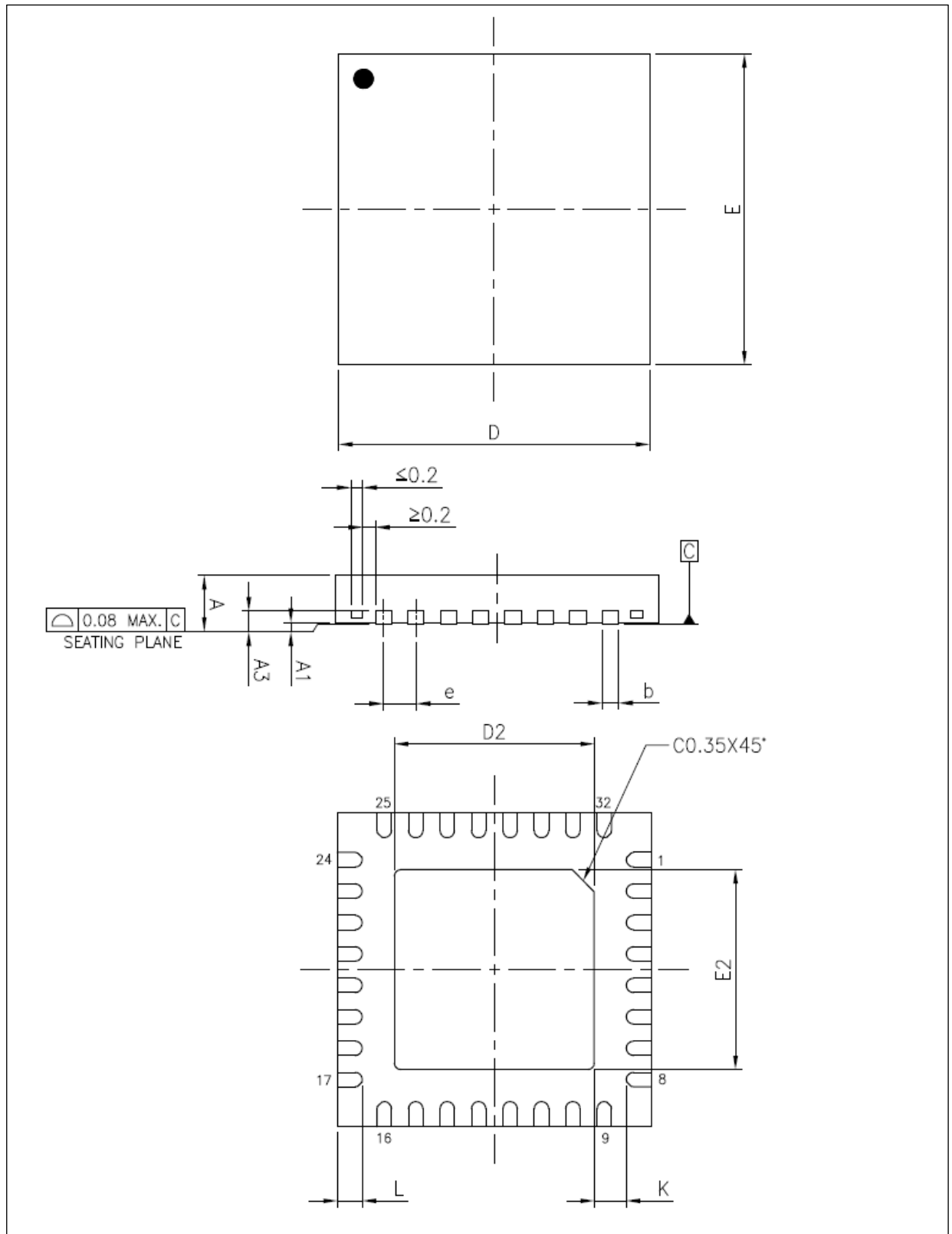
picture35. LQFP32 – 7 x 7 mmMarking (Package Top View)



7.3 QF

encapsulated data

FN32 – 5 x 5 mm 32Pinned Quad Flat No Leads Package Drawing



(1) Figures are not drawn to scale.

surface48. QFN32 – 5 x 5 mm 32Leaded Quad Flat No Lead Package Mechanical Data

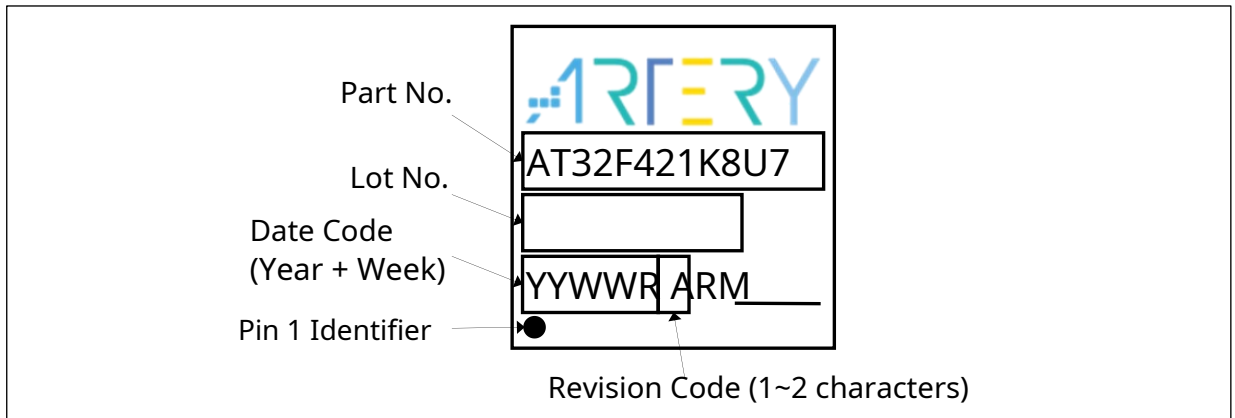
| label | mm | | | inch ⁽¹⁾ | | |
|-------|---------------|---------------|---------------|---------------------|---------------|---------------|
| | minimum value | typical value | maximum value | minimum value | typical value | maximum value |
| A | 0.70 | 0.75 | 0.80 | 0.028 | 0.030 | 0.031 |
| A1 | 0.00 | 0.02 | 0.05 | 0.000 | 0.001 | 0.002 |
| A3 | 0.203 REF. | | | 0.008 REF. | | |
| b | 0.18 | 0.25 | 0.30 | 0.007 | 0.010 | 0.012 |
| D. | 5.00 BSC. | | | 0.197 BSC. | | |
| D2 | 3.20 | 3.25 | 3.30 | 0.126 | 0.128 | 0.130 |
| E. | 5.00 BSC. | | | 0.197 BSC. | | |
| E2 | 3.20 | 3.25 | 3.30 | 0.126 | 0.128 | 0.130 |
| e | 0.50 BSC. | | | 0.020 BSC. | | |
| K | 0.20 | - | - | 0.008 | - | - |
| L | 0.35 | 0.40 | 0.45 | 0.014 | 0.016 | 0.018 |

(1) Inch values are based on mm data according to 3It is obtained by rounding to decimal precision conversion.

QFN32 – 5 x 5 mm equipment marking The image below is a top marking orientation with pin1

Examples of identifying marker locations

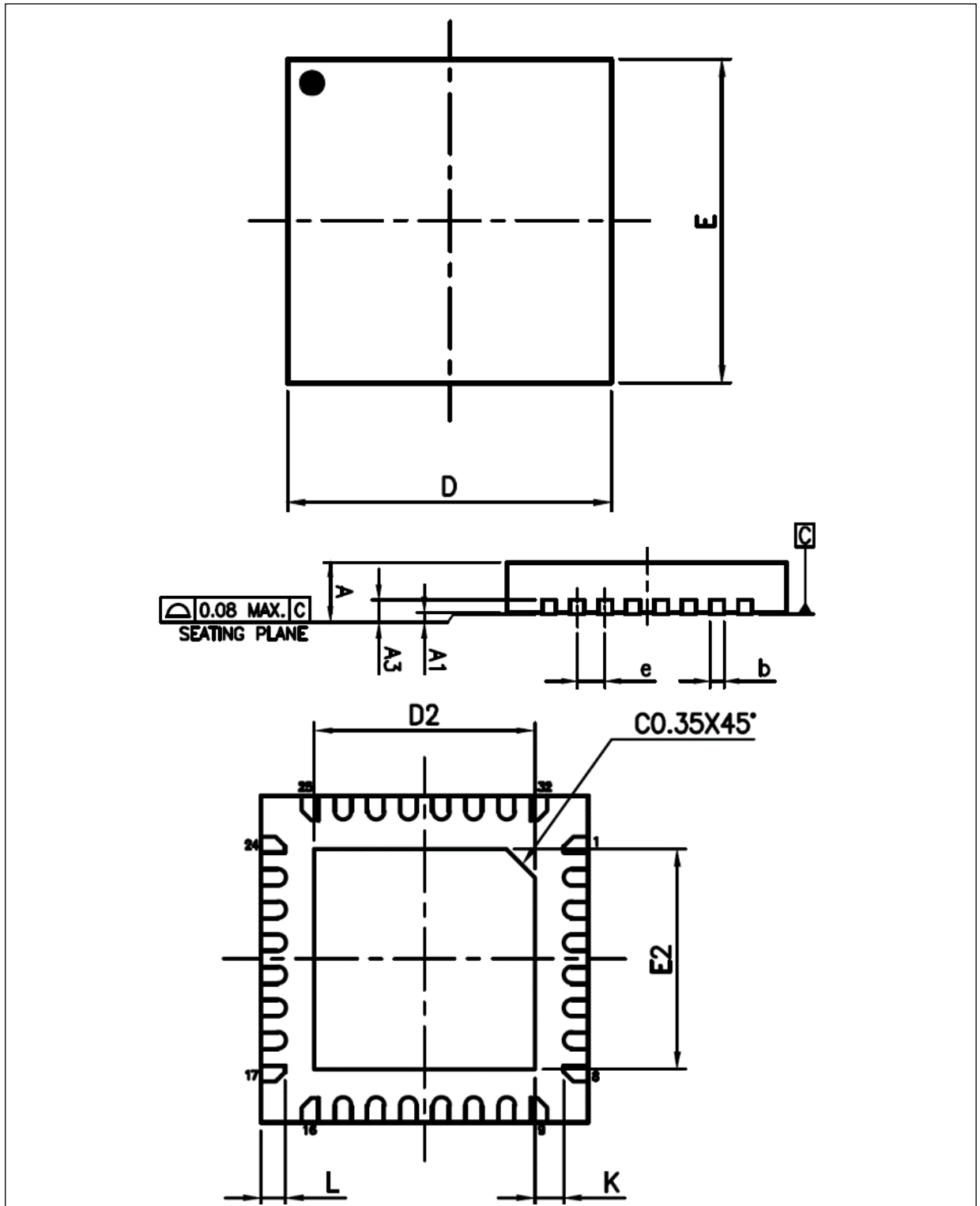
picture37. QFN32 – 5 x 5 mm Marking (Package Top View)



7.4 QFN32-4

encapsulated data

32 – 4 x 4 mm 32Pinned Quad Flat No Leads Package Drawing



(1) Figures are not drawn to scale.

surface49. QFN32 – 4 x 4 mm 32Leaded Quad Flat No Lead Package Mechanical Data

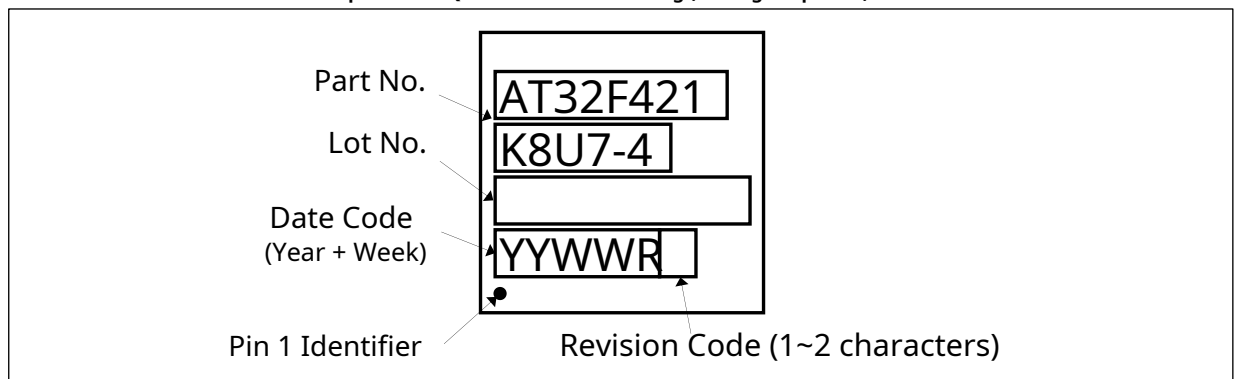
| label | mm | | | inch ⁽¹⁾ | | |
|-------|---------------|---------------|---------------|---------------------|---------------|---------------|
| | minimum value | typical value | maximum value | minimum value | typical value | maximum value |
| A | 0.80 | 0.85 | 0.90 | 0.031 | 0.033 | 0.035 |
| A1 | 0.00 | 0.02 | 0.05 | 0.000 | 0.001 | 0.002 |
| A3 | 0.203 REF. | | | 0.008 REF. | | |
| b | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| D. | 4.00 BSC. | | | 0.157 BSC. | | |
| D2 | 2.65 | 2.70 | 2.75 | 0.104 | 0.106 | 0.108 |
| E. | 4.00 BSC. | | | 0.157 BSC. | | |
| E2 | 2.65 | 2.70 | 2.75 | 0.104 | 0.106 | 0.108 |
| e | 0.40 BSC. | | | 0.016 BSC. | | |
| K | 0.20 | - | - | 0.008 | - | - |
| L | 0.25 | 0.30 | 0.35 | 0.010 | 0.012 | 0.014 |

(1) Inch values are based on mm data according to 3It is obtained by rounding to decimal precision conversion.

QFN32 – 4x4mm equipment marking The image below is a top marking orientation with pin1

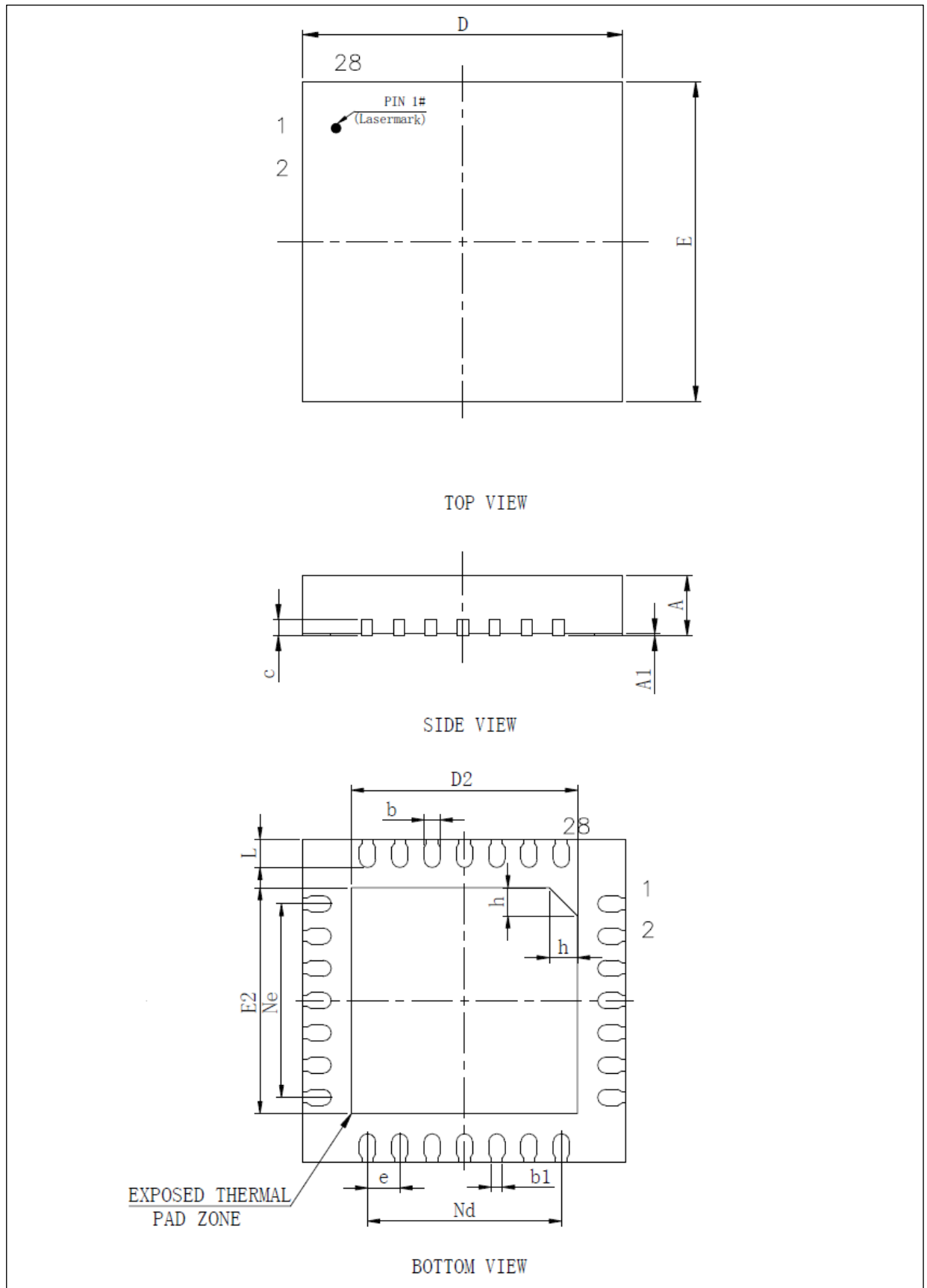
Examples of identifying marker locations

picture39. QFN32 – 4 x 4mm Marking (Package Top View)



7.5 QFN28 – 4 x 4 mm encapsulated data

picture40. QFN28 – 4 x 4 mm 28Pinned Quad Flat No Leads Package Drawing



(1) Figures are not drawn to scale.

surface50. QFN28 – 4 x 4 mm 28Leaded Quad Flat No Lead Package Mechanical Data

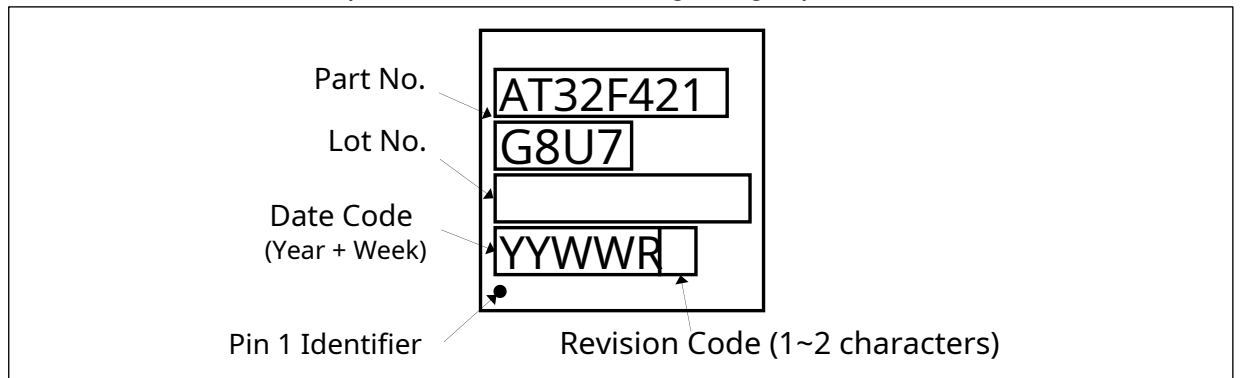
| label | mm | | | inch ⁽¹⁾ | | |
|-------|---------------|---------------|---------------|---------------------|---------------|---------------|
| | minimum value | typical value | maximum value | minimum value | typical value | maximum value |
| A | 0.70 | 0.75 | 0.80 | 0.028 | 0.030 | 0.031 |
| A1 | 0.00 | 0.02 | 0.05 | 0.000 | 0.001 | 0.002 |
| b | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| c | 0.18 | 0.20 | 0.25 | 0.007 | 0.008 | 0.010 |
| D. | 3.90 | 4.00 | 4.10 | 0.154 | 0.157 | 0.161 |
| D2 | 2.70 | 2.80 | 2.90 | 0.106 | 0.110 | 0.114 |
| e | 0.40 BSC. | | | 0.016 BSC. | | |
| Ne | 2.40 BSc. | | | 0.094 BSC. | | |
| Nd | 2.40 BSC. | | | 0.094 BSC. | | |
| E. | 3.90 | 4.00 | 4.10 | 0.154 | 0.157 | 0.161 |
| E2 | 2.70 | 2.80 | 2.90 | 0.106 | 0.110 | 0.114 |
| L | 0.30 | 0.35 | 0.40 | 0.012 | 0.014 | 0.016 |
| h | 0.30 | 0.35 | 0.40 | 0.012 | 0.014 | 0.016 |

(1)Inch values are based on mm data according to3It is obtained by rounding to decimal precision conversion.

QFN28 – 4x4mmequipment marking The image below is a top marking orientation with pin1

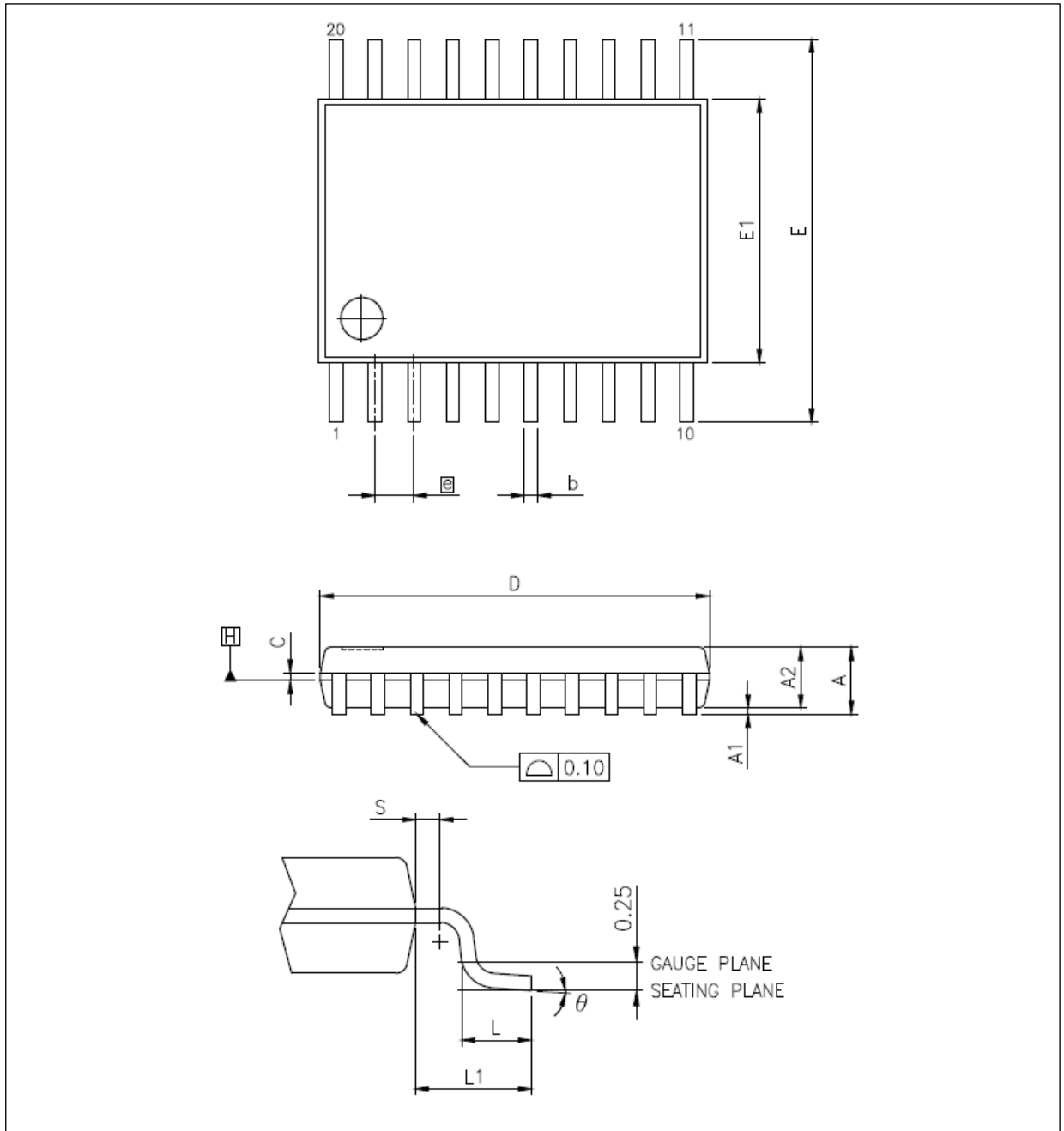
Examples of identifying marker locations

picture41. QFN28 – 4 x 4mmMarking (Package Top View)



7.6 TSSOP20 – 6.5 x 4.4 mm encapsulated data

picture42. TSSOP20 – 6.5 x 4.4 mm 20Pin thin and compact small size package diagram



(1) Figures are not drawn to scale.

surface51. TSSOP20 – 6.5 x 4.4 mm 20Lead Thin Shrink Small Size Package Mechanical Data

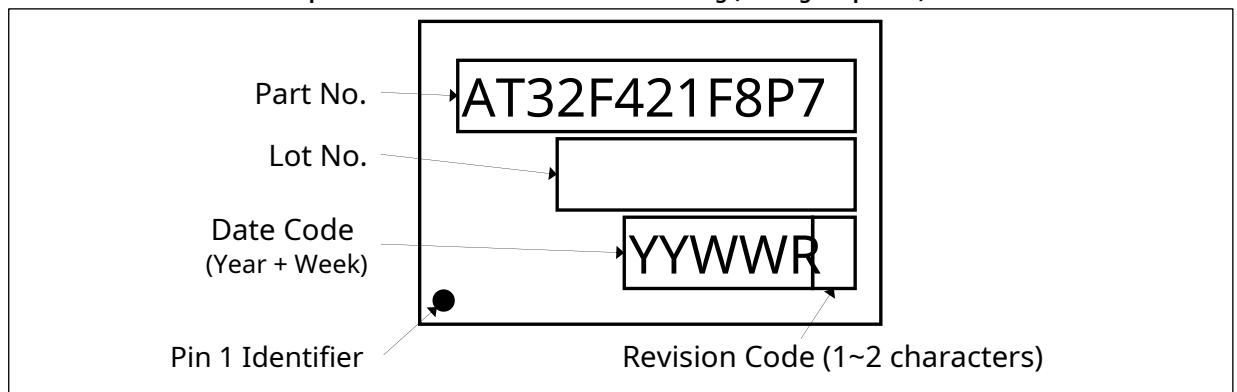
| label | mm | | | inch ⁽¹⁾ | | |
|-------|---------------|---------------|---------------|---------------------|---------------|---------------|
| | minimum value | typical value | maximum value | minimum value | typical value | maximum value |
| A | - | - | 1.20 | - | - | 0.047 |
| A1 | 0.05 | - | 0.15 | 0.002 | - | 0.006 |
| A2 | 0.80 | 1.00 | 1.05 | 0.031 | 0.039 | 0.041 |
| b | 0.19 | - | 0.30 | 0.007 | - | 0.012 |
| C | 0.09 | - | 0.20 | 0.004 | - | 0.008 |
| D. | 6.40 | 6.50 | 6.60 | 0.252 | 0.256 | 0.260 |
| E1 | 4.30 | 4.40 | 4.50 | 0.169 | 0.173 | 0.177 |
| E. | 6.40 BSc. | | | 0.252 BSC. | | |
| e | 0.65 BSC. | | | 0.026 BSC. | | |
| L1 | 1.00 REF. | | | 0.039 REF. | | |
| L | 0.50 | 0.60 | 0.75 | 0.020 | 0.024 | 0.030 |
| S | 0.20 | - | - | 0.008 | - | - |
| Θ | 0° | - | 8° | 0° | - | 8° |

(1) Inch values are based on mm data according to 3It is obtained by rounding to decimal precision conversion.

TSSOP20 – 6.5 x 4.4mm equipment marking The image below is a top marking

orientation with pin1 Examples of identifying marker locations

picture43. TSSOP20 – 6.5 x 4.4 mm Marking (Package Top View)



7.7

thermal properties

The maximum junction temperature of the chip (T_{jmax}) must not exceed [surface9](#) The range of values given. The maximum junction temperature of the chip (T_{jmax}) in Celsius

In degrees, it can be calculated with the following formula:

$$T_{jmax} = T_{amax} + (P_{dmax} \times \Theta_{JA})$$

in:

- T_{amax} is the maximum ambient temperature, with °C express,

- Θ_{JA} is the junction-to-ambient thermal impedance of the package, with °C/W mark,

- P_{dmax} yes P_{INTmax} and $P_{I/Omax}$ and ($P_{dmax} = P_{INTmax} + P_{I/Omax}$),

- P_{INTmax} yes I_{DD} and V_{DD} The product of , in watts (Watt) represents the maximum internal power consumption of the chip.

$P_{I/Omax}$ is the maximum power dissipation of all output pins:

$$P_{I/Omax} = \Sigma(V_{OLX} I_{OL}) + \Sigma((V_{DD} - V_{OH}) \times I_{OH}),$$

considered in the application I/O on low and high on the actual V_{OL}/I_{OL} and V_{OH}/I_{OH} .

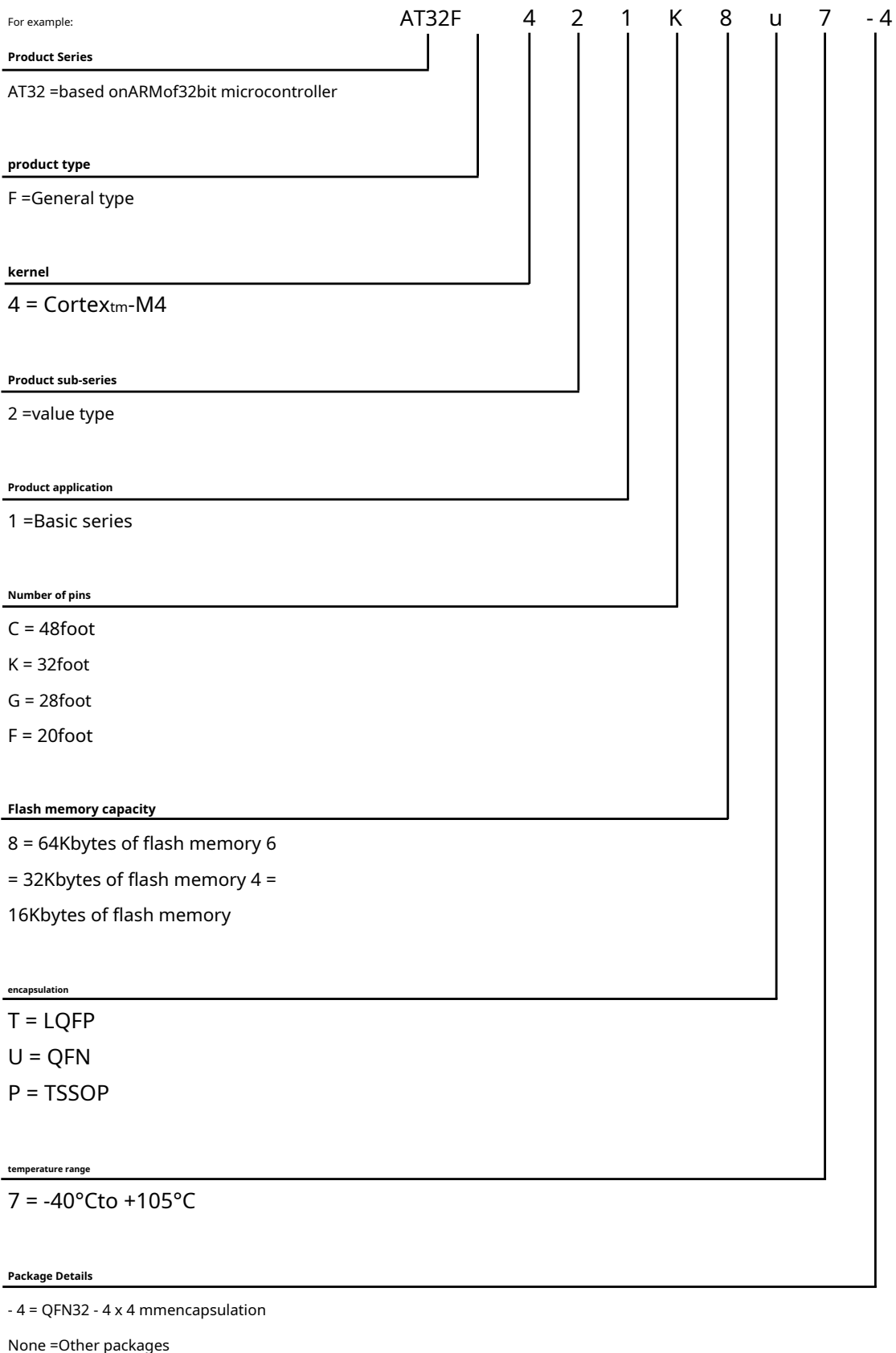
surface52.Package Thermal Characteristics

| symbol | parameter | value | unit |
|---------------|---------------------------------------------------------------------------------|-------|------|
| Θ_{JA} | Thermal Impedance Junction to Ambient -LQFP48 - 7 × 7 mm / 0.5 mm spacing | 87.0 | °C/W |
| | Thermal Impedance Junction to Ambient -LQFP32 - 7 × 7 mm / 0.8 mm spacing | 82.4 | |
| | Thermal Impedance Junction to Ambient -QFN32 - 5 × 5 mm / 0.5 mm spacing | 39.8 | |
| | Thermal Impedance Junction to Ambient -QFN32 - 4 × 4 mm / 0.4 mm spacing | 44.8 | |
| | Thermal Impedance Junction to Ambient -QFN28 - 4 × 4 mm / 0.4 mm spacing | 44.8 | |
| | Thermal Impedance Junction to Ambient -TSSOP20 - 6.5 × 4.4 mm / 0.65 mm spacing | 103.0 | |

8 order code

surface53. AT32F421Series Order Code Information Diagram

For example:



For a more list of options (speed, package, etc.) and other relevant information, please contact the nearest Artelli sales office.

9 version history

surface54.Document Version History

| date | Version | change |
|-----------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 2020.8.17 | 1.00 | original version |
| 2020.9.16 | 1.01 | 1.fix picture1 , surface9 , and surface19 middle APB1 and APB2 The maximum frequency of 120 MHz 2.Revises surface38 middle SPI Conditions and maximum values of clock frequency 3.Add surface30 EFT The test result is 3/A (2kV) 4.Add surface9 footnote (4) illustrate QFN28 encapsulation PA11 and PA12 Recommendations for software settings 5.fix picture2 HSI 48 MHz Block Diagram |

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